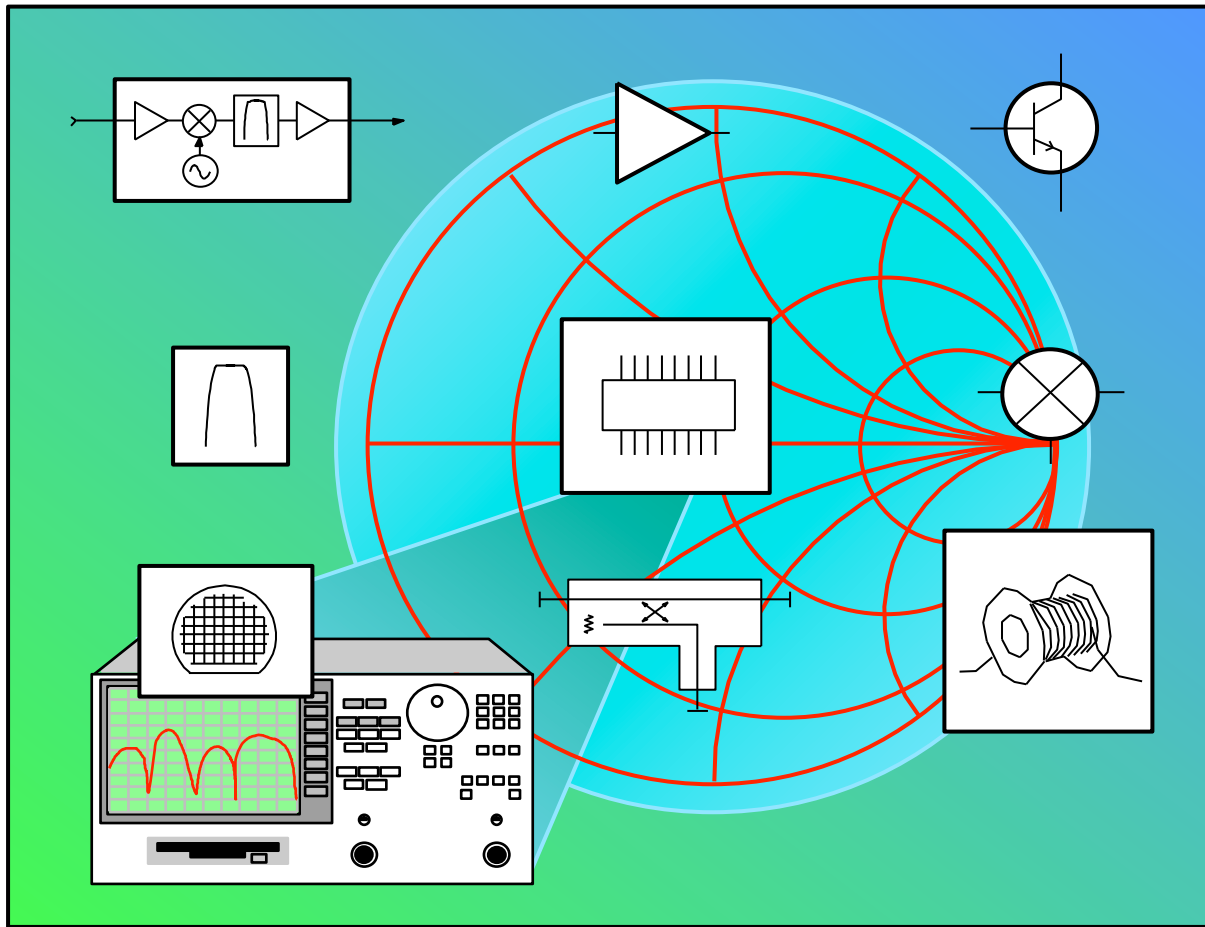
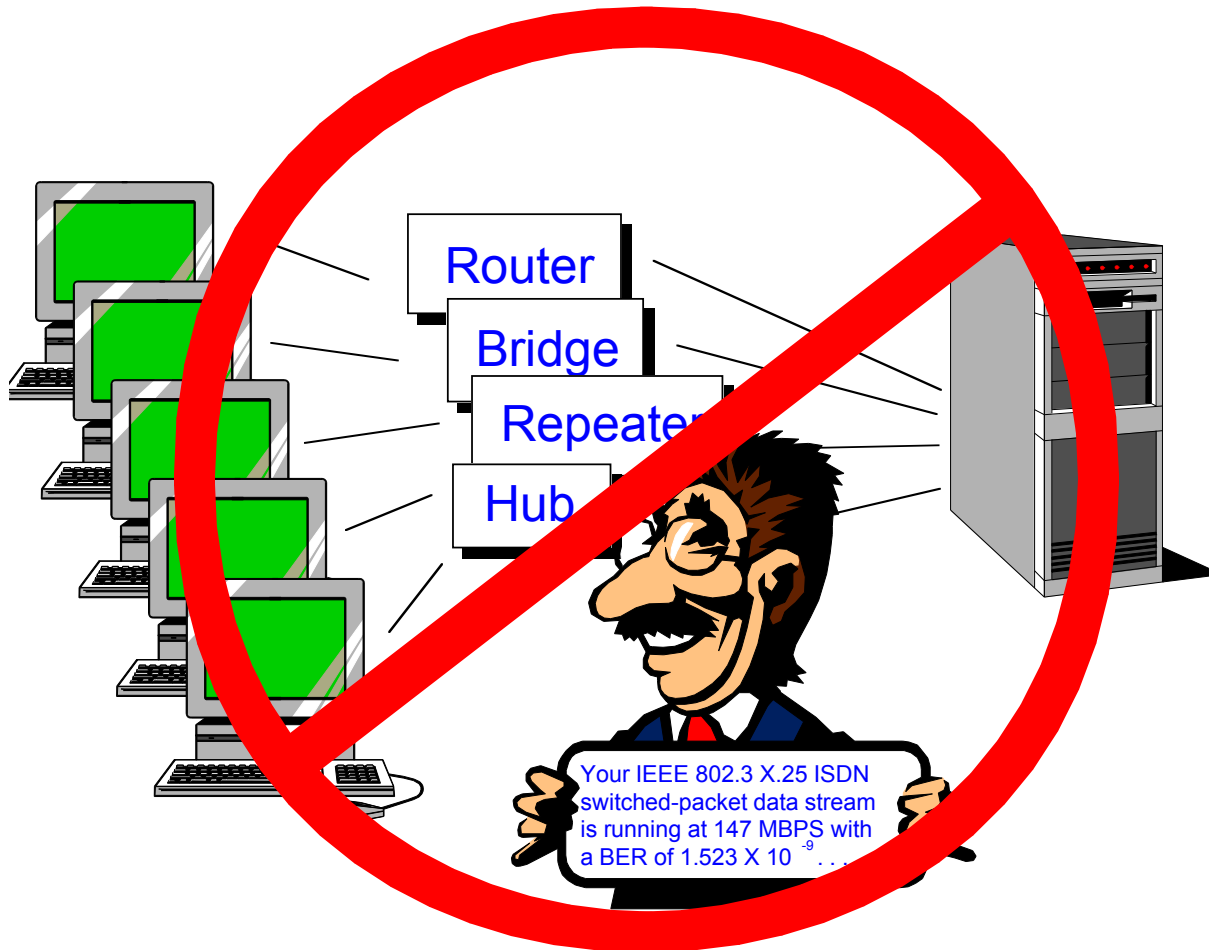


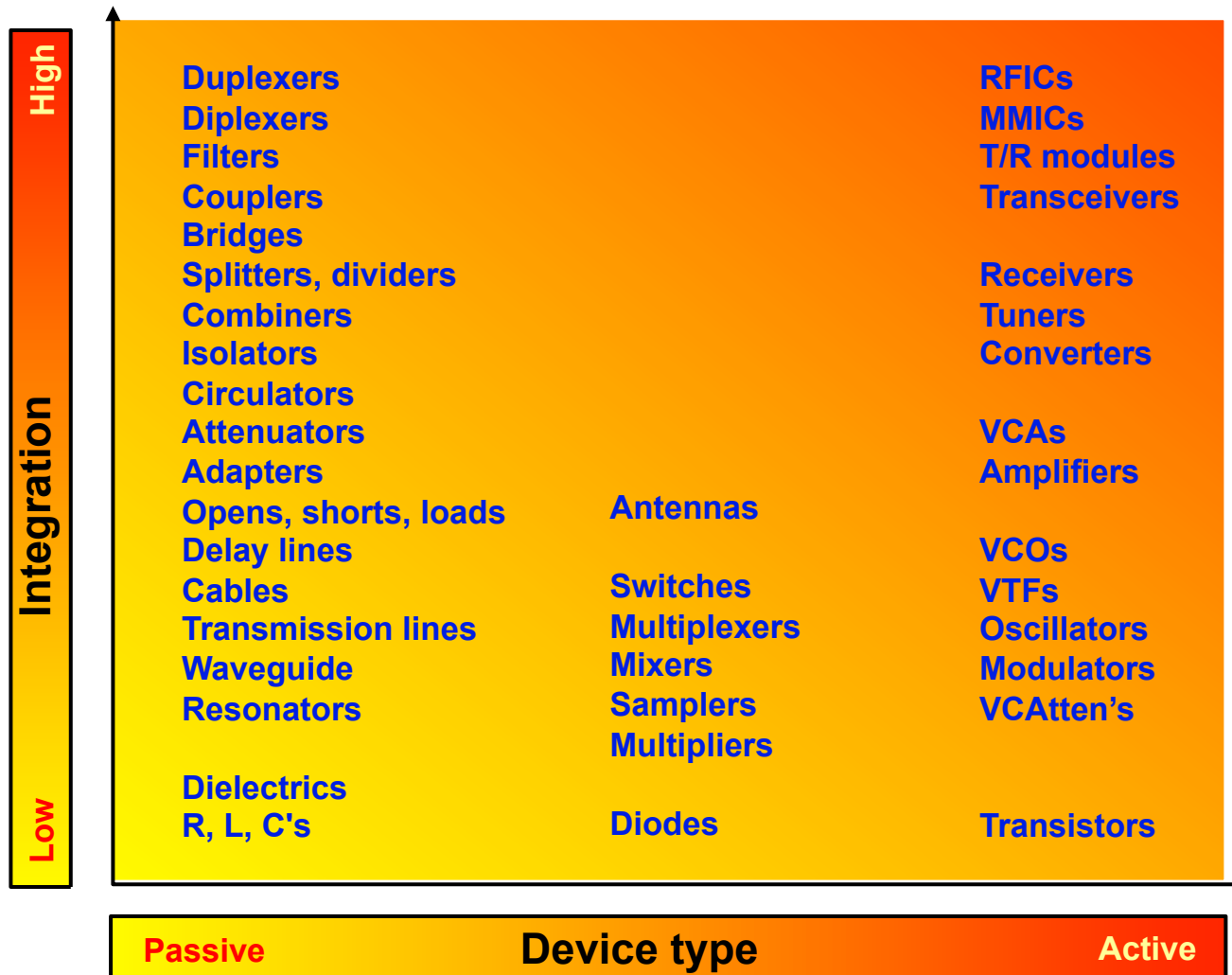
Network Analyzer Basics



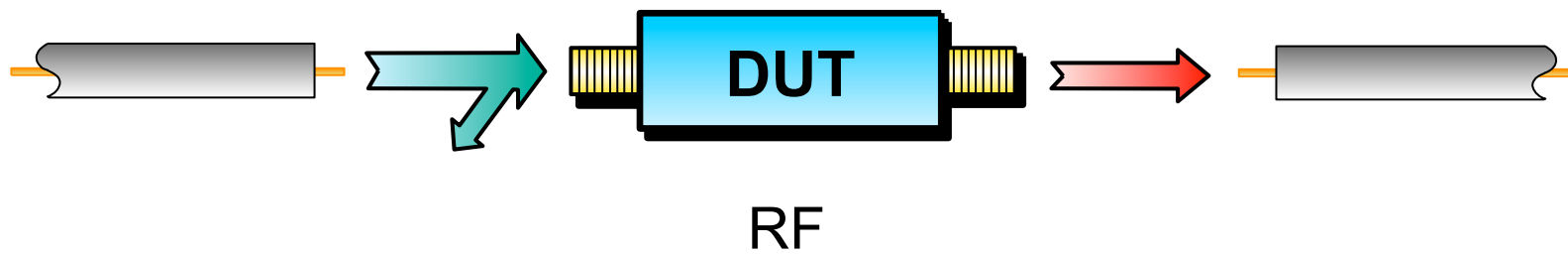
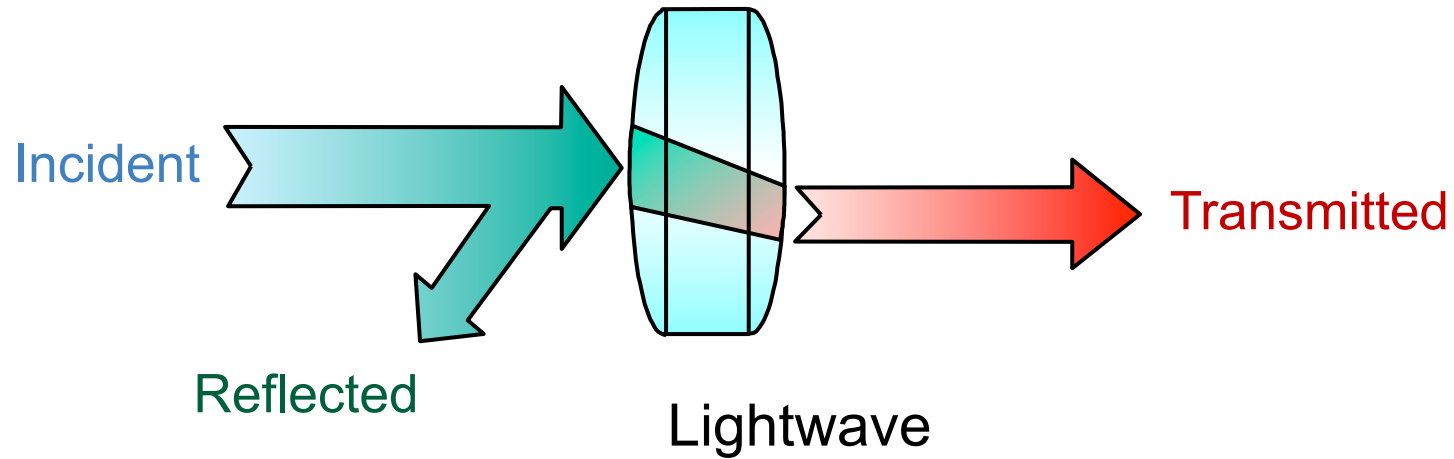
Network Analysis is NOT....



What Types of Devices are Tested?

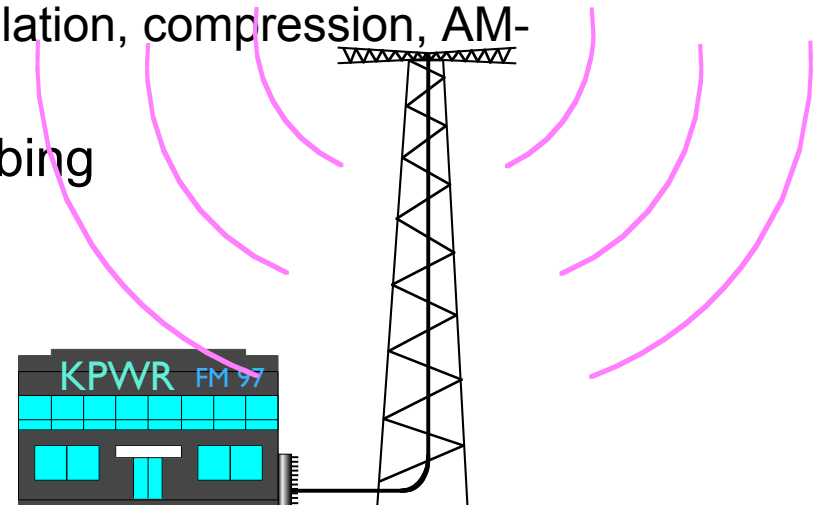


Lightwave Analogy to RF Energy



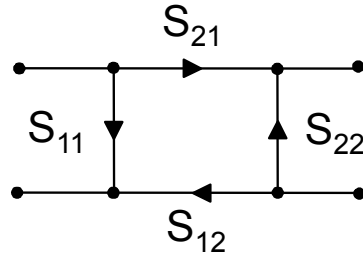
Why Do We Need to Test Components?

- Verify specifications of “building blocks” for more complex RF systems
- Ensure distortionless transmission of communications signals
 - linear: constant amplitude, linear phase / constant group delay
 - nonlinear: harmonics, intermodulation, compression, AM-to-PM conversion
- Ensure good match when absorbing power (e.g., an antenna)

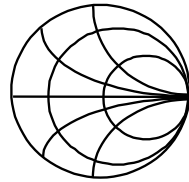


The Need for Both Magnitude and Phase

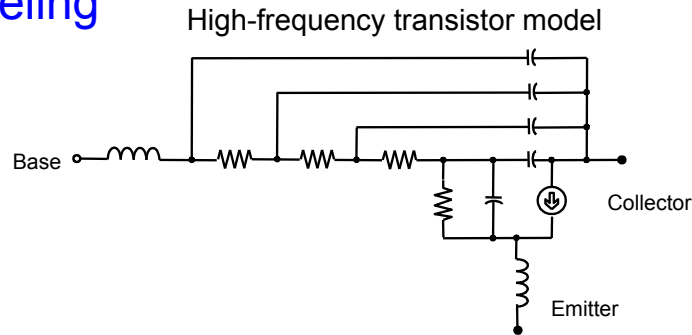
1. Complete characterization of linear networks



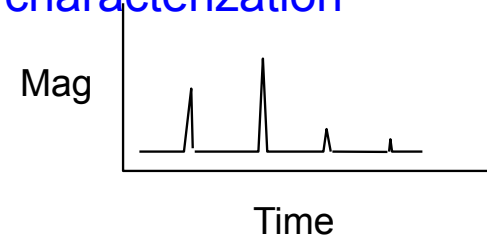
2. Complex impedance needed to design matching circuits



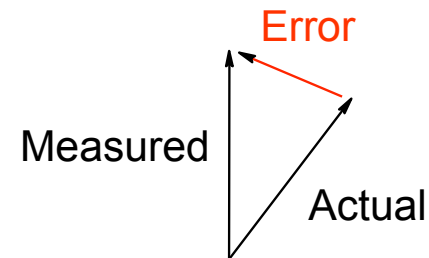
3. Complex values needed for device modeling



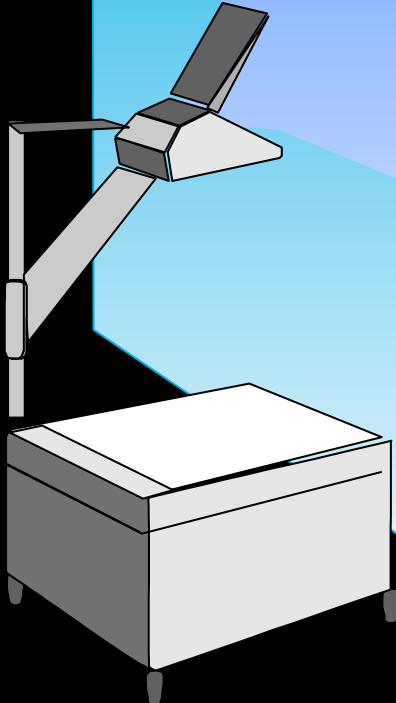
4. Time-domain characterization



5. Vector-error correction



Agenda



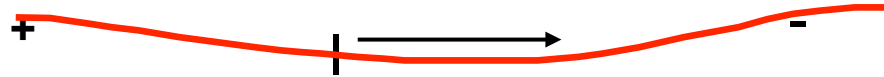
- **What measurements do we make?**
 - Transmission-line basics
 - Reflection and transmission parameters
 - S-parameter definition
- **Network analyzer hardware**
 - Signal separation devices
 - Detection types
 - Dynamic range
 - T/R versus S-parameter test sets
- **Error models and calibration**
 - Types of measurement error
 - One- and two-port models
 - Error-correction choices
 - Basic uncertainty calculations
- **Example measurements**
- **Appendix**



Transmission Line Basics

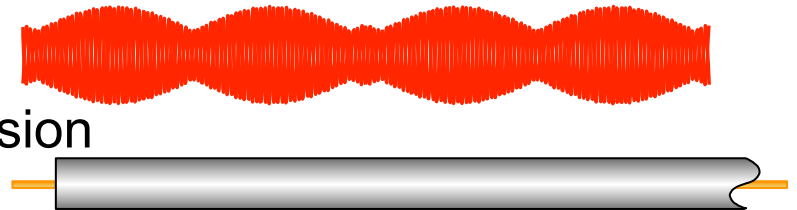
Low frequencies

- wavelengths \gg wire length
- current (I) travels down wires easily for efficient power transmission
- measured voltage and current not dependent on position along wire



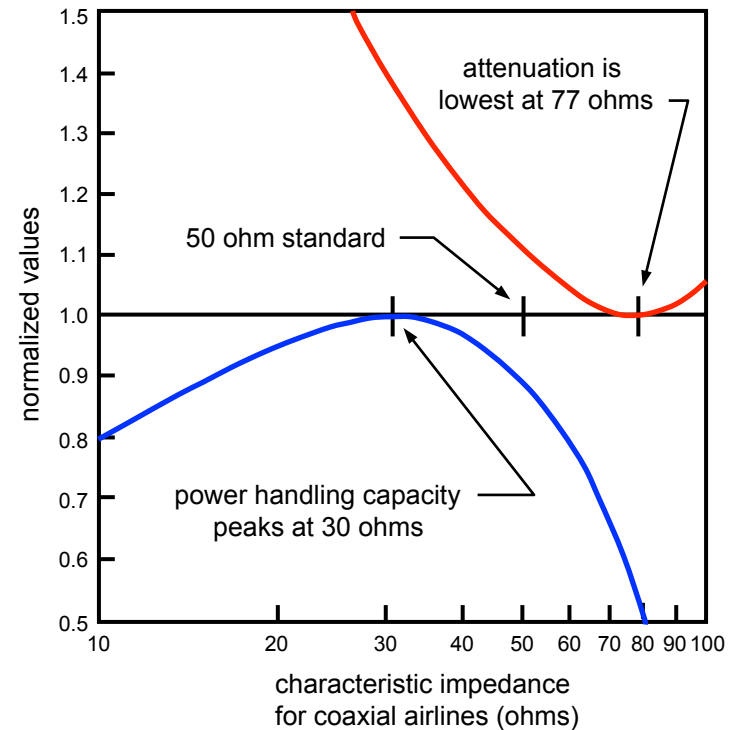
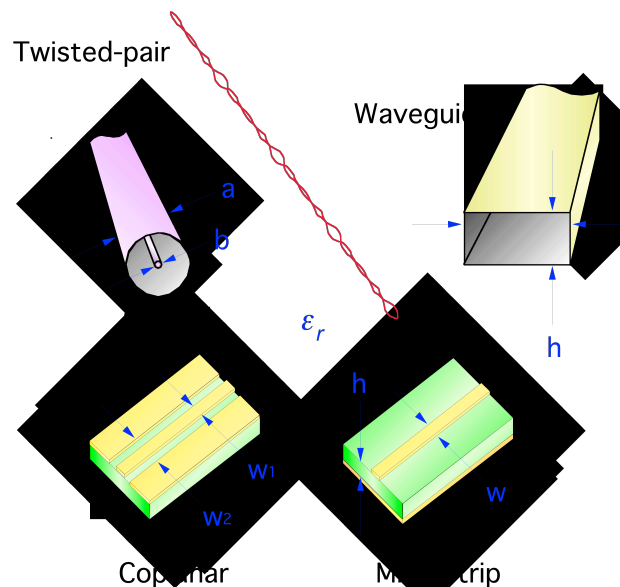
High frequencies

- wavelength \approx or \ll length of transmission medium
- need transmission lines for efficient power transmission
- matching to characteristic impedance (Z_0) is very important for low reflection and maximum power transfer
- measured envelope voltage dependent on position along line

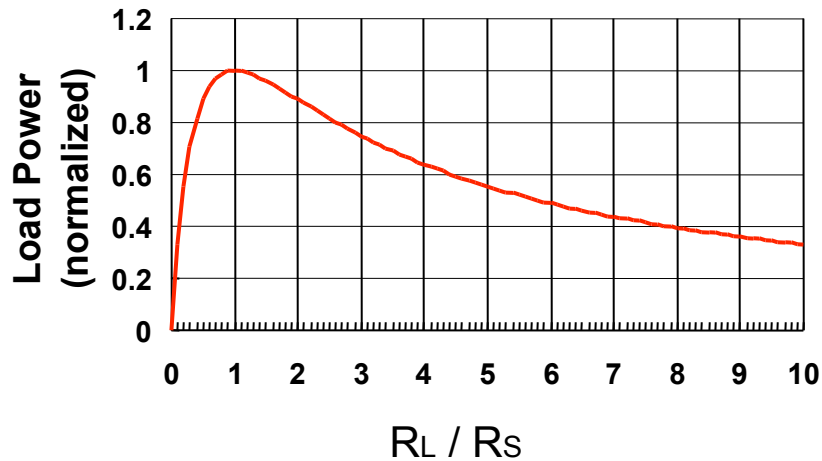
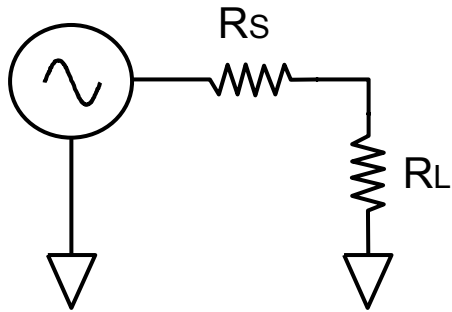


Transmission line Zo

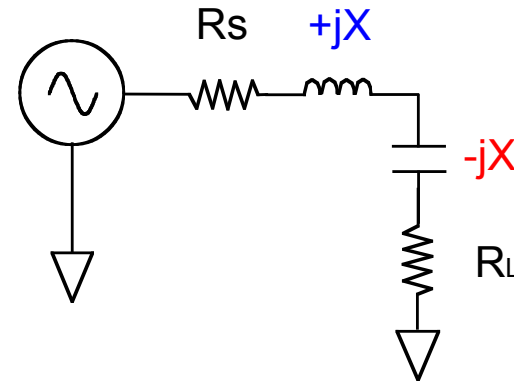
- Zo determines relationship between voltage and current waves
- Zo is a function of physical dimensions and ϵ_r
- Zo is usually a real impedance (e.g. 50 or 75 ohms)



Power Transfer Efficiency



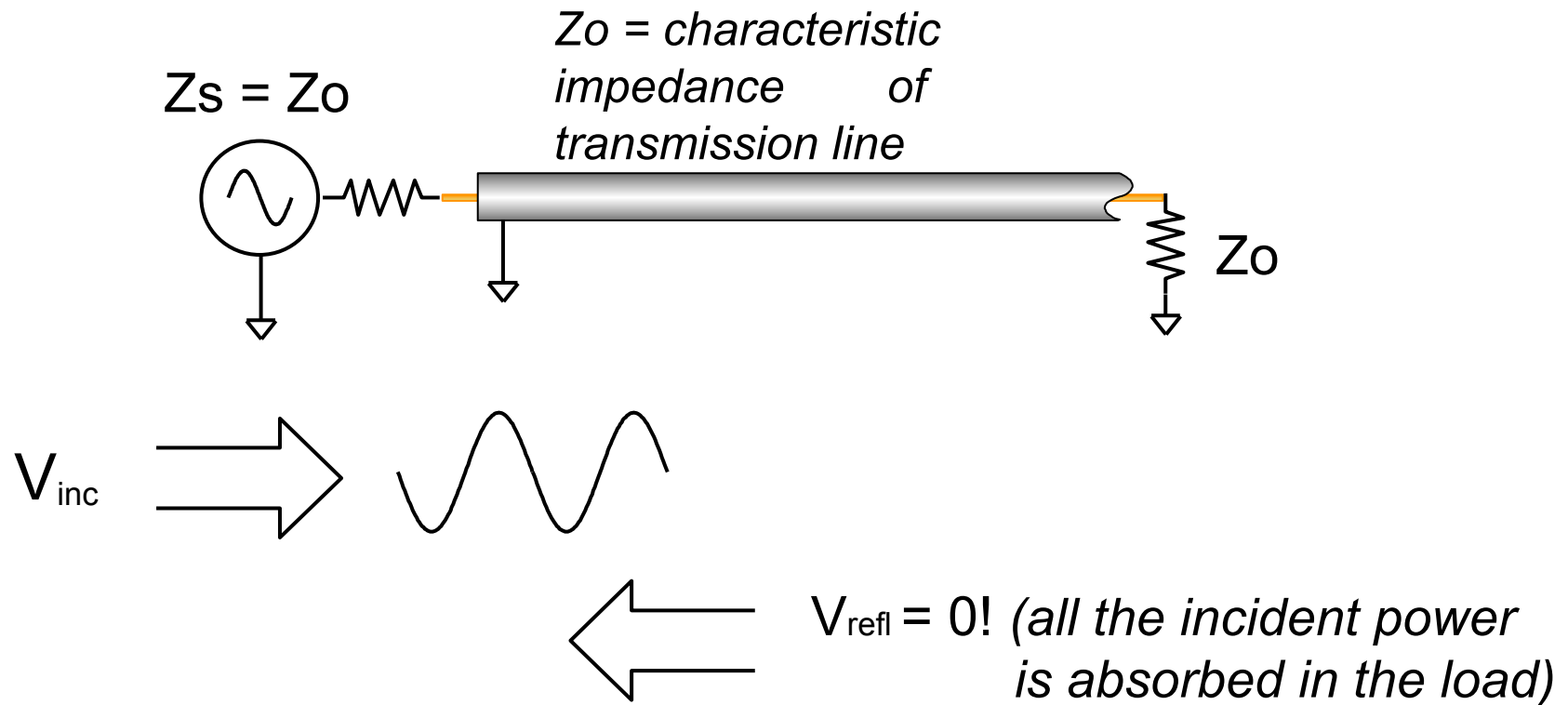
For complex impedances, maximum power transfer occurs when $Z_L = Z_S^*$ (conjugate match)



Maximum power is transferred when $R_L = R_S$

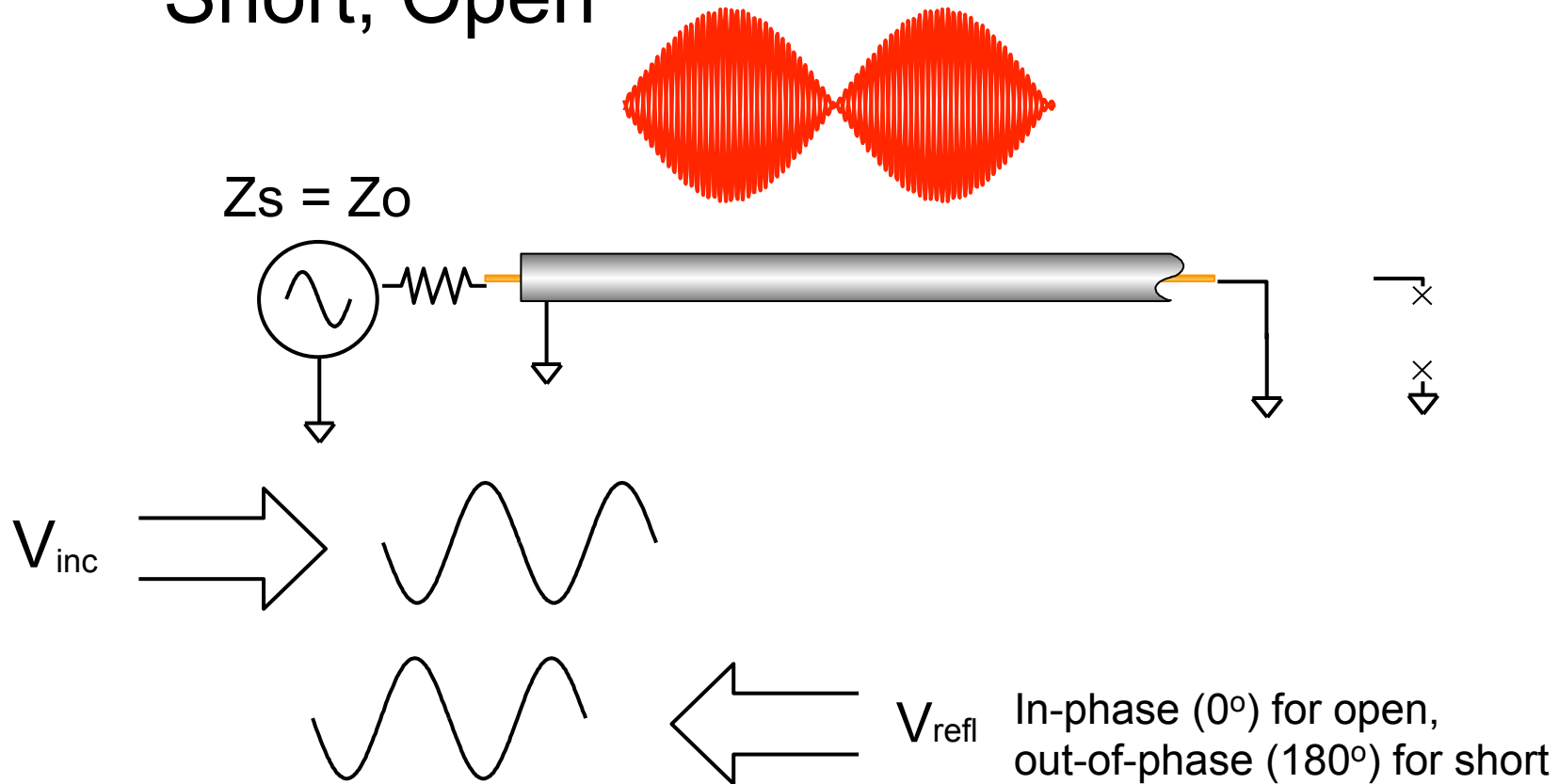


Transmission Line Terminated with Z_0



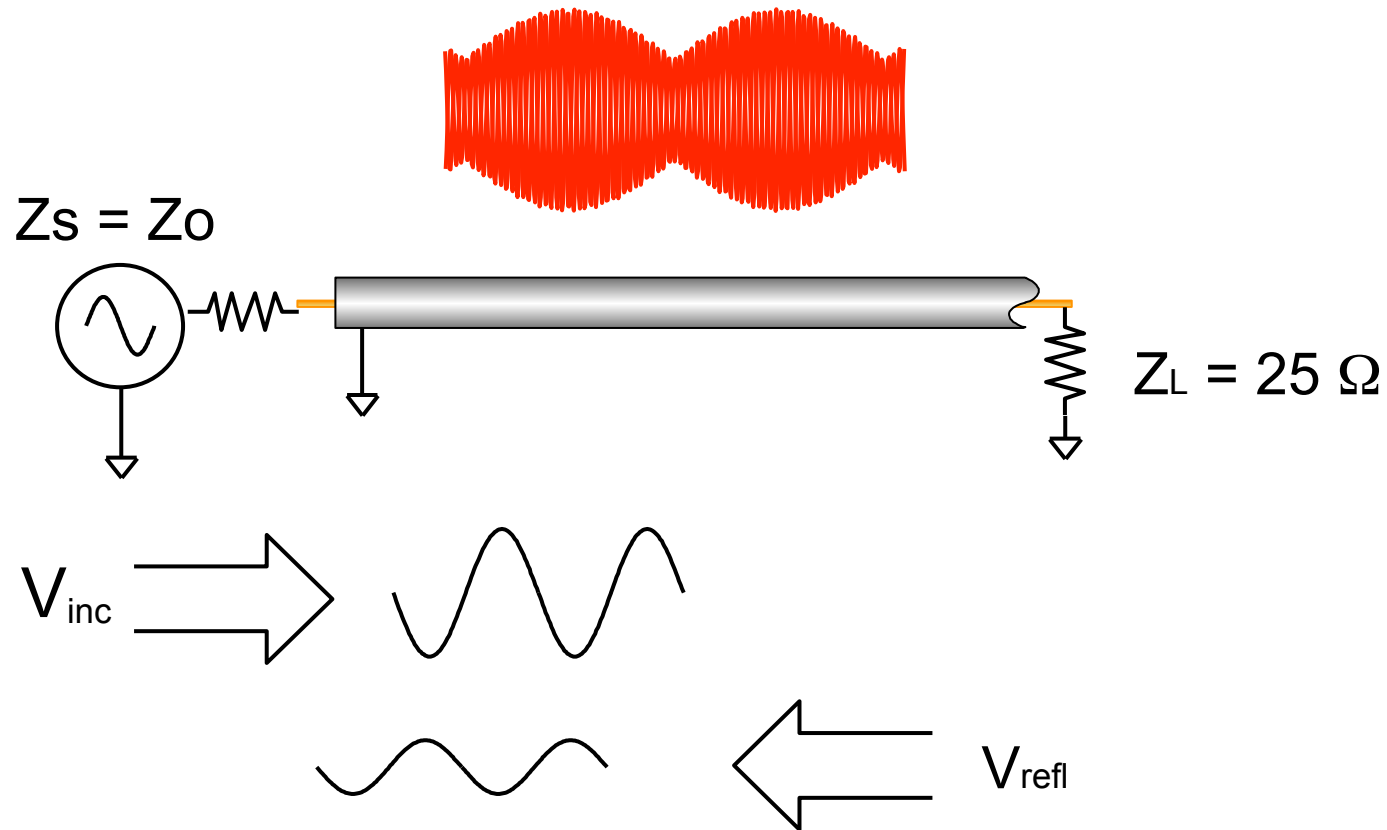
For reflection, a transmission line terminated in Z_0 behaves like an infinitely long transmission line

Transmission Line Terminated with Short, Open



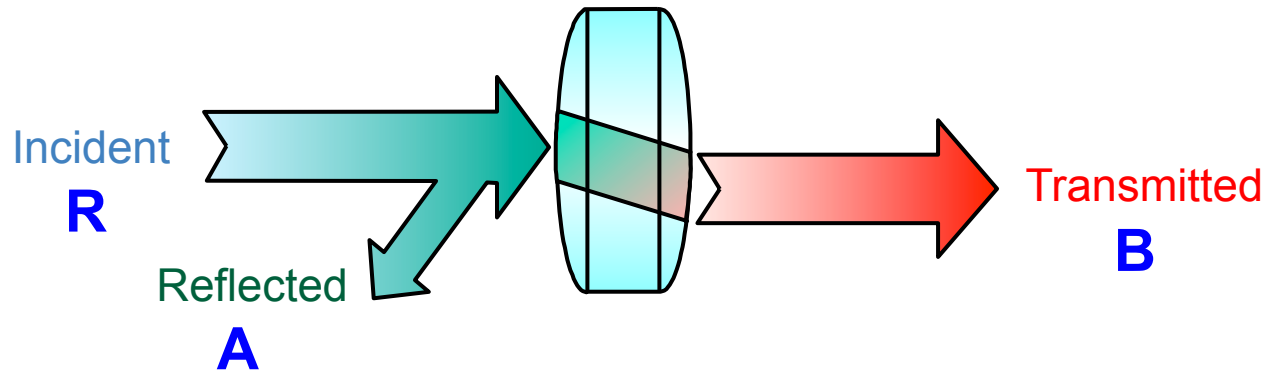
For reflection, a transmission line terminated in a short or open reflects all power back to source

Transmission Line Terminated with $25\ \Omega$



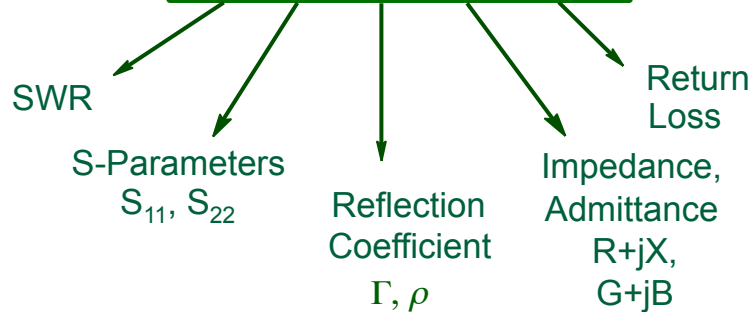
**Standing wave pattern
does not go to zero as
with short or open**

High-Frequency Device Characterization



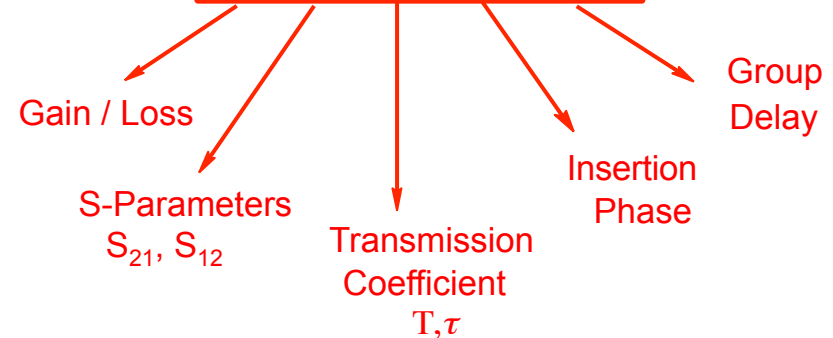
REFLECTION

$$\frac{\text{Reflected}}{\text{Incident}} = \frac{A}{R}$$



TRANSMISSION

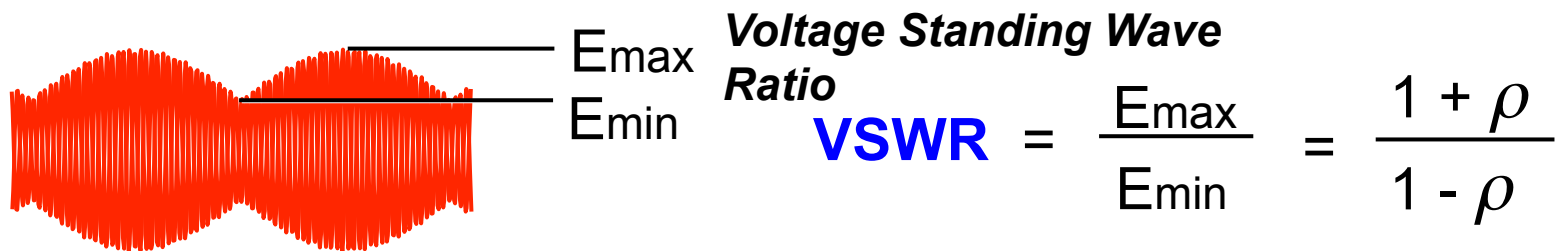
$$\frac{\text{Transmitted}}{\text{Incident}} = \frac{B}{R}$$



Reflection Parameters

Reflection Coefficient $\Gamma = \frac{V_{\text{reflected}}}{V_{\text{incident}}} = \rho \angle \Phi = \frac{Z_L - Z_0}{Z_L + Z_0}$

Return loss = $-20 \log(\rho)$, $\rho = |\Gamma|$

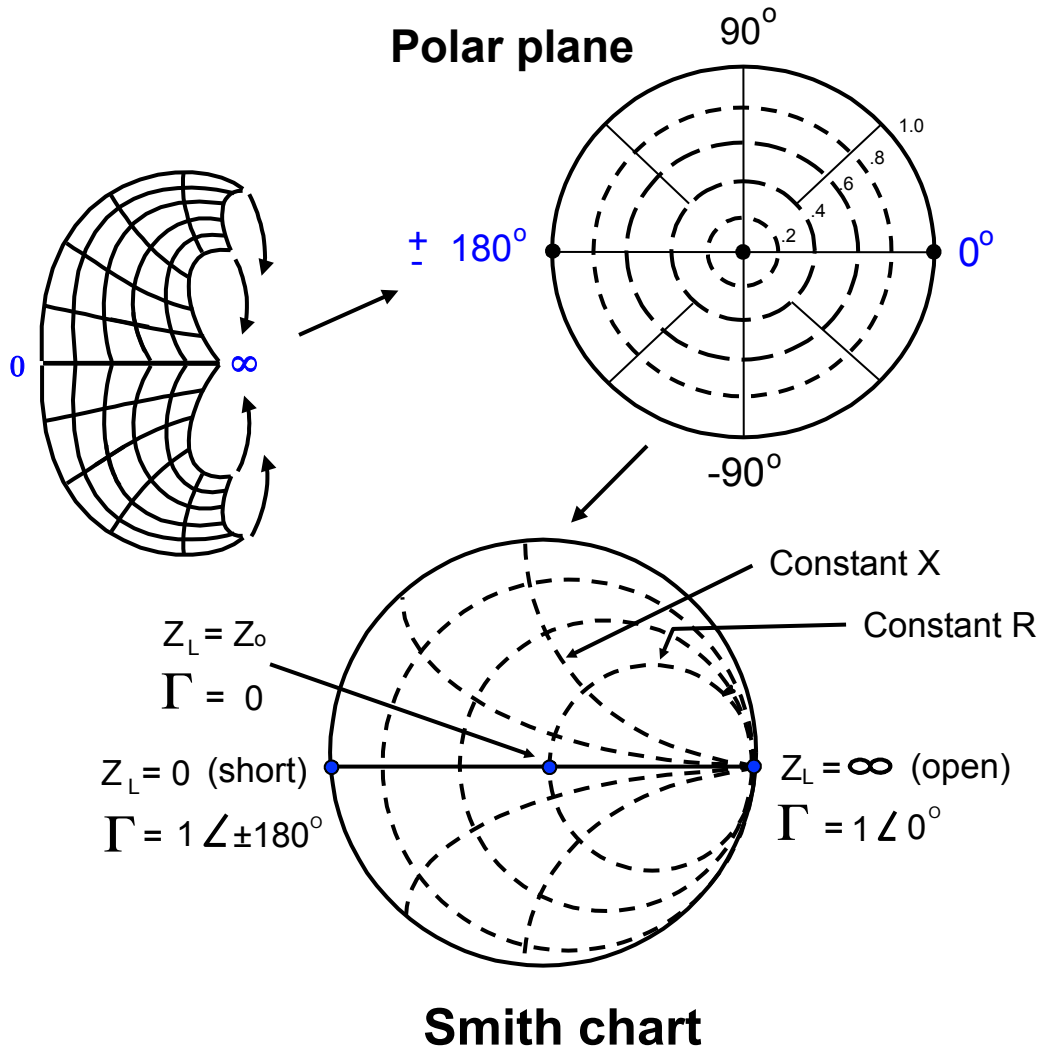
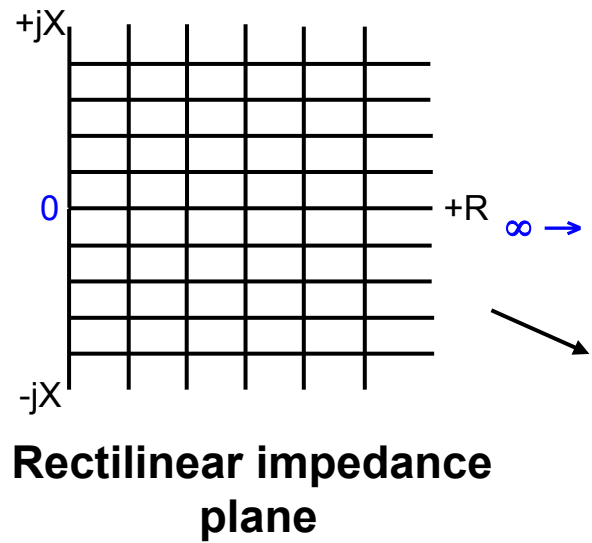


No reflection
 ($Z_L = Z_0$)

Full reflection
 ($Z_L = \text{open, short}$)

0	ρ	1
∞ dB	RL	0 dB
1	VSWR	∞

Smith Chart Review



**Smith Chart maps
rectilinear
impedance
plane onto polar
plane**



Transmission Parameters



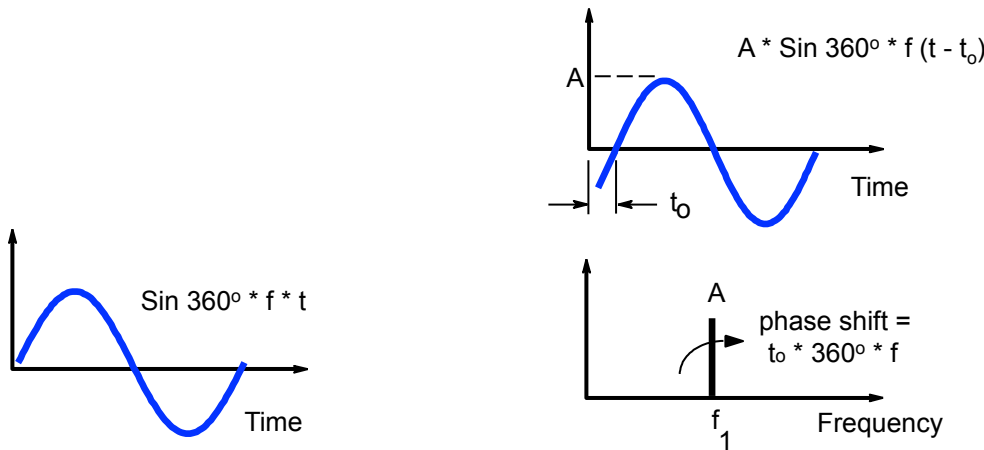
$$\text{Transmission Coefficient} = \mathbf{T} = \frac{V_{\text{Transmitted}}}{V_{\text{Incident}}} = \boldsymbol{\tau} \angle \boldsymbol{\phi}$$

$$\text{Insertion Loss (dB)} = -20 \text{ Log} \left| \frac{V_{\text{Trans}}}{V_{\text{Inc}}} \right| = -20 \log \boldsymbol{\tau}$$

$$\text{Gain (dB)} = 20 \text{ Log} \left| \frac{V_{\text{Trans}}}{V_{\text{Inc}}} \right| = 20 \log \boldsymbol{\tau}$$

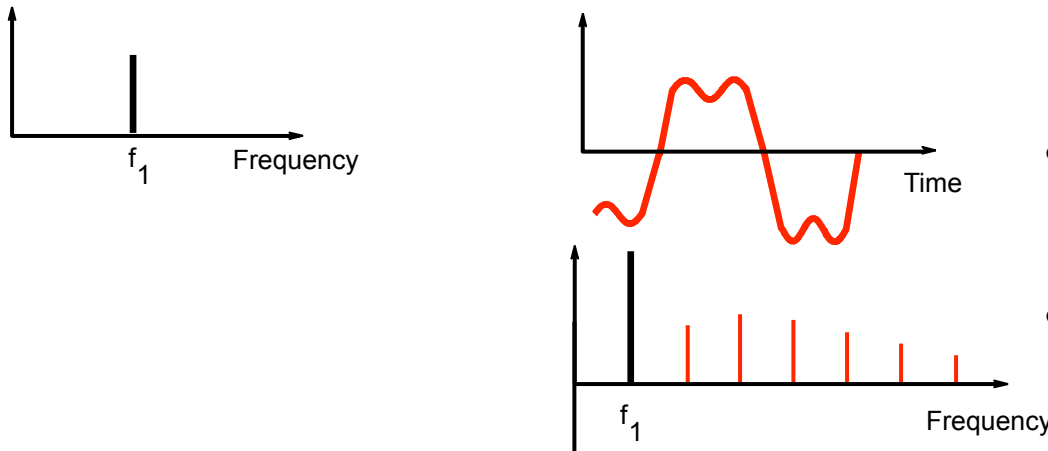
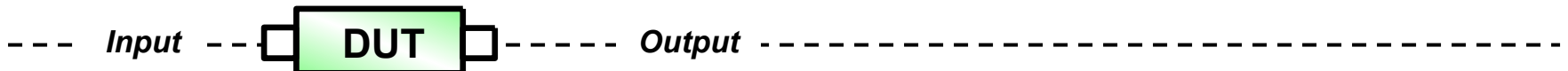


Linear Versus Nonlinear Behavior



Linear behavior:

- input and output frequencies are the same (no additional frequencies created)
- output frequency only undergoes magnitude and phase change

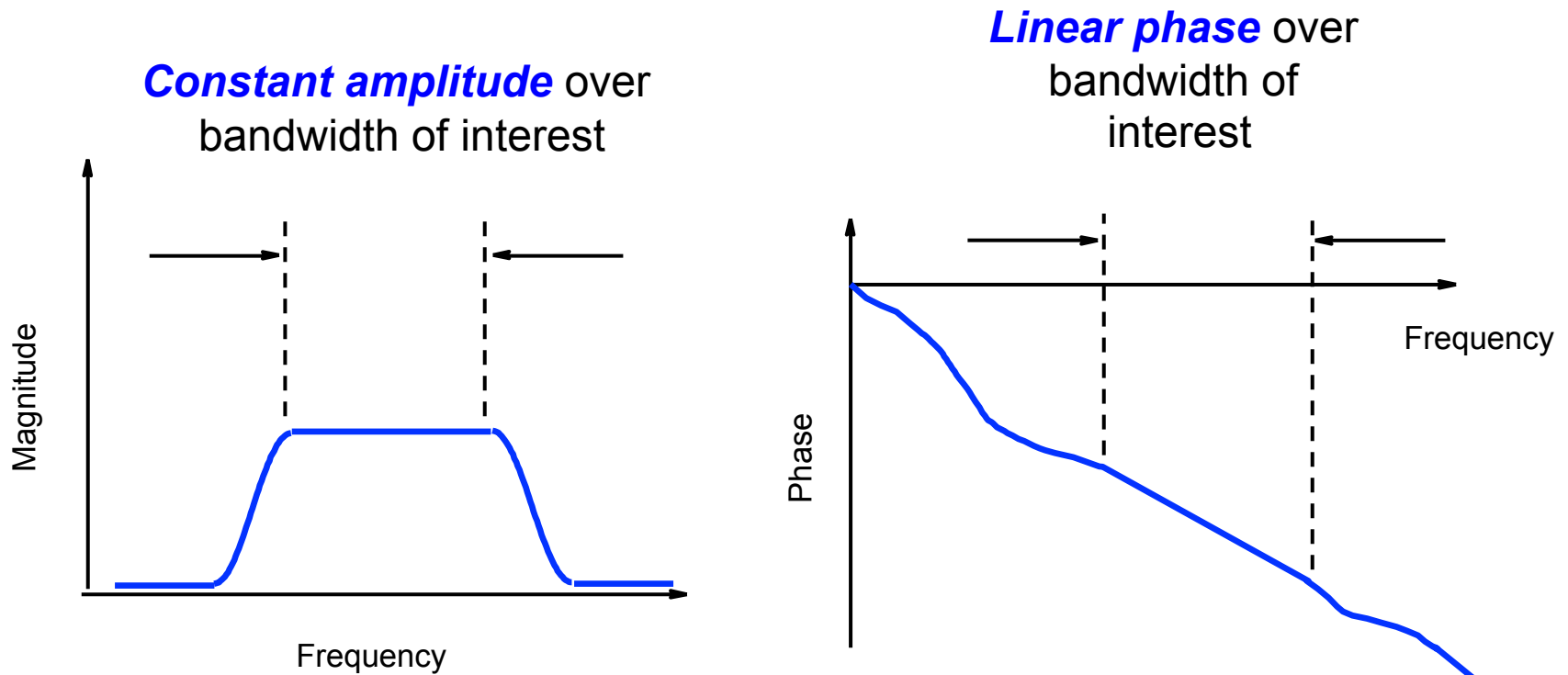


Nonlinear behavior:

- output frequency may undergo frequency shift (e.g. with mixers)
- additional frequencies created (harmonics, intermodulation)

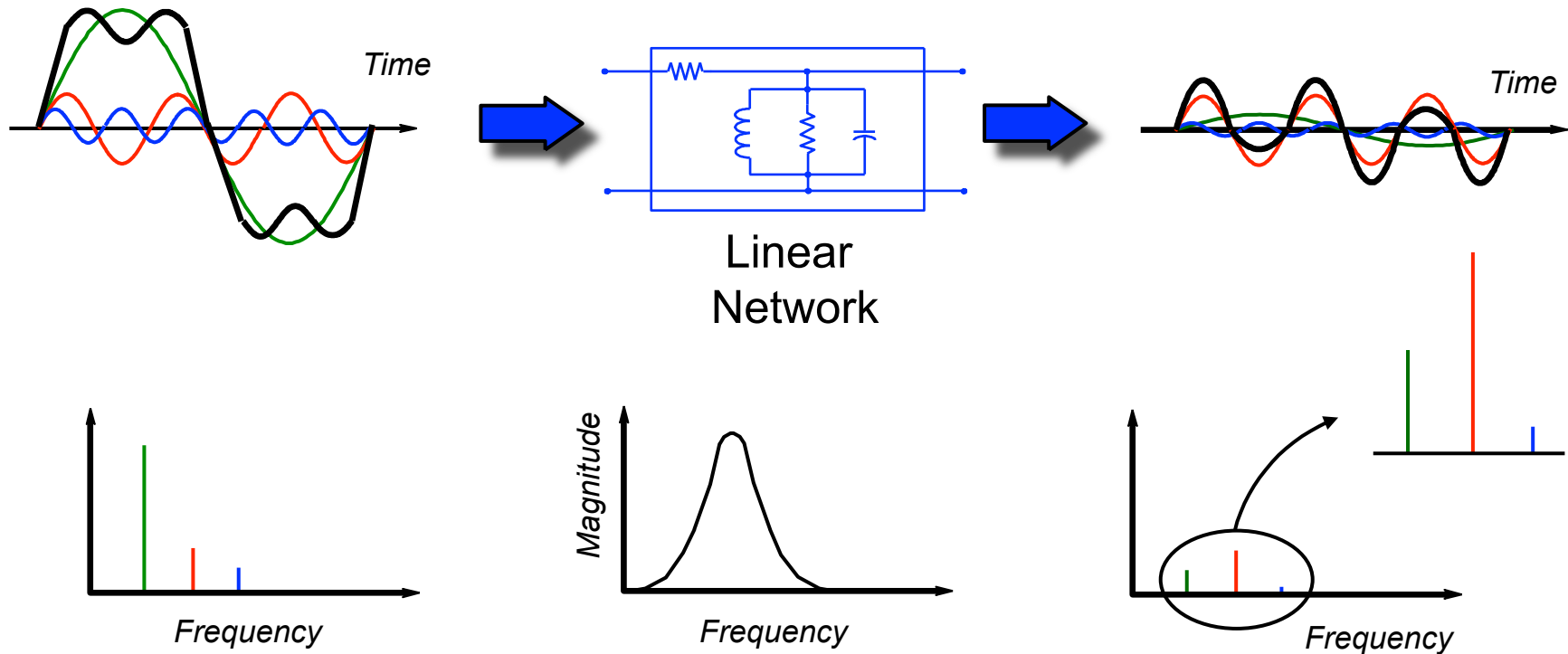
Criteria for Distortionless Transmission

Linear Networks



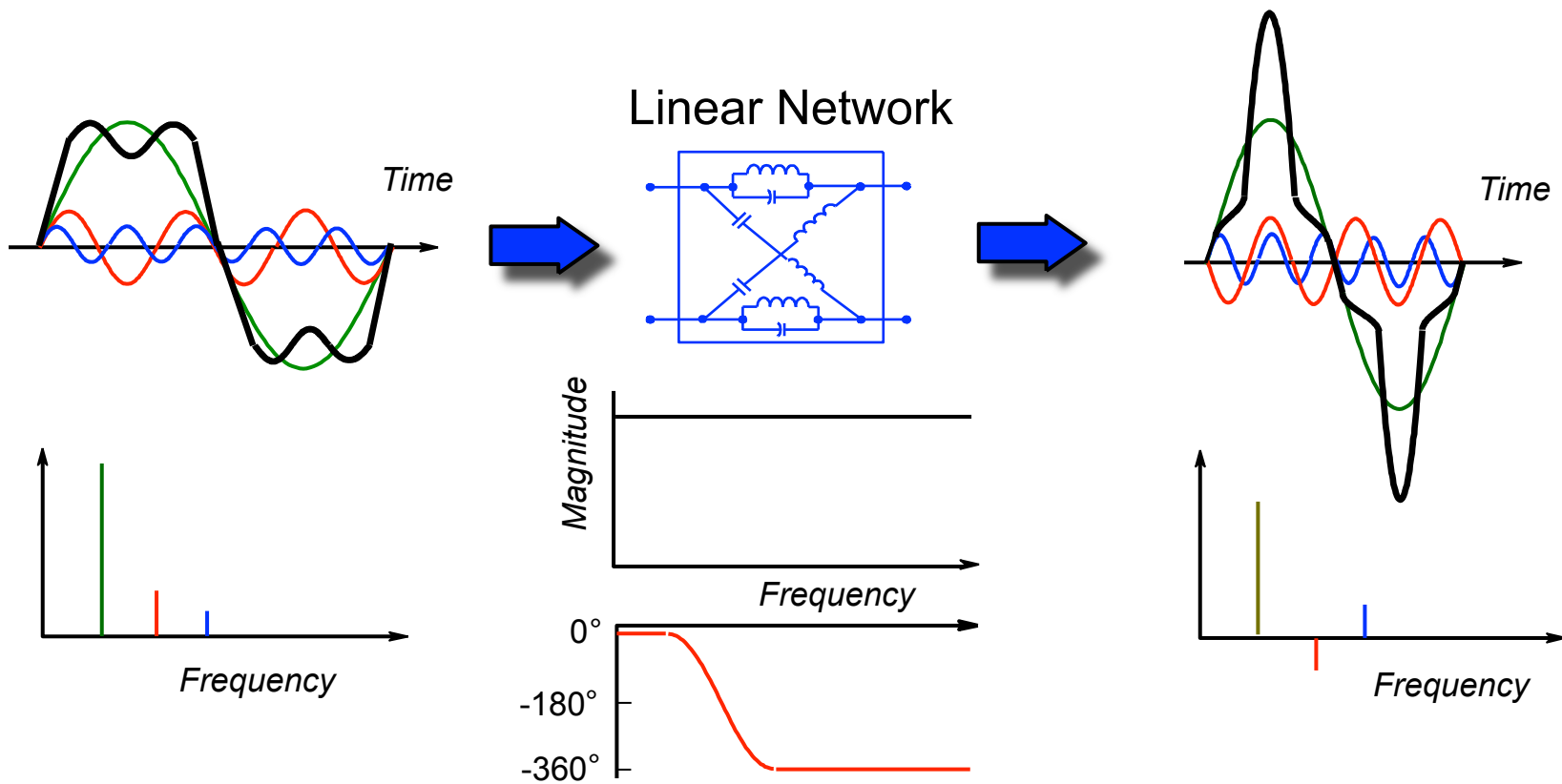
Magnitude Variation with Frequency

$$F(t) = \sin \omega t + \frac{1}{3} \sin 3\omega t + \frac{1}{5} \sin 5\omega t$$



Phase Variation with Frequency

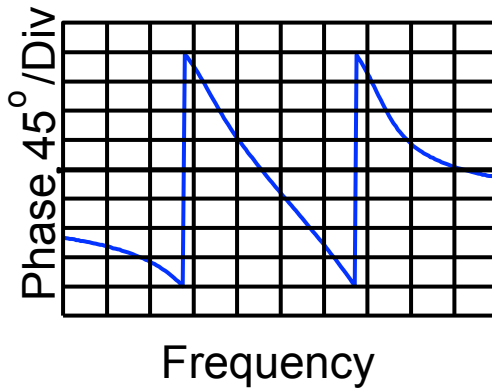
$$F(t) = \sin \omega t + \frac{1}{3} \sin 3\omega t + \frac{1}{5} \sin 5\omega t$$



Deviation from Linear Phase

*Use electrical delay to
remove linear portion of
phase response*

RF filter response

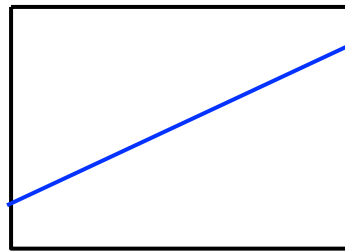


Low resolution

Linear electrical length
added

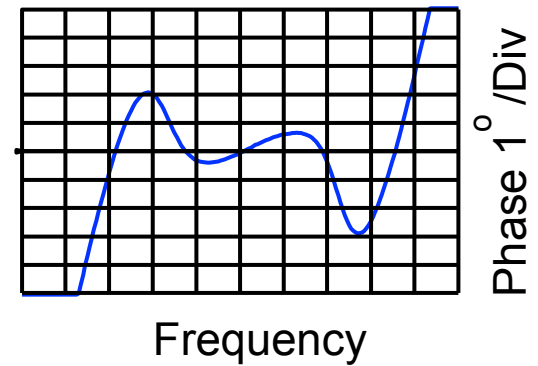
(Electrical delay function)

+



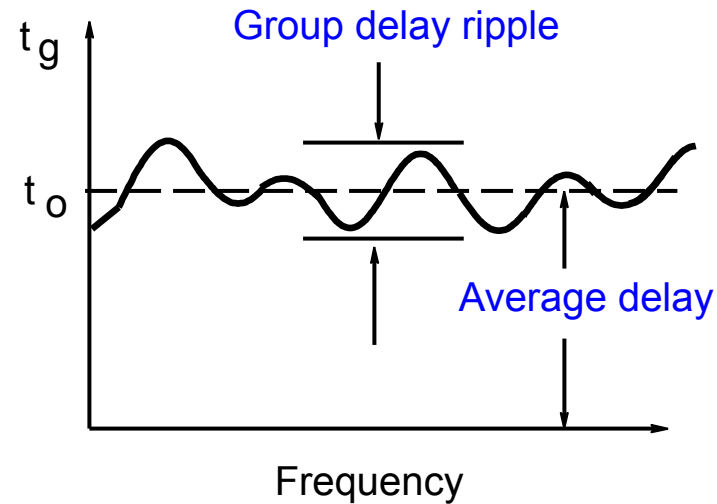
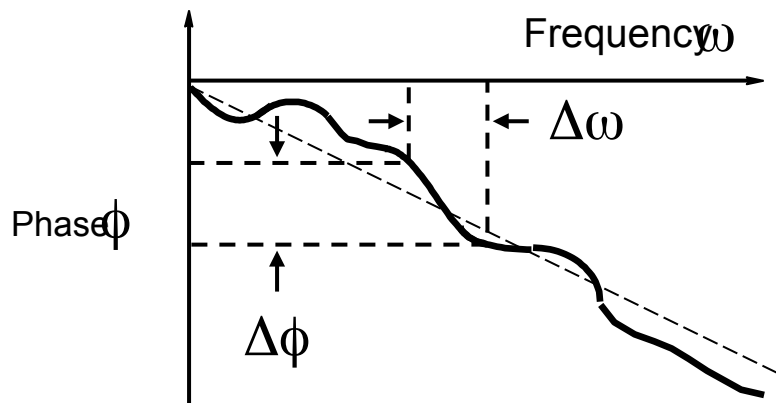
yields

Deviation from linear
phase



High resolution

Group Delay



Group Delay (t_g) =

$$\frac{-d\phi}{d\omega} = \frac{-1}{360^\circ} * \frac{d\phi}{df}$$

ϕ in radians

ω in radians/sec

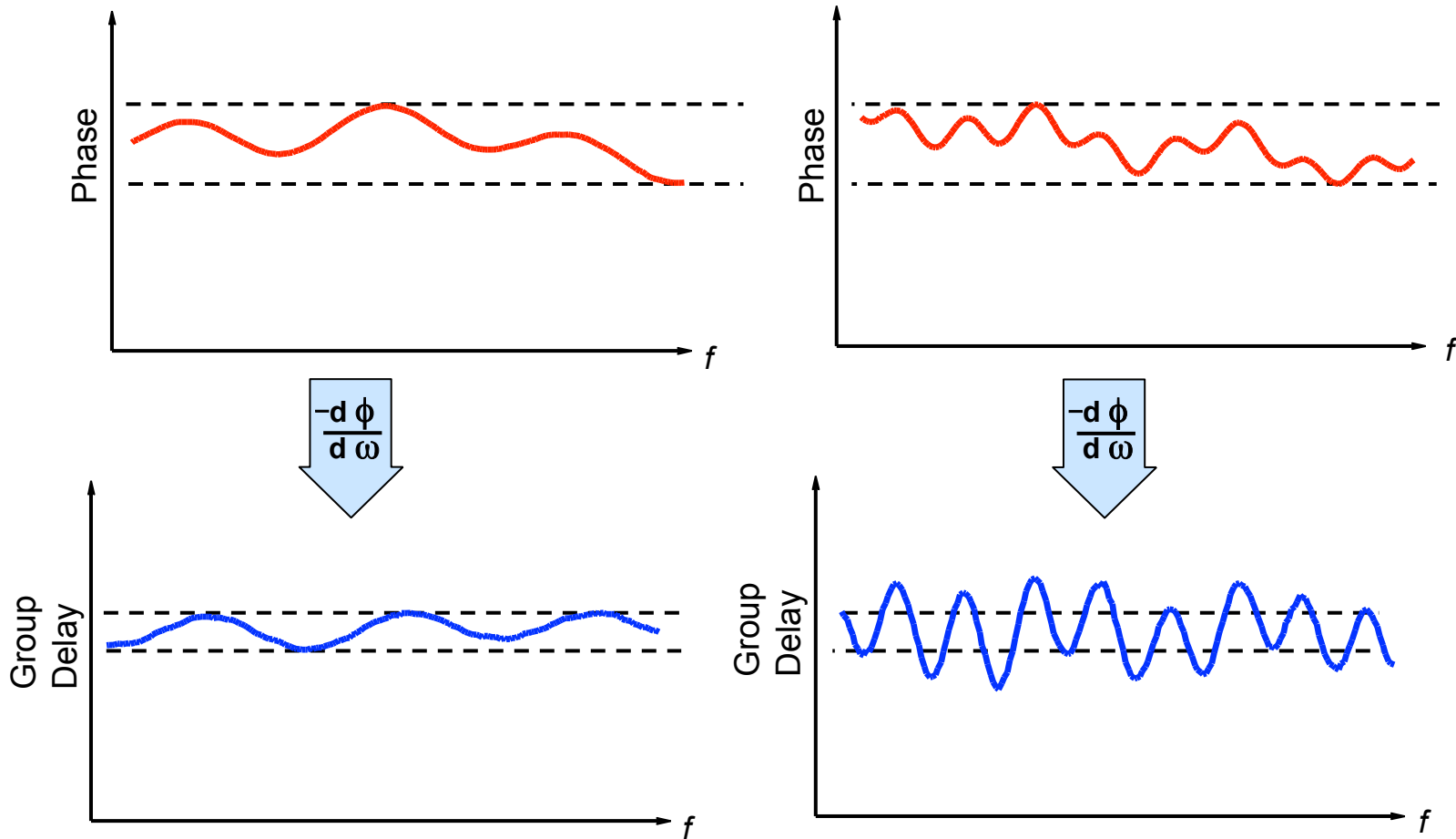
ϕ in degrees

f in Hertz ($\omega = 2\pi f$)

- group-delay ripple indicates phase distortion
- average delay indicates electrical length of DUT
- aperture of measurement is very important



Why Measure Group Delay?



Same p-p phase ripple can result in different group delay



Characterizing Unknown Devices

Using parameters (H, Y, Z, S) to characterize devices:

- gives linear behavioral model of our device
- measure parameters (e.g. voltage and current) versus frequency under various source and load conditions (e.g. short and open circuits)
- compute device parameters from measured data
- predict circuit performance under any source and load conditions

H-parameters

$$V_1 = h_{11}I_1 + h_{12}V_2$$

$$I_2 = h_{21}I_1 + h_{22}V_2$$

Y-parameters

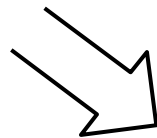
$$I_1 = y_{11}V_1 + y_{12}V_2$$

$$I_2 = y_{21}V_1 + y_{22}V_2$$

Z-parameters

$$V_1 = z_{11}I_1 + z_{12}I_2$$

$$V_2 = z_{21}I_1 + z_{22}I_2$$

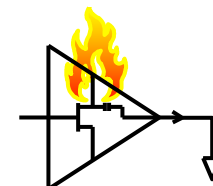


$$h_{11} = \left. \frac{V_1}{I_1} \right|_{V_2=0} \quad (\text{requires } \mathbf{short\ circuit})$$

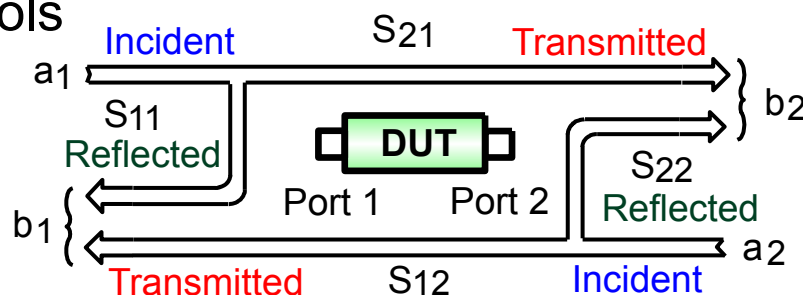
$$h_{12} = \left. \frac{V_1}{V_2} \right|_{I_1=0} \quad (\text{requires } \mathbf{open\ circuit})$$



Why Use S-Parameters?



- relatively easy to **obtain** at high frequencies
 - measure voltage traveling waves with a vector network analyzer
 - don't need shorts/opens which can cause active devices to oscillate or self-destruct
- relate to **familiar** measurements (gain, loss, reflection coefficient ...)
- can **cascade** S-parameters of multiple devices to predict system performance
- can **compute** H, Y, or Z parameters from S-parameters if desired
- can easily import and use S-parameter files in our **electronic-simulation** tools

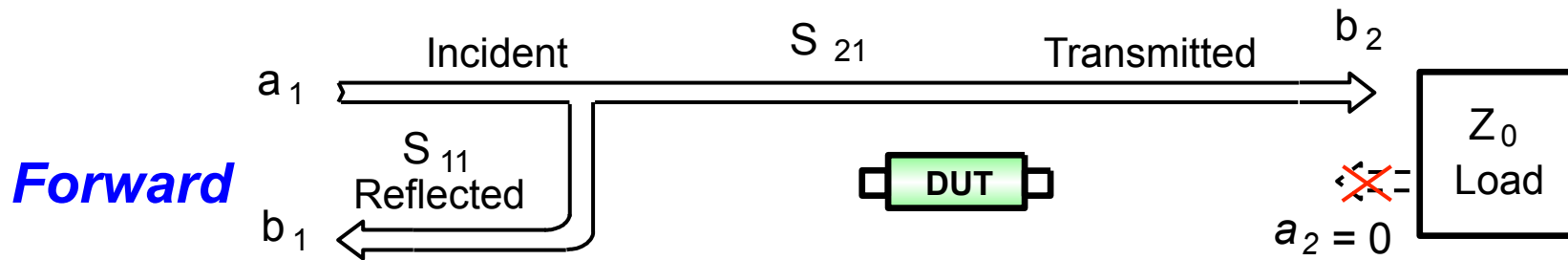


$$b_1 = S_{11}a_1 + S_{12}a_2$$

$$b_2 = S_{21}a_1 + S_{22}a_2$$



Measuring S-Parameters

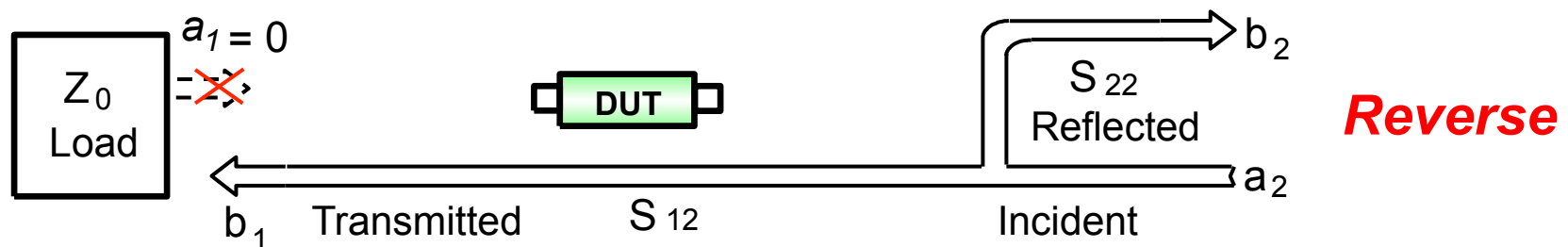


$$S_{11} = \frac{\text{Reflected}}{\text{Incident}} = \frac{b_1}{a_1} \Big|_{a_2 = 0}$$

$$S_{21} = \frac{\text{Transmitted}}{\text{Incident}} = \frac{b_2}{a_1} \Big|_{a_2 = 0}$$

$$S_{22} = \frac{\text{Reflected}}{\text{Incident}} = \frac{b_2}{a_2} \Big|_{a_1 = 0}$$

$$S_{12} = \frac{\text{Transmitted}}{\text{Incident}} = \frac{b_1}{a_2} \Big|_{a_1 = 0}$$



Equating S-Parameters with Common Measurement Terms

S11 = forward reflection coefficient (*input match*)

S22 = reverse reflection coefficient (*output match*)

S21 = forward transmission coefficient (*gain or loss*)

S12 = reverse transmission coefficient (*isolation*)

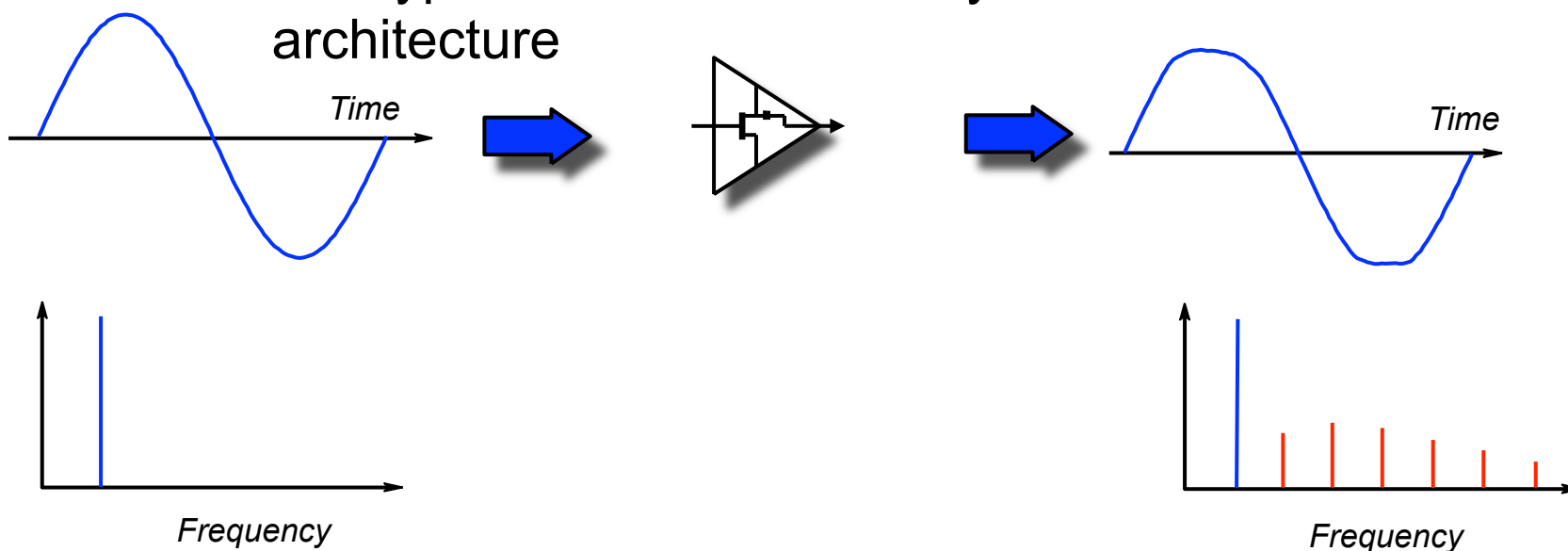
Remember, S-parameters are inherently complex, linear quantities -- however, we often express them in a log-magnitude format



Criteria for Distortionless Transmission

Nonlinear Networks

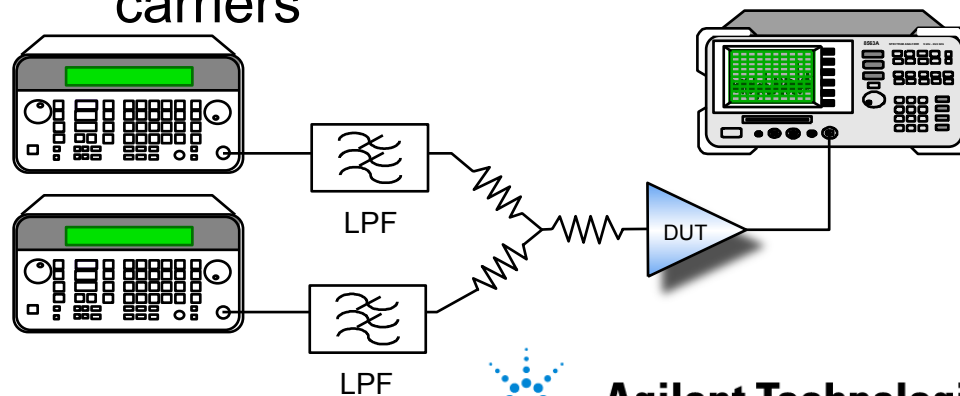
- Saturation, crossover, intermodulation, and other nonlinear effects can cause signal distortion
- Effect on system depends on amount and type of distortion and system architecture



Measuring Nonlinear Behavior

Most common measurements:

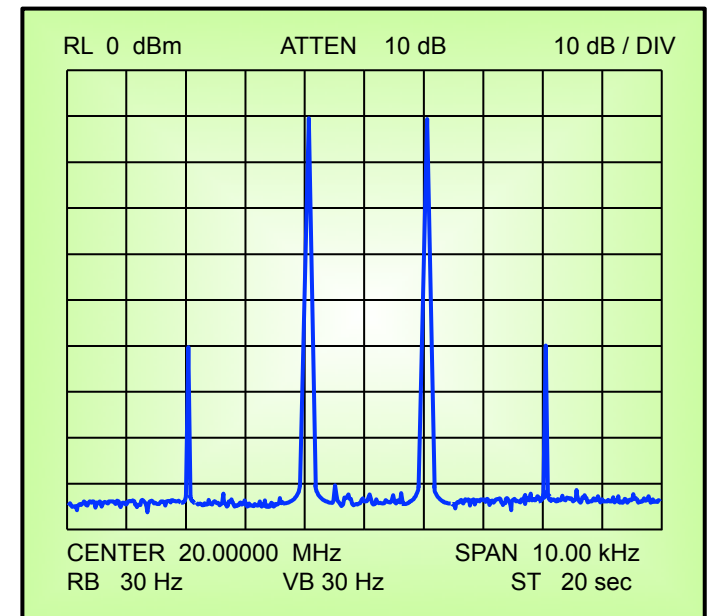
- using a **network analyzer** and power sweeps
 - gain compression
 - AM to PM conversion
- using a **spectrum analyzer** + source(s)
 - harmonics, particularly second and third
 - intermodulation products resulting from two or more RF carriers



Network Analyzer Basics

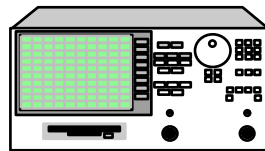
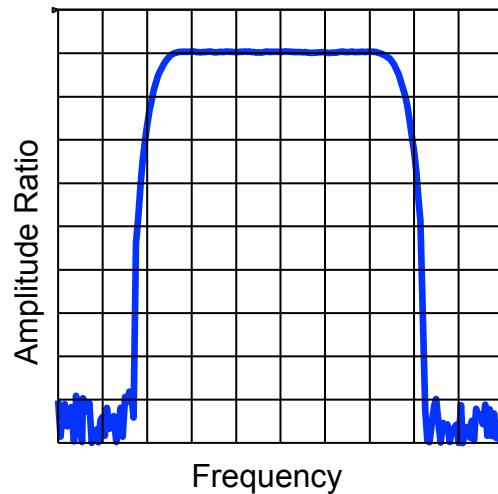


Agilent Technologies

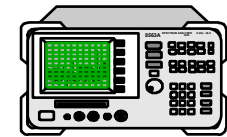
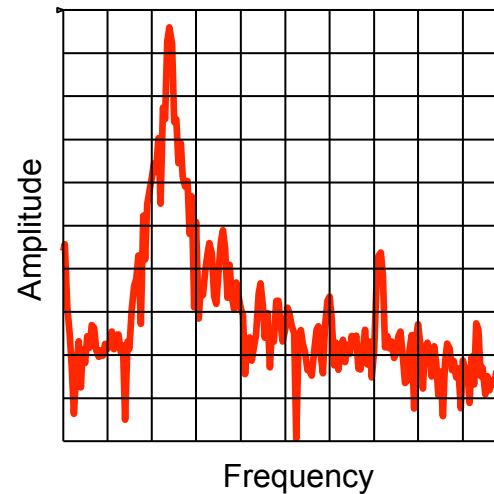


Copyright
2000

What is the Difference Between **Network** and **Spectrum** Analyzers?



Measures
known
signal



Measures
unknown
signals

Network analyzers:

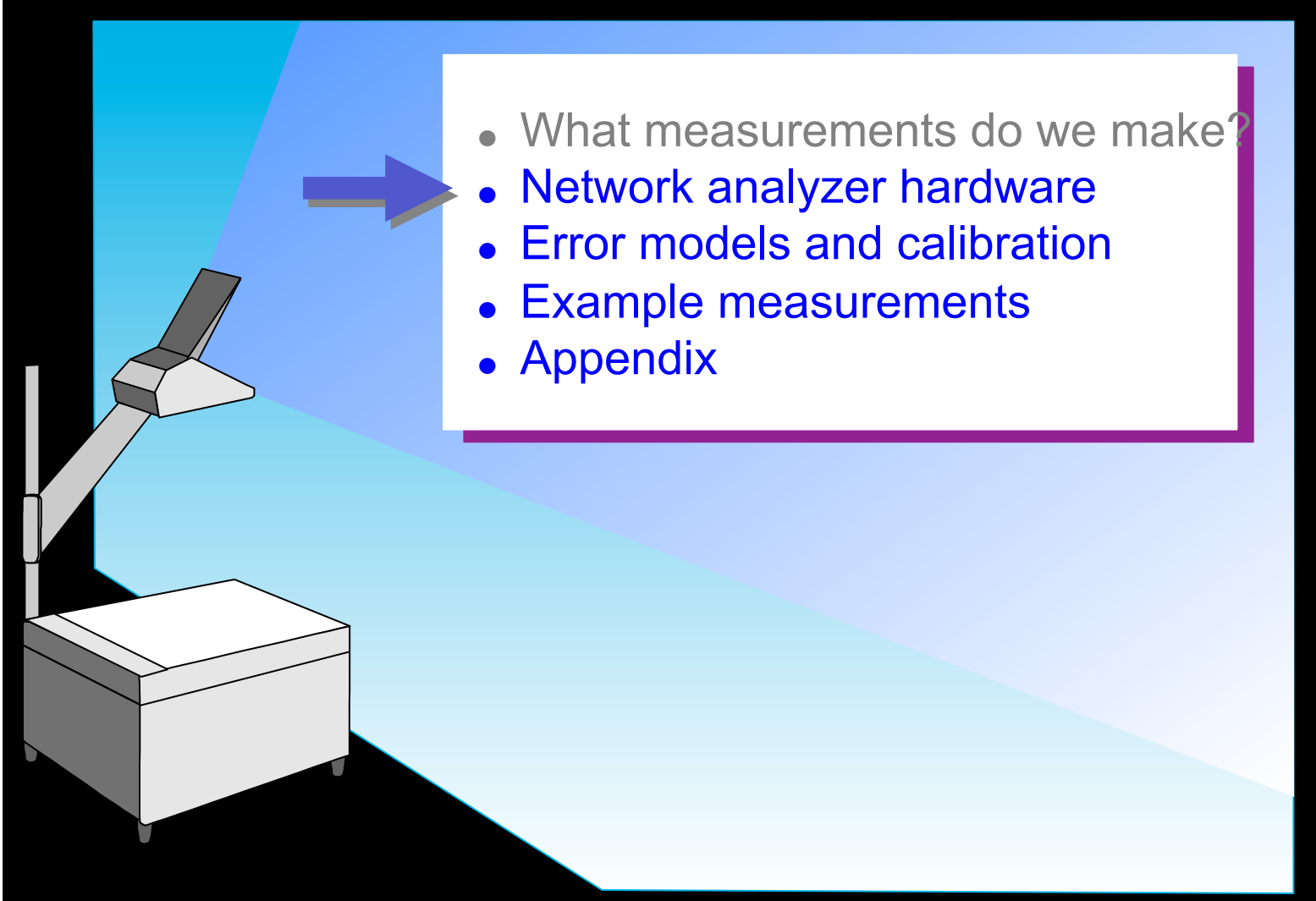
- measure components, devices, circuits, sub-assemblies
- contain source and receiver
- display ratioed amplitude and phase (frequency or power sweeps)
- offer advanced error correction

Spectrum analyzers:

- measure signal amplitude characteristics (carrier level, sidebands, harmonics...)
- can demodulate (& measure) complex signals
- are receivers only (single channel)
- can be used for scalar component test (*no phase*) with tracking gen. or ext. source(s)

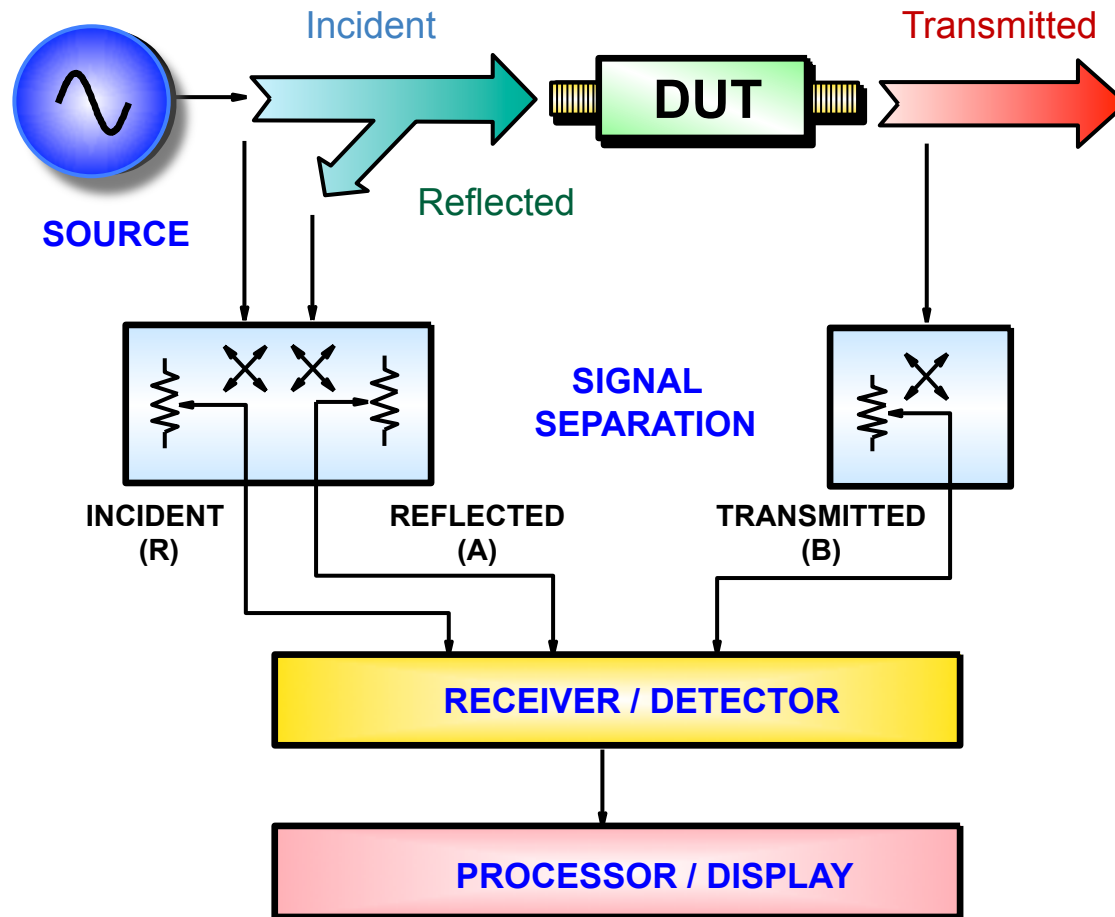


Agenda

- 
- What measurements do we make?
 - Network analyzer hardware
 - Error models and calibration
 - Example measurements
 - Appendix

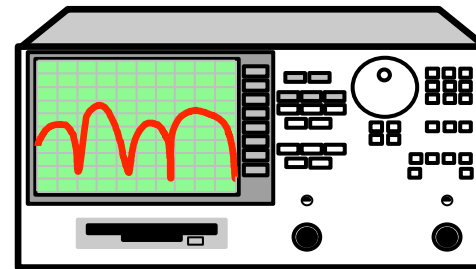
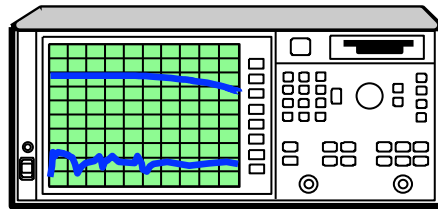
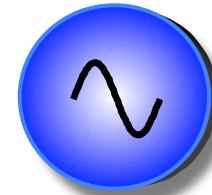


Generalized Network Analyzer Block Diagram



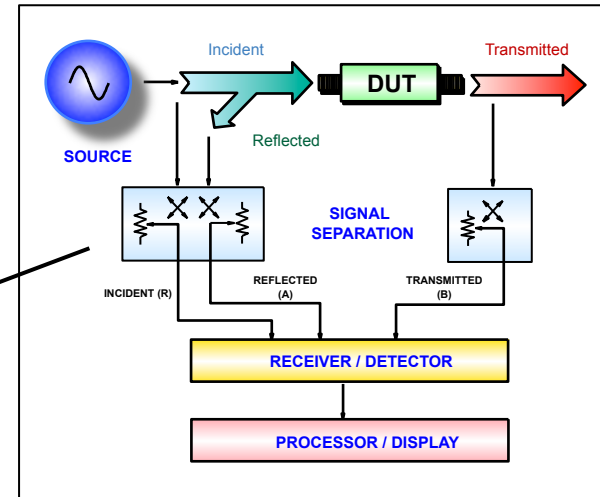
Source

- Supplies stimulus for system
- Swept frequency or power
- Traditionally NAs used separate source
- Most Agilent analyzers sold today have **integrated, synthesized** sources

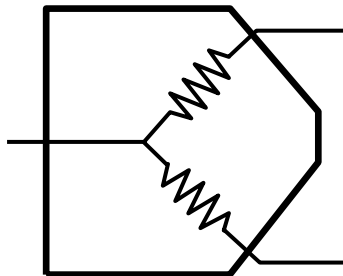


Signal Separation

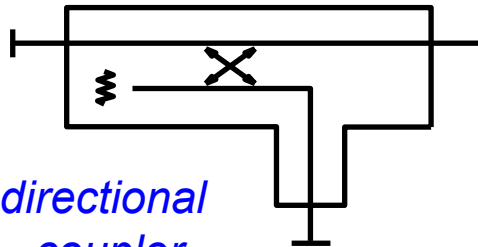
- measure incident signal for reference
- separate incident and reflected signals



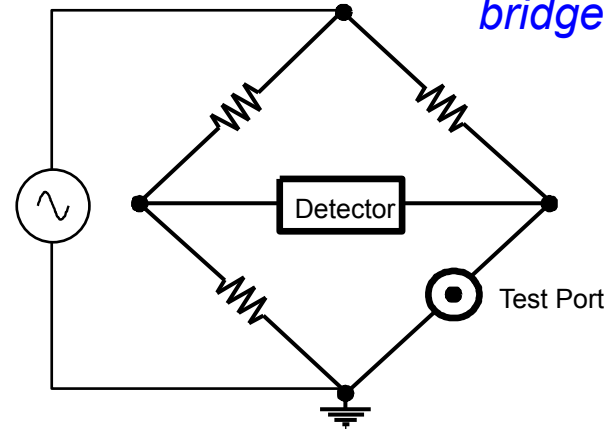
splitter



directional coupler

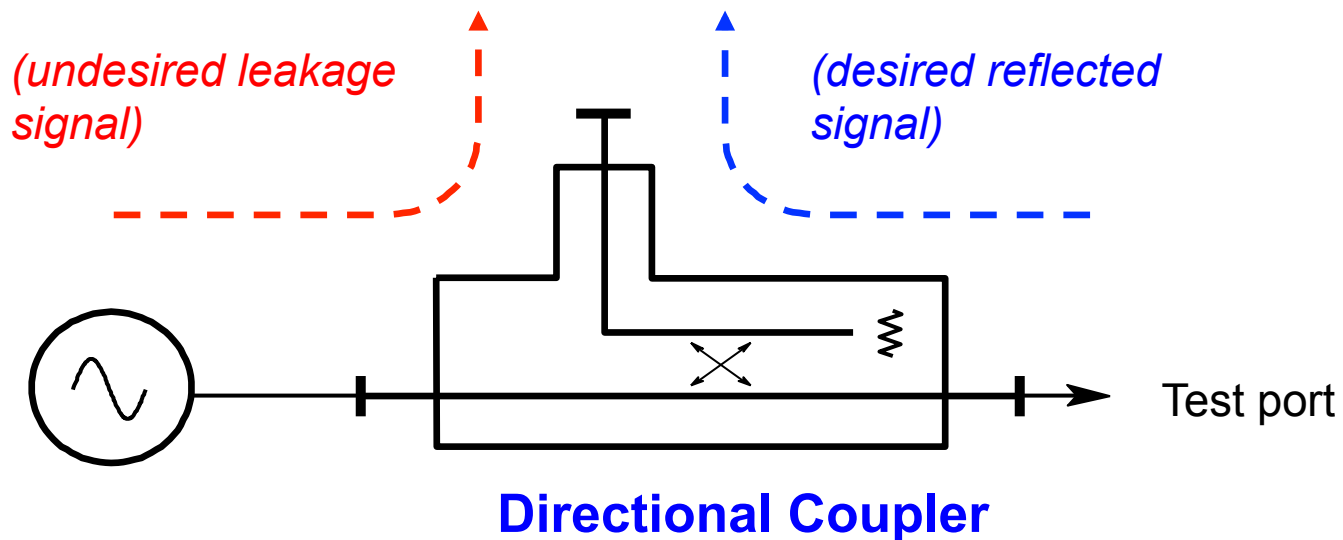


bridge

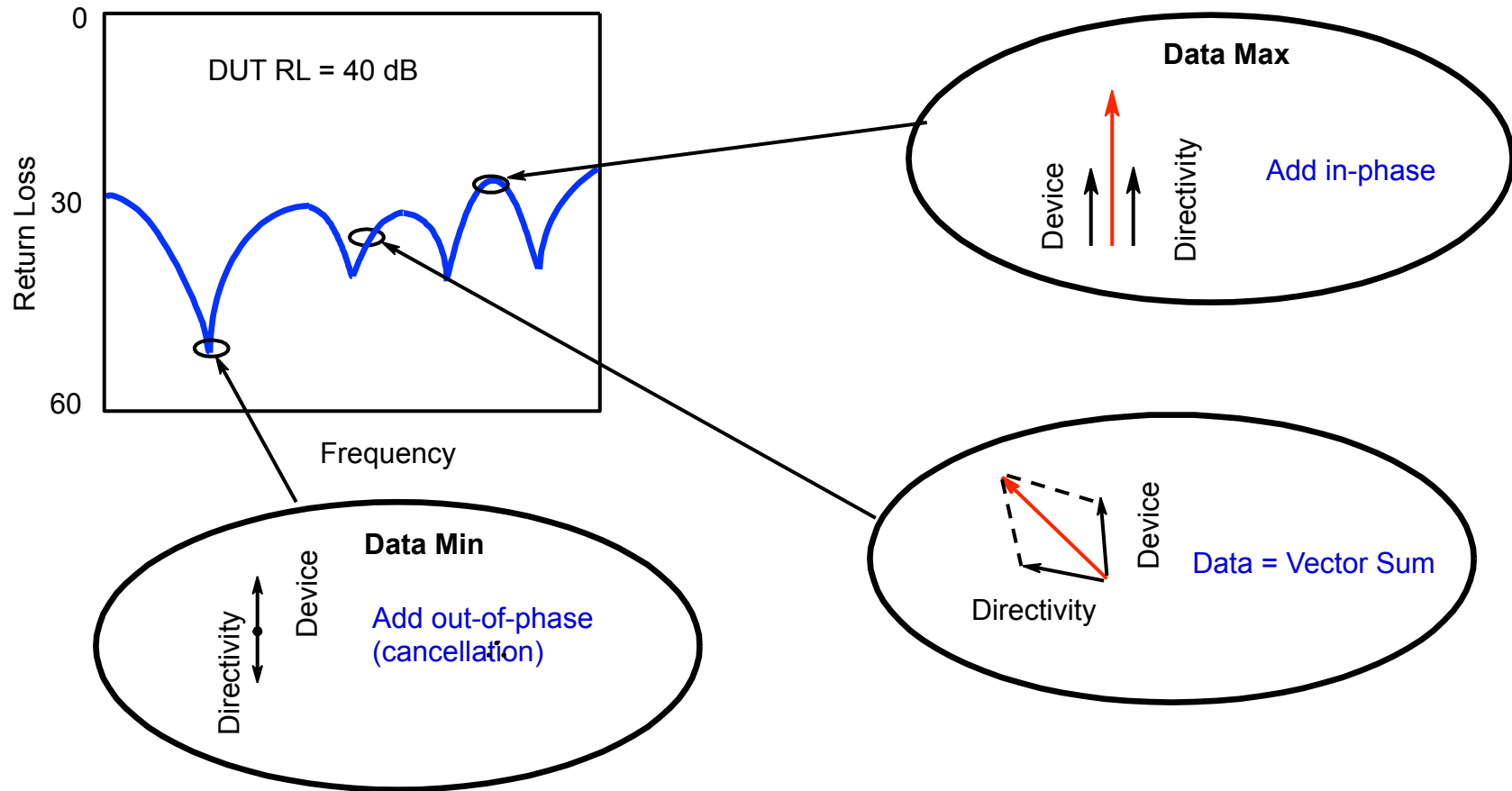


Directivity

Directivity is a measure of how well a coupler can separate signals moving in opposite directions



Interaction of Directivity with the DUT (Without Error Correction)

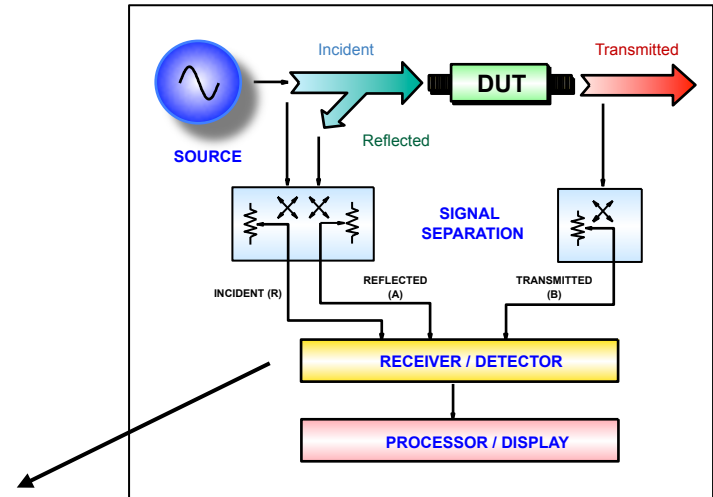
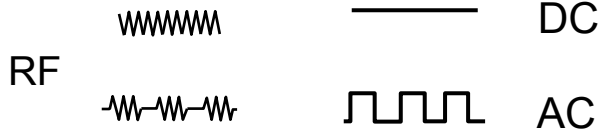


Detector Types

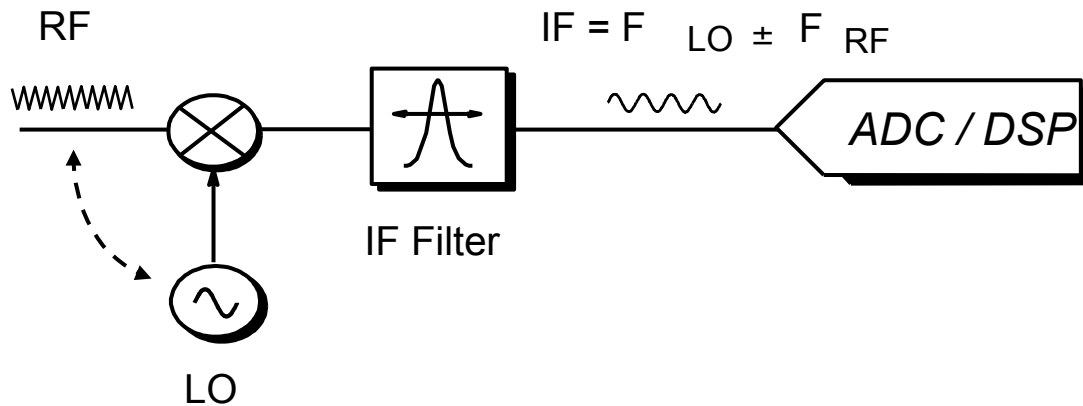
Diode



Scalar **broadband**
(no phase information)

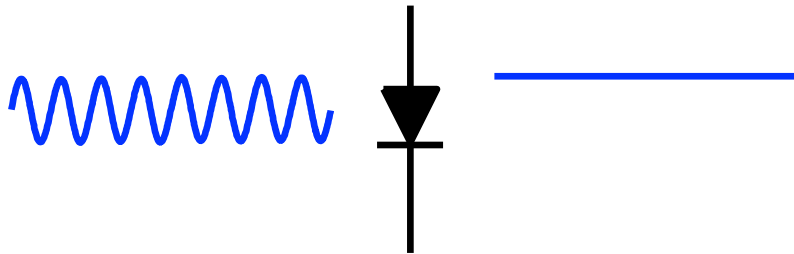


Tuned Receiver

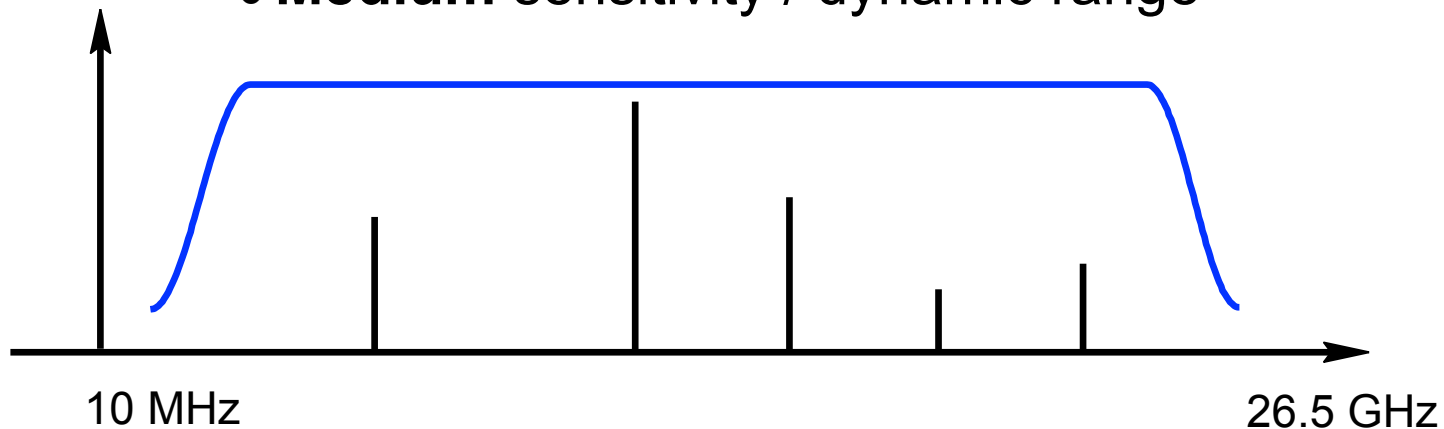


Vector
(magnitude and phase)

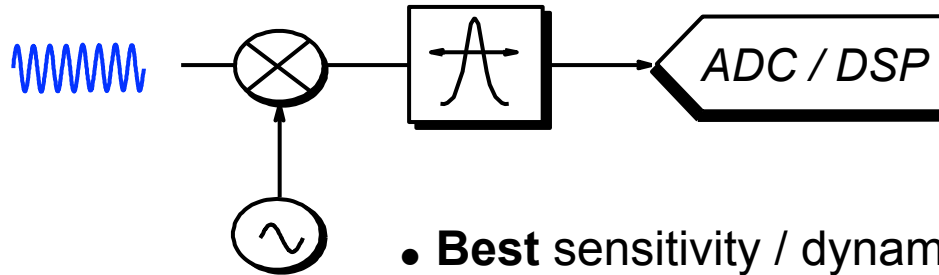
Broadband Diode Detection



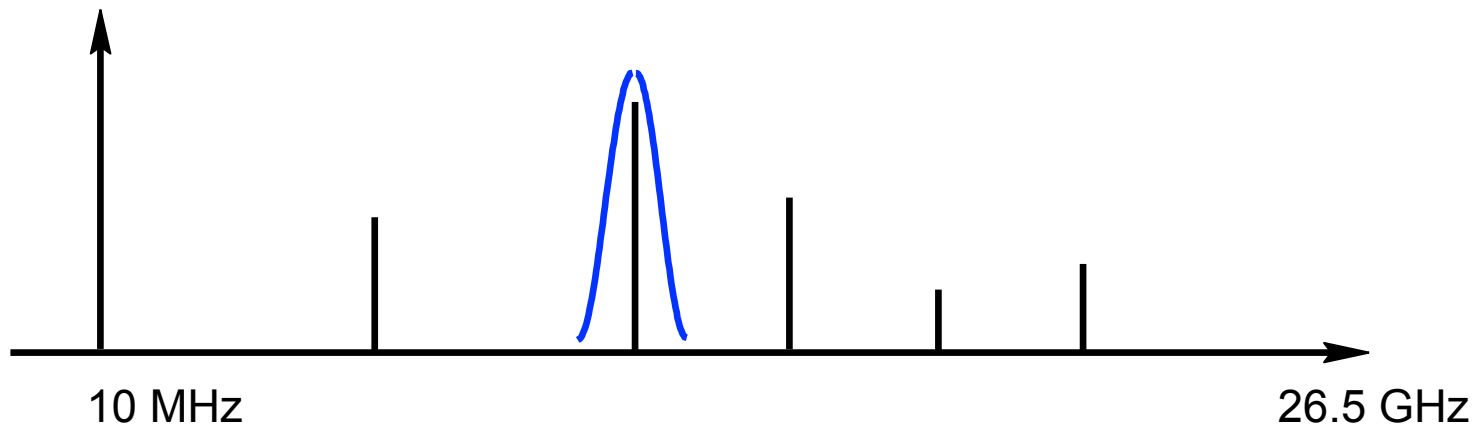
- Easy to make **broadband**
- **Inexpensive** compared to tuned receiver
- Good for measuring frequency-translating devices
- Improve dynamic range by increasing power
- **Medium** sensitivity / dynamic range



Narrowband Detection - Tuned Receiver

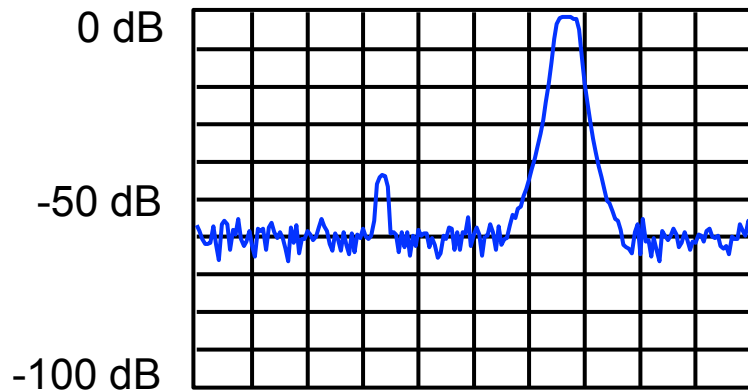


- **Best** sensitivity / dynamic range
- Provides harmonic / spurious signal **rejection**
- Improve dynamic range by increasing **power**, decreasing IF **bandwidth**, or **averaging**
- Trade off noise floor and measurement speed



Comparison of Receiver Techniques

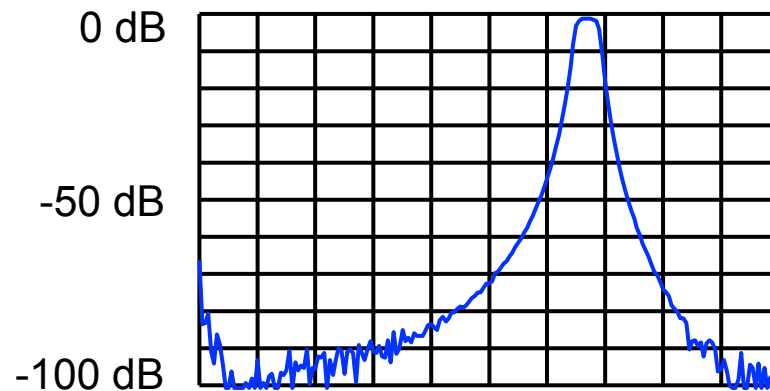
Broadband (diode) detection



-60 dBm Sensitivity

- higher noise floor
- false responses

Narrowband (tuned-receiver) detection



< -100 dBm Sensitivity

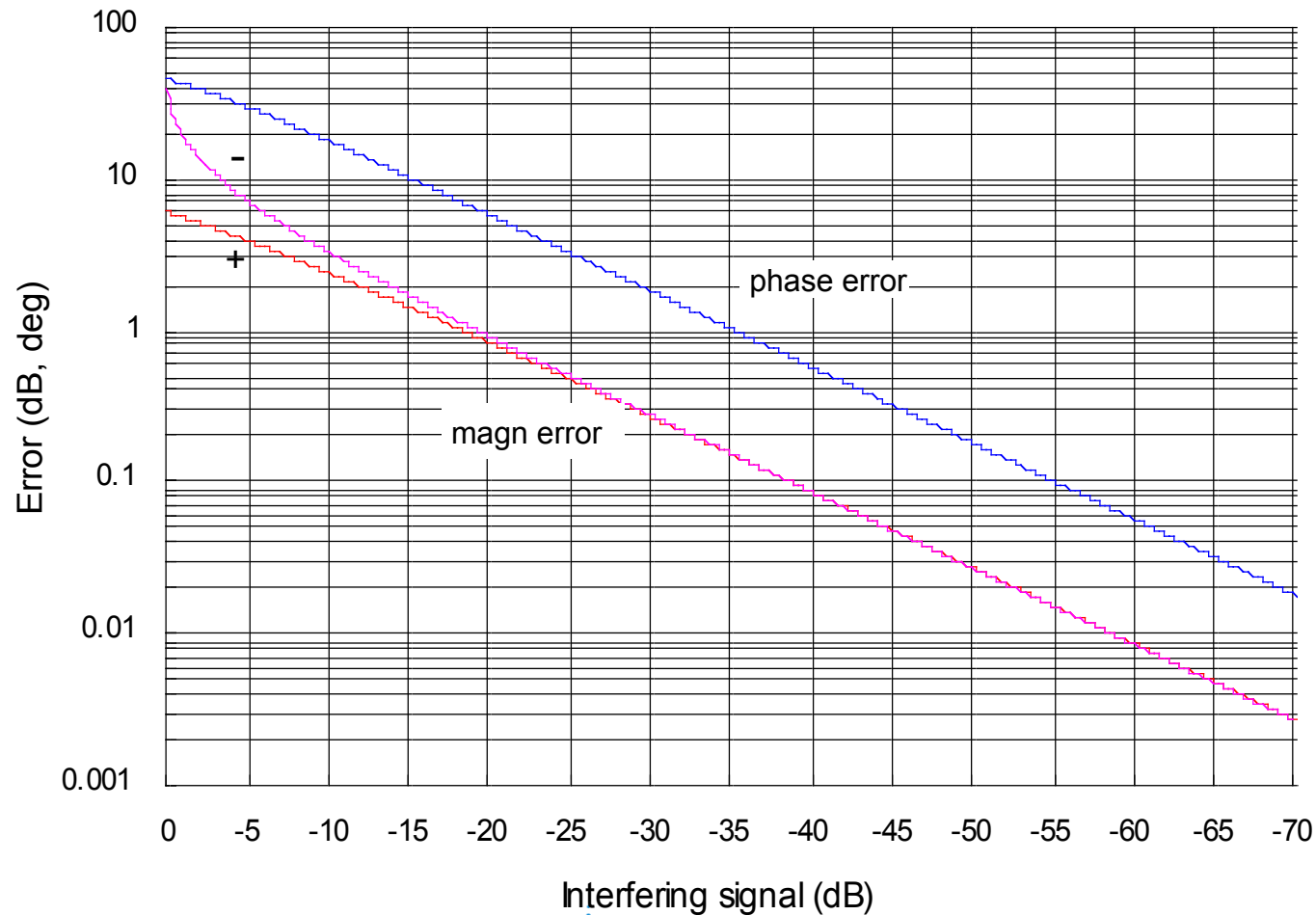
- high dynamic range
- harmonic immunity

***Dynamic range = maximum receiver power -
receiver noise floor***



Dynamic Range and Accuracy

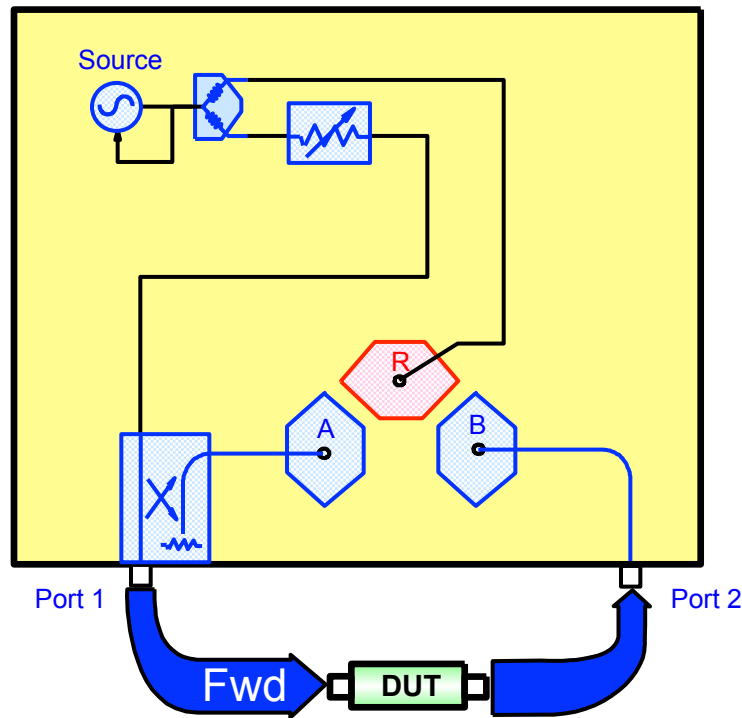
Error Due to Interfering Signal



Dynamic range is very important for measurement accuracy!

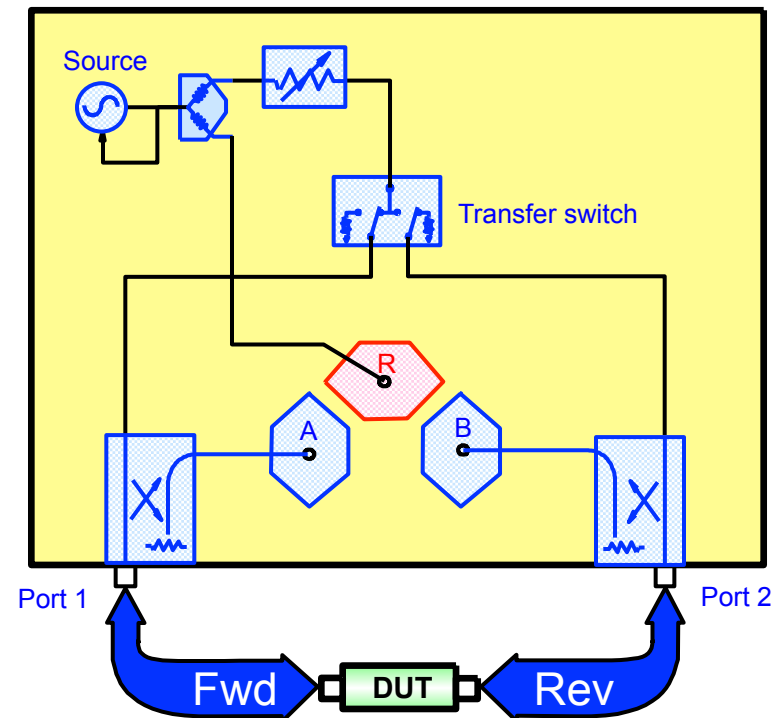
T/R Versus S-Parameter Test Sets

Transmission/Reflection Test Set



- RF always comes out port 1
- port 2 is always receiver
- **response, one-port** cal available

S-Parameter Test Set

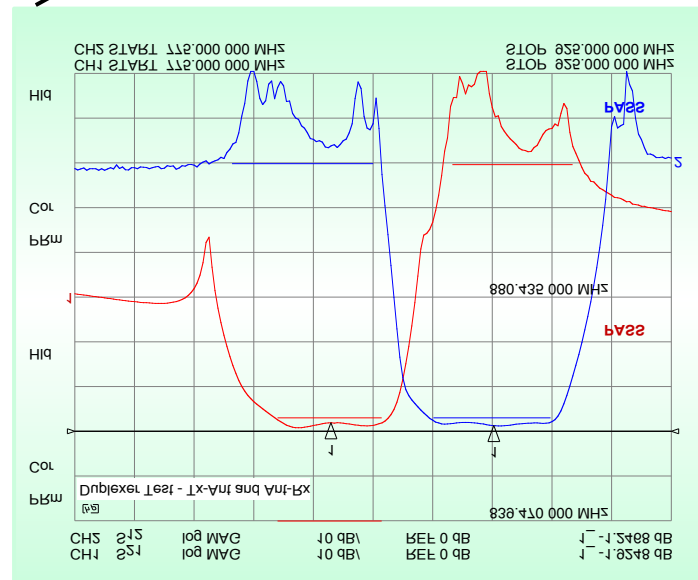
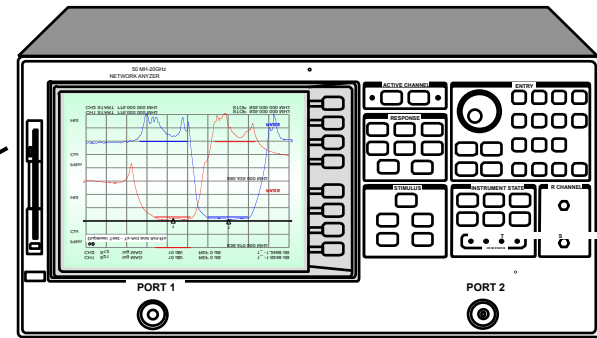
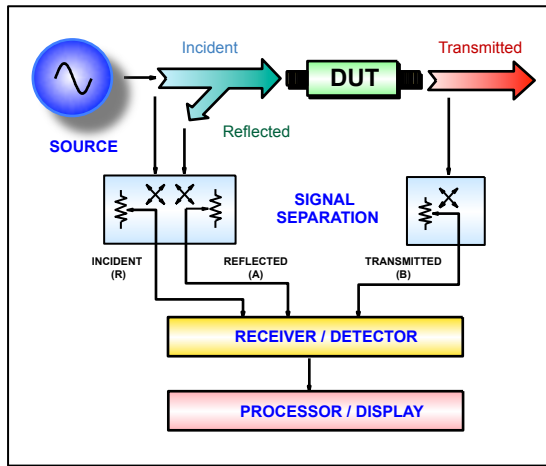


- RF comes out port 1 or port 2
- forward and reverse measurements
- **two-port** calibration possible

Copyright
2000

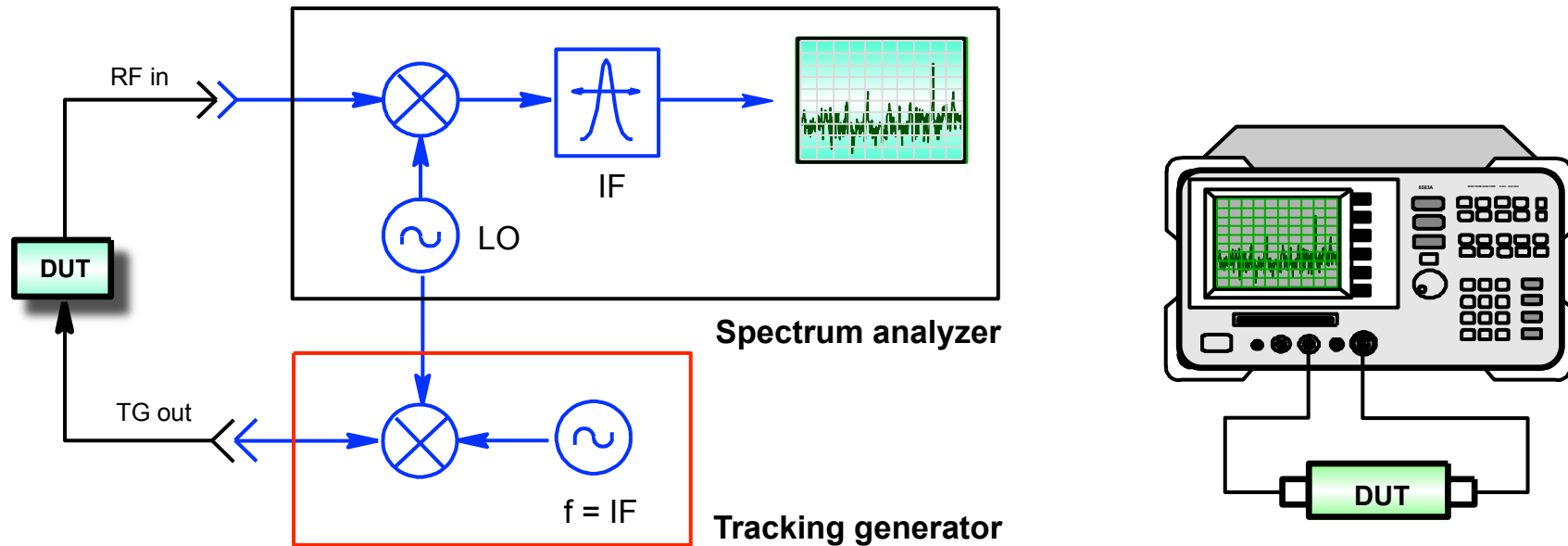


Processor / Display



- markers
- limit lines
- pass/fail indicators
- linear/log formats
- grid/polar/Smith charts

Spectrum Analyzer / Tracking Generator

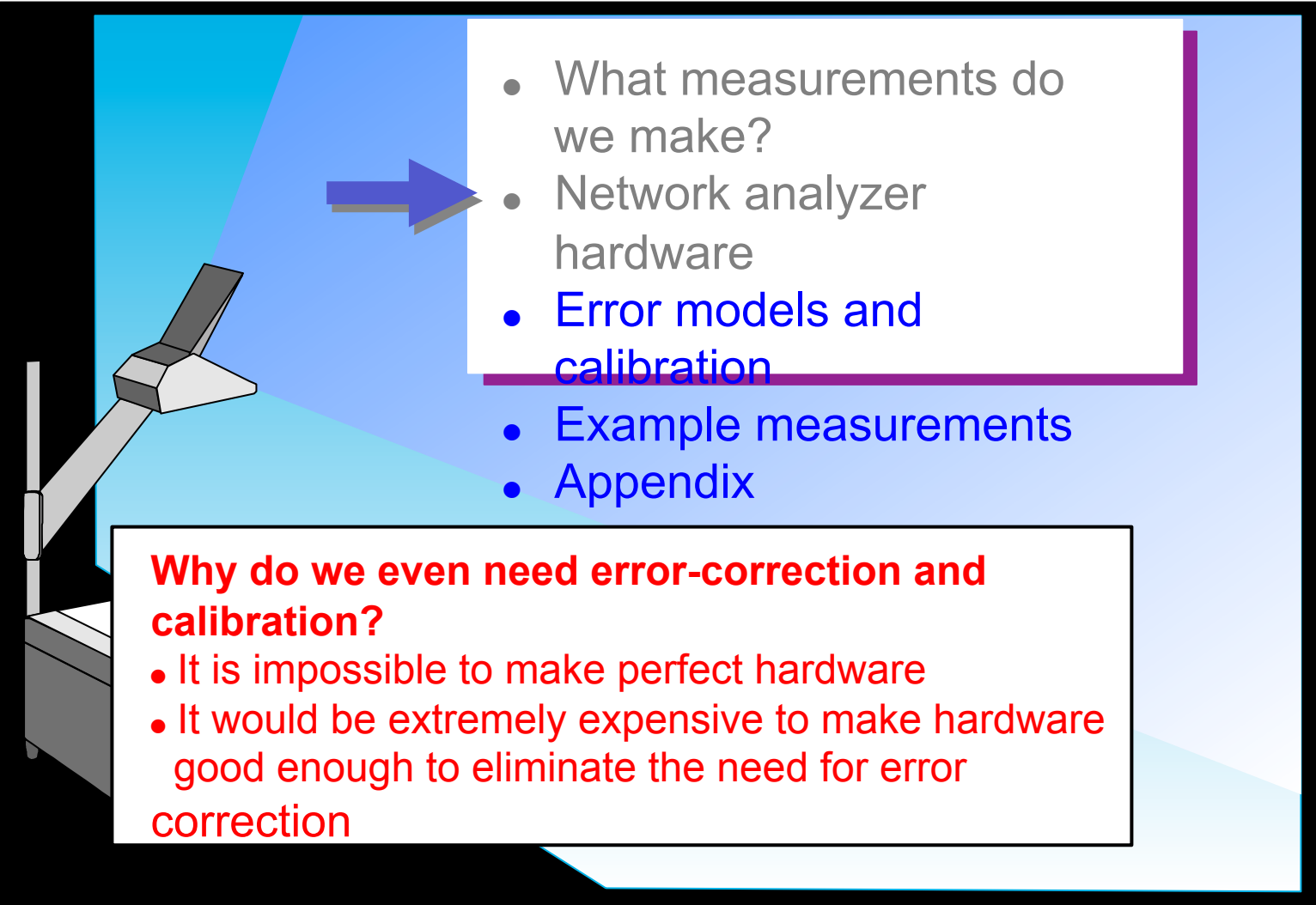


Key differences from network analyzer:

- **one channel** -- no ratioed or phase measurements
- More **expensive** than scalar NA (but better dynamic range)
- Only error correction available is **normalization** (and possibly open-short averaging)
- Poorer **accuracy**
- Small **incremental cost** if SA is required for other measurements



Agenda

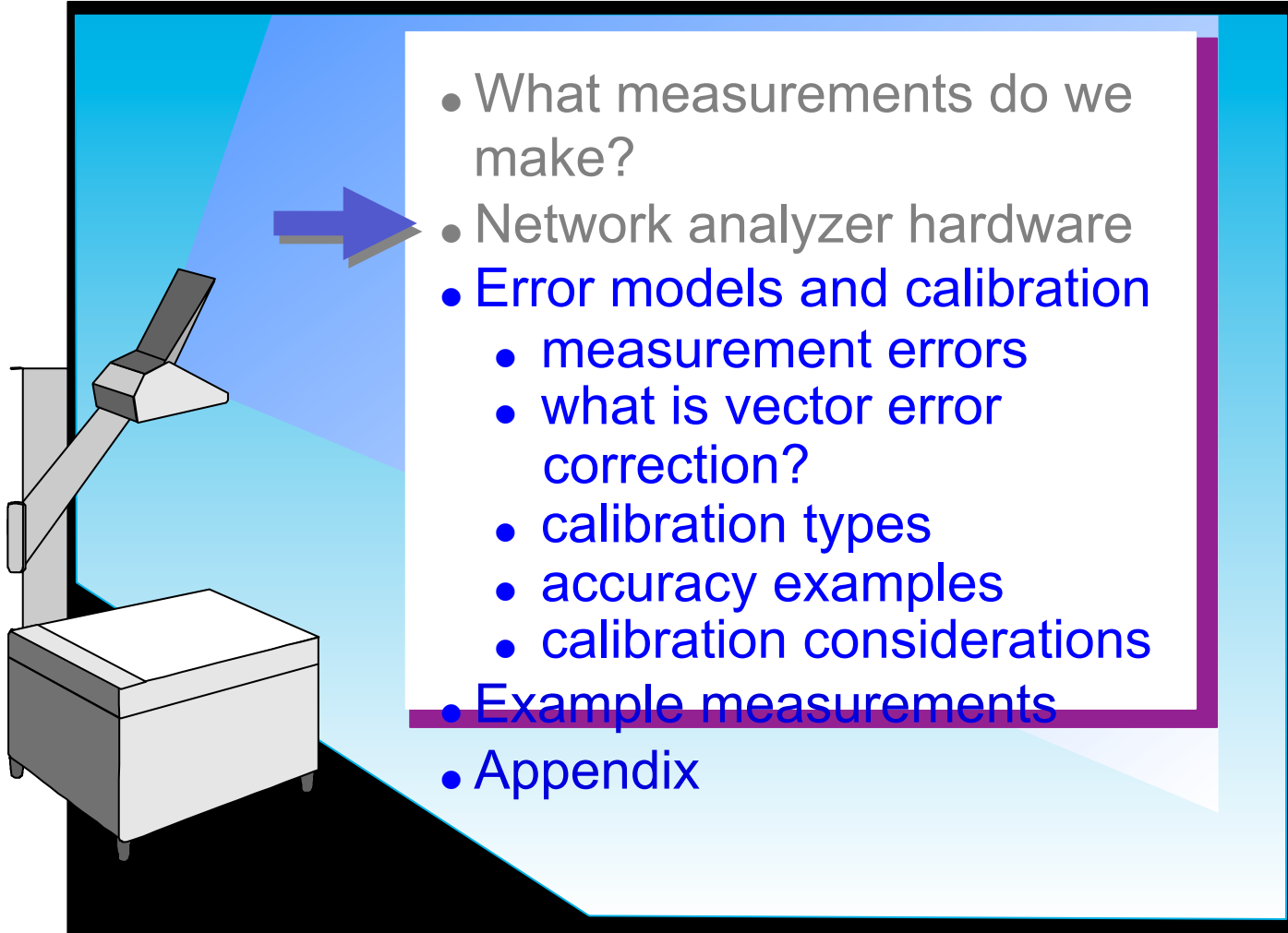
- 
- What measurements do we make?
 - Network analyzer hardware
 - Error models and calibration
 - Example measurements
 - Appendix

Why do we even need error-correction and calibration?

- It is impossible to make perfect hardware
- It would be extremely expensive to make hardware good enough to eliminate the need for error correction



Calibration Topics



A stylized illustration of a network analyzer on the left, with a blue beam of light emanating from its probe and pointing towards a white rectangular box on the right. The box contains a list of calibration topics. The background is a light blue gradient with a dark blue border.

- What measurements do we make?
- Network analyzer hardware
- **Error models and calibration**
 - measurement errors
 - what is vector error correction?
 - calibration types
 - accuracy examples
 - calibration considerations
- **Example measurements**
- **Appendix**



Measurement Error Modeling

Systematic errors

- due to **imperfections** in the analyzer and test setup
- assumed to be **time invariant** (predictable)



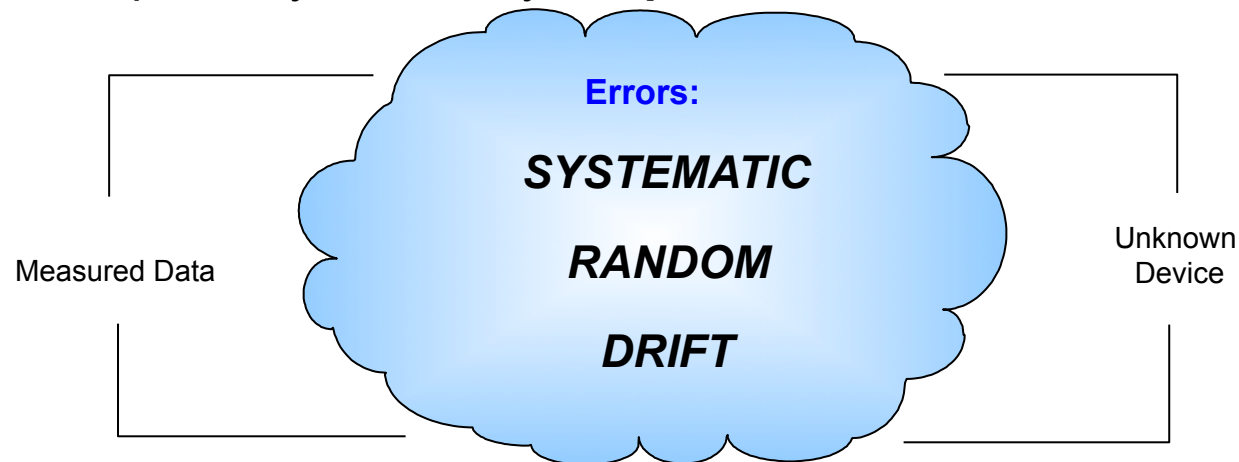
Random errors

- **vary** with time in random fashion (unpredictable)
- main contributors: instrument **noise**, switch and connector **repeatability**

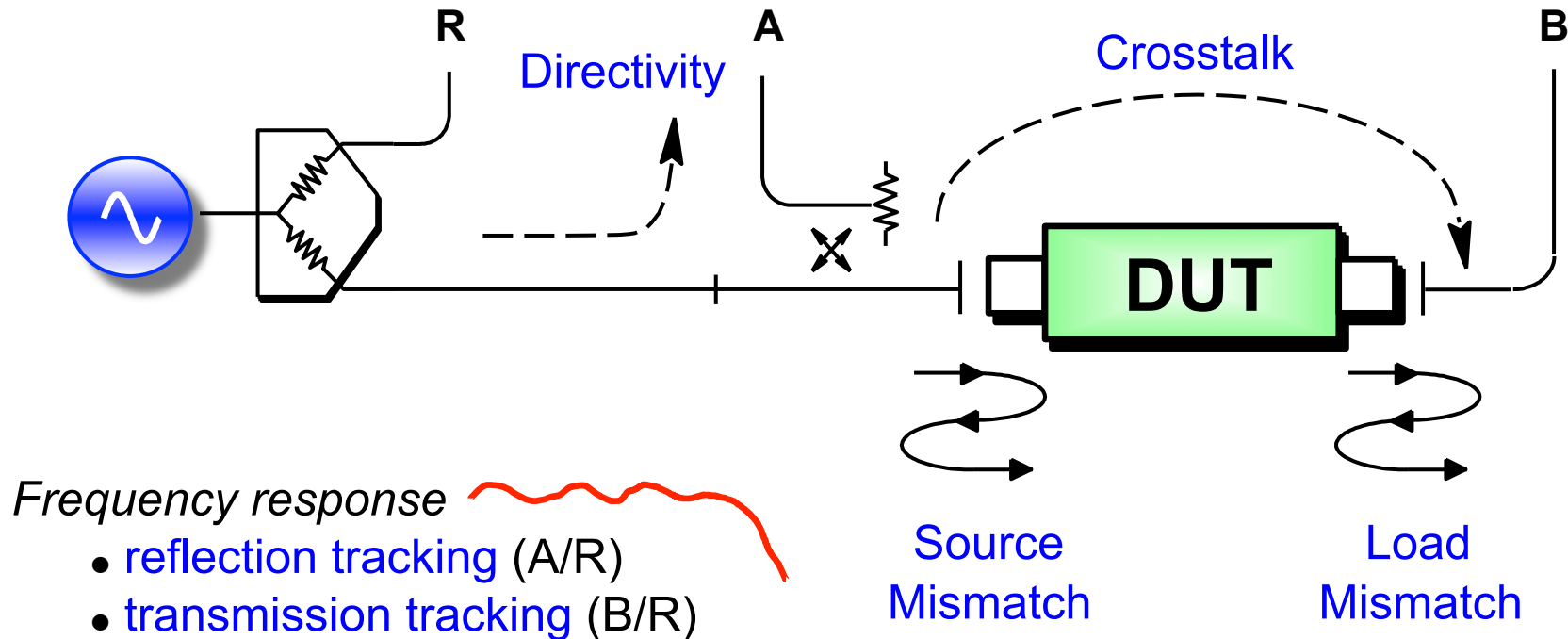


Drift errors

- due to system performance changing **after** a calibration has been done
- primarily caused by **temperature variation**



Systematic Measurement Errors



Six forward and six reverse error terms yields 12 error terms for two-

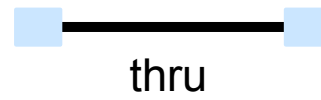
port devices
Agilent Technologies



Types of Error Correction

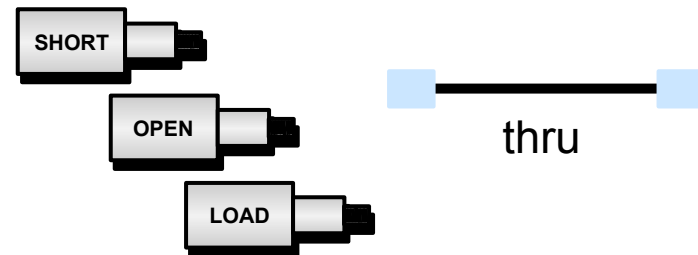
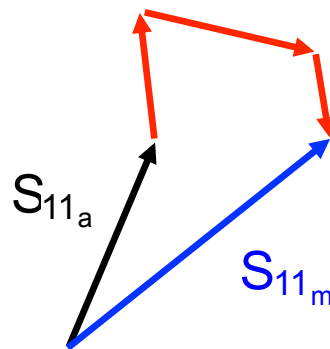
- **response (normalization)**

- simple to perform
- only corrects for tracking errors
- stores reference trace in memory, then does data divided by memory



- **vector**

- requires more standards
- requires an analyzer that can measure phase
- accounts for all major sources of systematic error

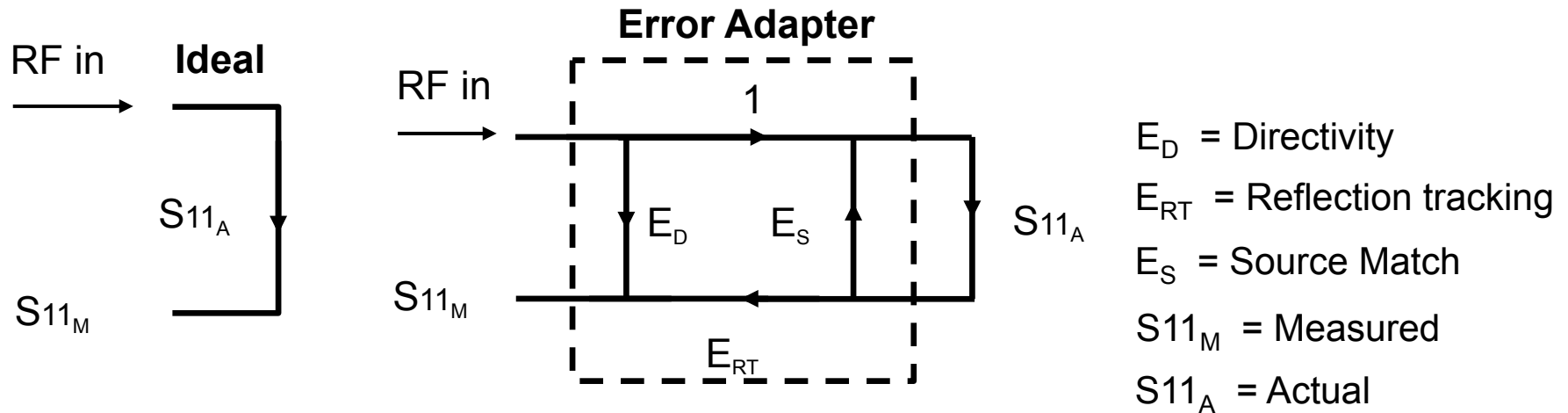


What is Vector-Error Correction?

- Process of characterizing systematic error terms
 - measure **known standards**
 - remove effects from subsequent measurements
- **1-port calibration** (*reflection measurements*)
 - only 3 systematic error terms measured
 - directivity, source match, and reflection tracking
- **Full 2-port calibration** (*reflection and transmission measurements*)
 - 12 systematic error terms measured
 - usually requires 12 measurements on four known standards (SOLT)
- Standards defined in **cal kit definition** file
 - network analyzer contains standard cal kit definitions
 - **CAL KIT DEFINITION MUST MATCH ACTUAL CAL KIT USED!**
 - User-built standards must be characterized and entered into user cal-kit



Reflection: One-Port Model

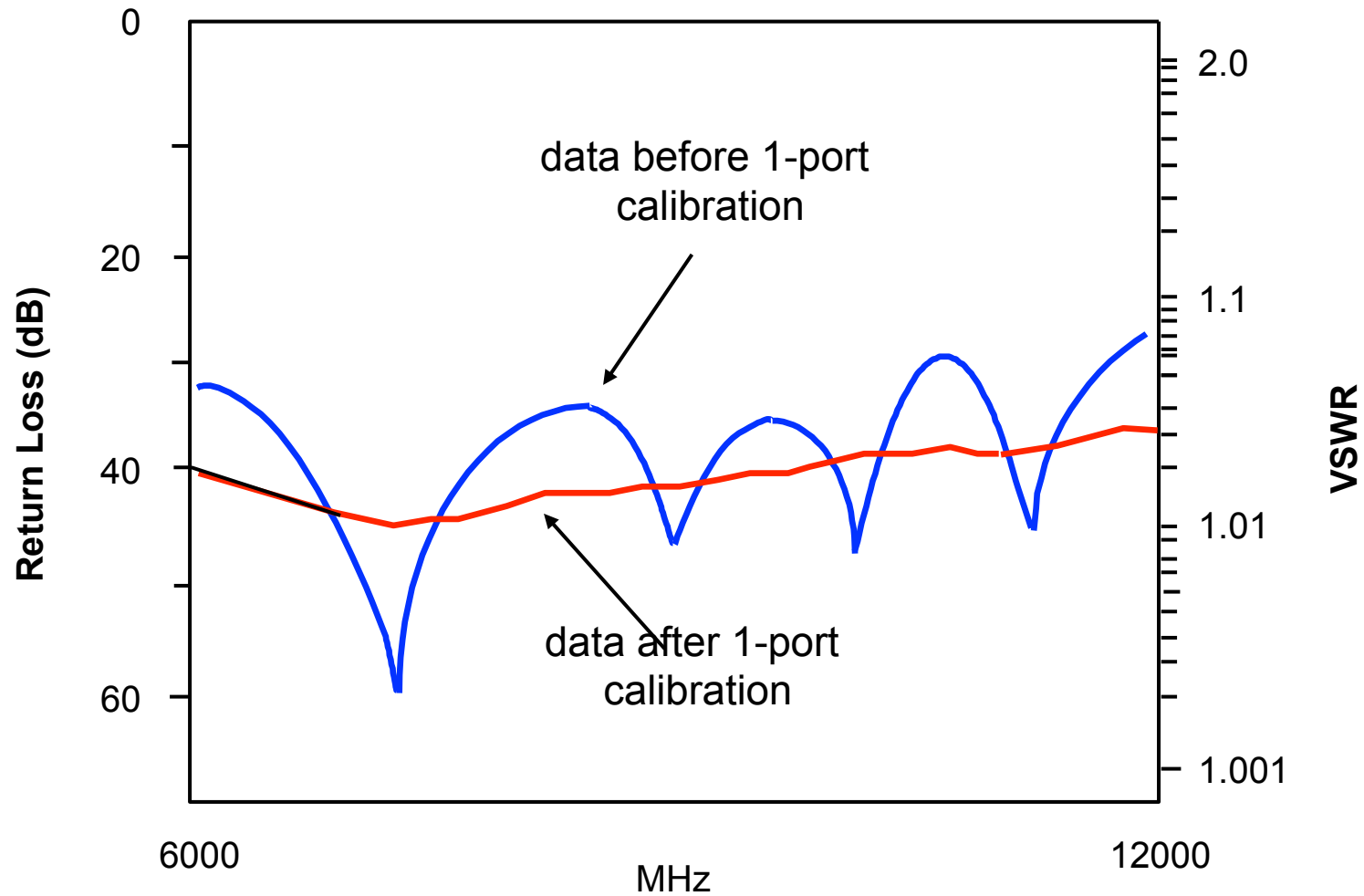


**To solve for error terms,
we measure 3 standards to
generate 3 equations and
3 unknowns**

$$S_{11_M} = E_D + \frac{E_{RT} S_{11_A}}{1 - E_S S_{11_A}}$$

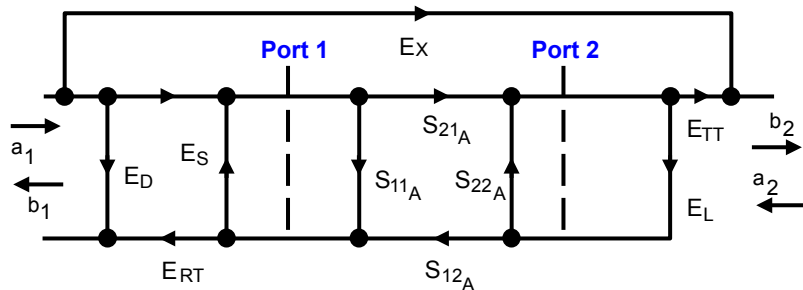
- Assumes good termination at port two if testing two-port devices
- If using port 2 of NA *and* DUT reverse isolation is low (e.g., filter passband):
 - assumption of good termination is not valid
 - two-port error correction yields better results

Before and After One-Port Calibration

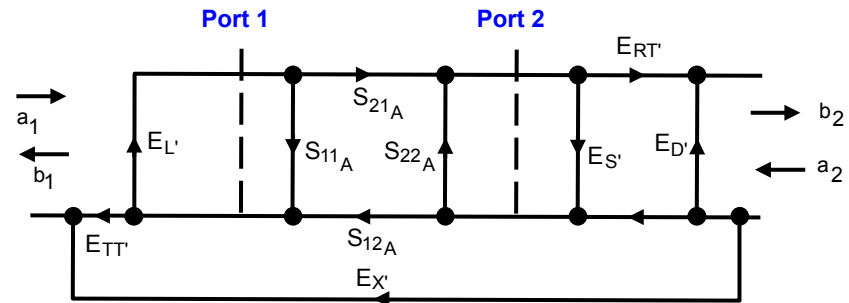


Two-Port Error Correction

Forward model



Reverse model



- | | |
|-------------------------------------|---------------------------------------|
| E_D = fwd directivity | E_L = fwd load match |
| E_S = fwd source match | E_{TT} = fwd transmission tracking |
| E_{RT} = fwd reflection tracking | E_X = fwd isolation |
| $E_{D'}$ = rev directivity | $E_{L'}$ = rev load match |
| $E_{S'}$ = rev source match | $E_{TT'}$ = rev transmission tracking |
| $E_{RT'}$ = rev reflection tracking | $E_{X'}$ = rev isolation |

- Each actual S-parameter is a function of all four measured S-parameters
- Analyzer must make forward *and* reverse sweep to update any one S-parameter
- Luckily, you don't need to know these equations to **use** network analyzers!!!

$$S_{11a} = \frac{\left(\frac{S_{11m} - E_D}{E_{RT}}\right)\left(1 + \frac{S_{22m} - E_{D'}}{E_{RT'}} E_{S'}\right) - E_L \left(\frac{S_{21m} - E_X}{E_{TT}}\right) \left(\frac{S_{12m} - E_{X'}}{E_{TT'}}\right)}{\left(1 + \frac{S_{11m} - E_{D'}}{E_{RT}} E_S\right)\left(1 + \frac{S_{22m} - E_{D'}}{E_{RT'}} E_{S'}\right) - E_{L'} E_L \left(\frac{S_{21m} - E_X}{E_{TT}}\right) \left(\frac{S_{12m} - E_{X'}}{E_{TT'}}\right)}$$

$$S_{21a} = \frac{\left(\frac{S_{21m} - E_X}{E_{TT}}\right)\left(1 + \frac{S_{22m} - E_{D'}}{E_{RT'}} (E_{S'} - E_L)\right)}{\left(1 + \frac{S_{11m} - E_D}{E_{RT}} E_S\right)\left(1 + \frac{S_{22m} - E_{D'}}{E_{RT'}} E_{S'}\right) - E_{L'} E_L \left(\frac{S_{21m} - E_X}{E_{TT}}\right) \left(\frac{S_{12m} - E_{X'}}{E_{TT'}}\right)}$$

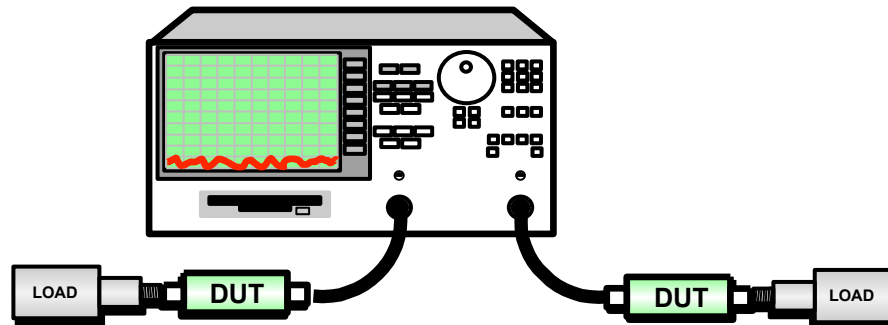
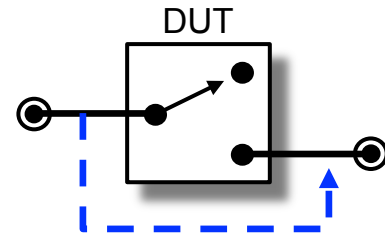
$$S_{12a} = \frac{\left(\frac{S_{12m} - E_{X'}}{E_{TT'}}\right)\left(1 + \frac{S_{11m} - E_D}{E_{RT}} (E_S - E_{L'})\right)}{\left(1 + \frac{S_{11m} - E_D}{E_{RT}} E_S\right)\left(1 + \frac{S_{22m} - E_{D'}}{E_{RT'}} E_{S'}\right) - E_{L'} E_L \left(\frac{S_{21m} - E_X}{E_{TT}}\right) \left(\frac{S_{12m} - E_{X'}}{E_{TT'}}\right)}$$

$$S_{22a} = \frac{\left(\frac{S_{22m} - E_{D'}}{E_{RT'}}\right)\left(1 + \frac{S_{11m} - E_D}{E_{RT}} E_S\right) - E_{L'} \left(\frac{S_{21m} - E_X}{E_{TT}}\right) \left(\frac{S_{12m} - E_{X'}}{E_{TT'}}\right)}{\left(1 + \frac{S_{11m} - E_D}{E_{RT}} E_S\right)\left(1 + \frac{S_{22m} - E_{D'}}{E_{RT'}} E_{S'}\right) - E_{L'} E_L \left(\frac{S_{21m} - E_X}{E_{TT}}\right) \left(\frac{S_{12m} - E_{X'}}{E_{TT'}}\right)}$$



Crosstalk: Signal Leakage Between Test Ports During Transmission

- Can be a problem with:
 - high-isolation devices (e.g., switch in open position)
 - high-dynamic range devices (some filter stopbands)
- Isolation calibration
 - adds noise to error model (measuring near noise floor of system)
 - only perform if really needed (use averaging if necessary)
 - if crosstalk is **independent** of DUT match, use two terminations
 - if **dependent** on DUT match, use DUT with termination on output



Errors and Calibration Standards

UNCORRECTED FULL 2-PORT

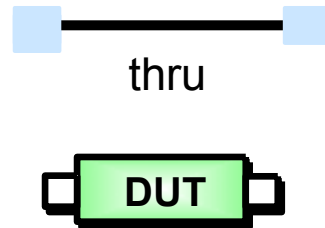


- Convenient
- Generally not accurate
- No errors removed

ENHANCED-RESPONSE

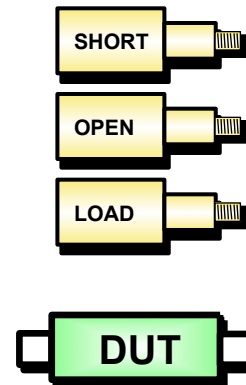
- Combines response and 1-port
- Corrects source match for transmission measurements

RESPONSE

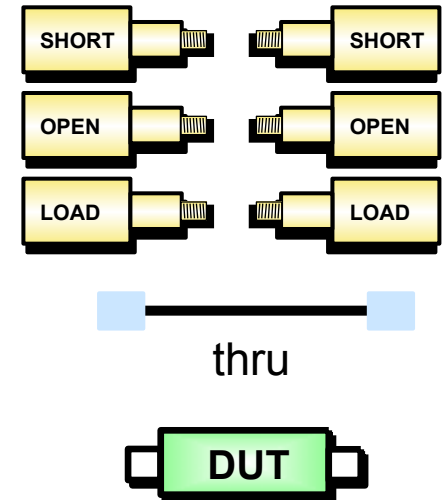


- Easy to perform
- Use when highest accuracy is not required
- Removes frequency response error

1-PORT



- For reflection measurements
- Need good termination for high accuracy with two-port devices
- Removes these errors:
 - Directivity
 - Source match
 - Reflection tracking

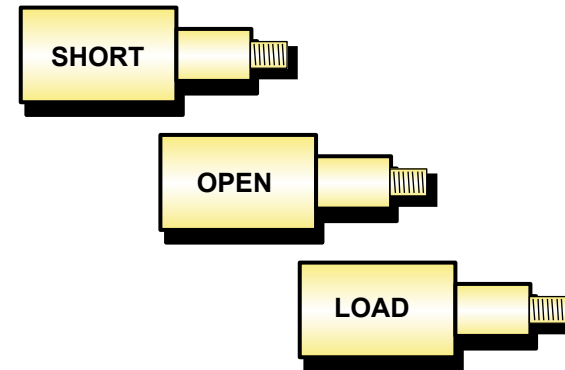





- Highest accuracy
- Removes these errors:
 - Directivity
 - Source, load match
 - Reflection tracking
 - Transmission tracking
 - Crosstalk



Calibration Summary

Reflection	Test Set (cal type)	
	T/R (one-port)	S-parameter (two-port)
• Reflection tracking	✓	✓
• Directivity	✓	✓
• Source match	✓	
• Load match	✗	

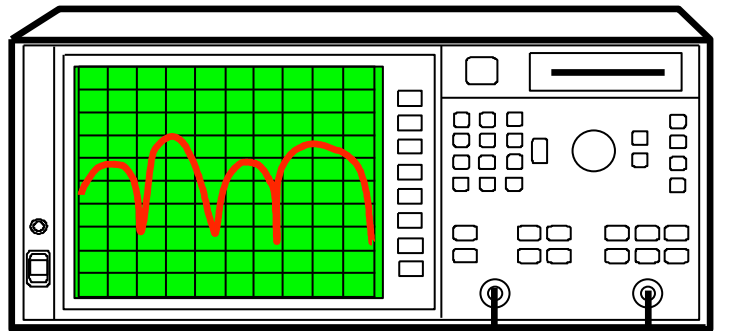


 **error can be corrected**
 **error cannot be corrected**
 * *enhanced response cal* corrects for source match during transmission measurements

Transmission	Test Set (cal type)	
	T/R (response, isolation)	S-parameter (two-port)
• Transmission Tracking	✓	✓
• Crosstalk	✓	✓
• Source match	(✓*)	✓
• Load match	✗	✓



Reflection Example Using a One-Port Cal



Directivity:
40 dB (.010)

.158

$$(.891)(.126)(.891) = .100$$

Load match:
18 dB (.126)

DUT

16 dB RL (.158)
1 dB loss (.891)

Remember: convert all dB values to linear for uncertainty calculations!

$$\rho \text{ or loss}_{(\text{linear})} = 10^{\left(\frac{-\text{dB}}{20}\right)}$$

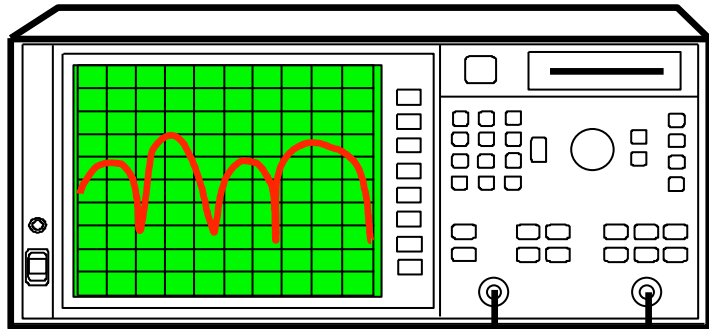
Measurement uncertainty:

$$-20 * \log (.158 + .100 + .010) = 11.4 \text{ dB } (-4.6\text{dB})$$

$$-20 * \log (.158 - .100 - .010) = 26.4 \text{ dB } (+10.4 \text{ dB})$$



Using a One-Port Cal + Attenuator



Load match:
18 dB (.126)

Measurement uncertainty:
 $-20 * \log (.158 + .039)$
 = 14.1 dB (-1.9 dB)
 $-20 * \log (.158 - .039)$
 = 18.5 dB (+2.5 dB)

Directivity:
40 dB (.010)

10 dB attenuator (.316)
SWR = 1.05 (.024)

DUT

16 dB RL (.158)
1 dB loss (.891)

.158

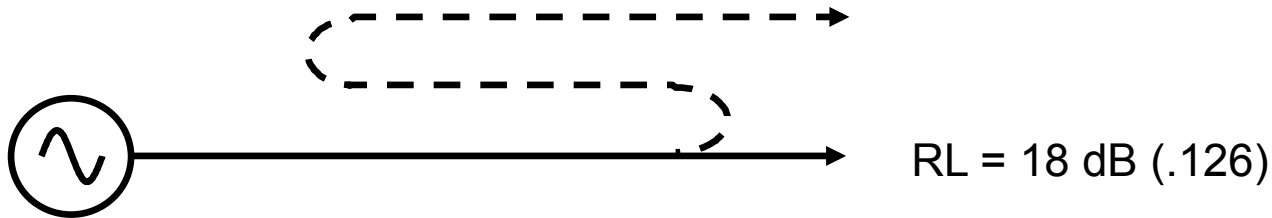
$$(.891)(.316)(.126)(.316)(.891) = .010$$

$$(.891)(.024)(.891) = .019$$

Low-loss bi-directional devices generally require two-port calibration for low measurement uncertainty

Worst-case error = .010 + .010 + .019 = .039

Transmission Example Using Response Cal



RL = 14 dB (.200)

Thru calibration (normalization) builds error into measurement due to source and load match interaction

Calibration

Uncertainty

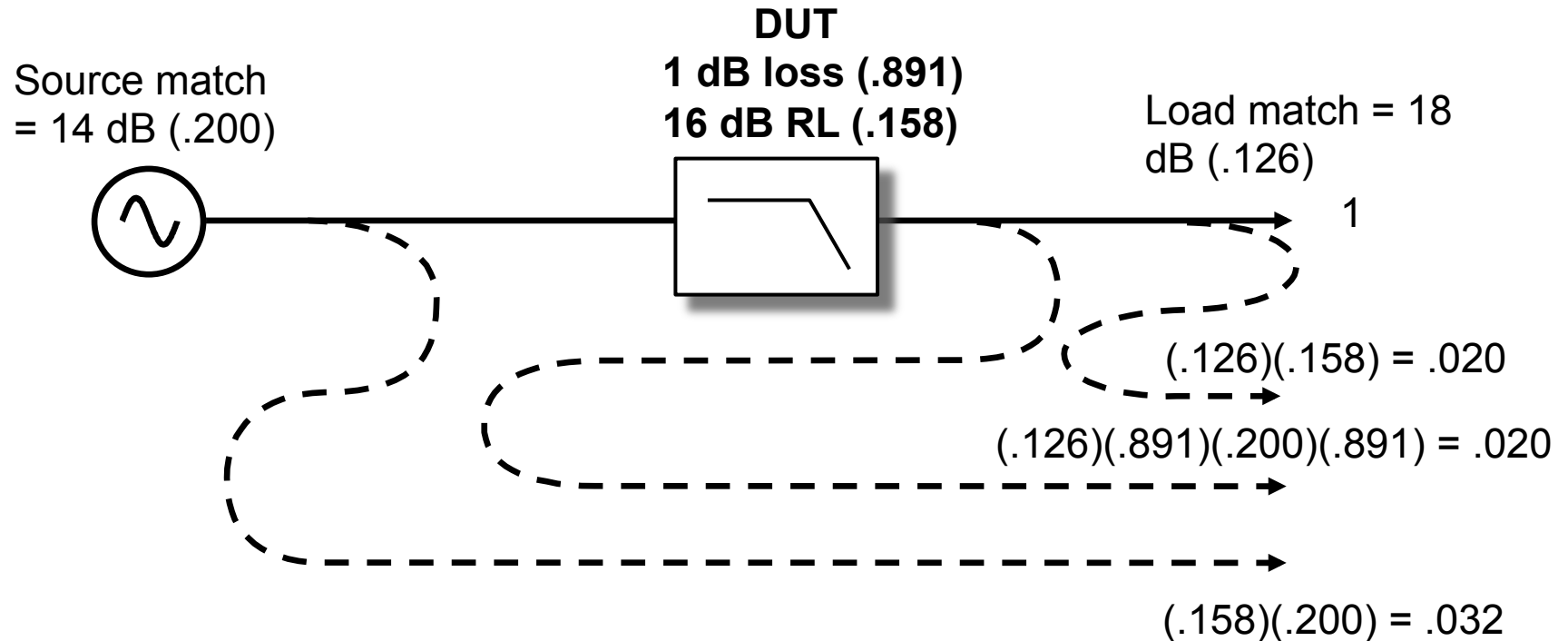
$$= (1 \pm \rho_S \rho_L)$$

$$= (1 \pm (.200)(.126))$$

$$= \pm 0.22 \text{ dB}$$



Filter Measurement with Response Cal



Total measurement uncertainty:

$$+0.60 + 0.22 = + 0.82 \text{ dB}$$

$$-0.65 - 0.22 = - 0.87 \text{ dB}$$

Measurement uncertainty

$$= 1 \pm (.020 + .020 + .032)$$

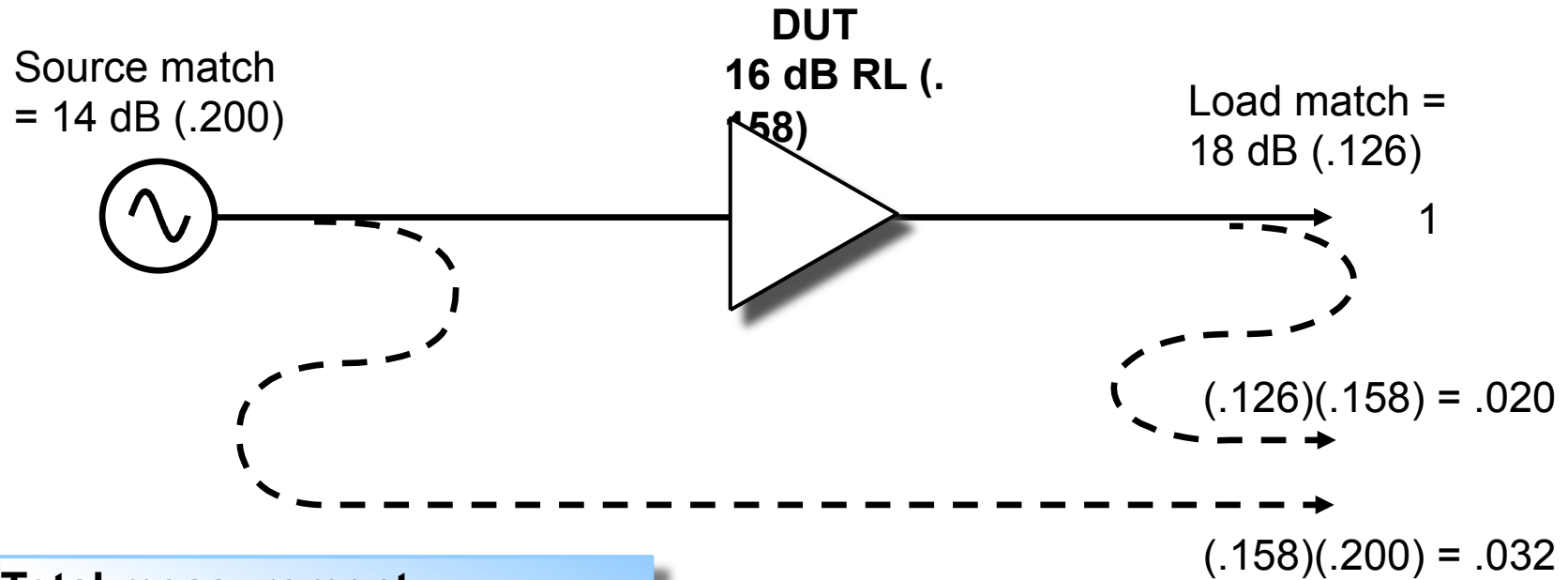
$$= 1 \pm .072$$

$$= + 0.60 \text{ dB}$$

$$- 0.65 \text{ dB}$$



Measuring Amplifiers with a Response Cal



Total measurement uncertainty:
 $+0.44 + 0.22 = + 0.66 \text{ dB}$
 $-0.46 - 0.22 = - 0.68 \text{ dB}$

Measurement uncertainty
 $= 1 \pm (.020+.032)$
 $= 1 \pm .052$
 $= + 0.44 \text{ dB}$
 $- 0.46 \text{ dB}$

Filter Measurements using the *Enhanced Response* Calibration

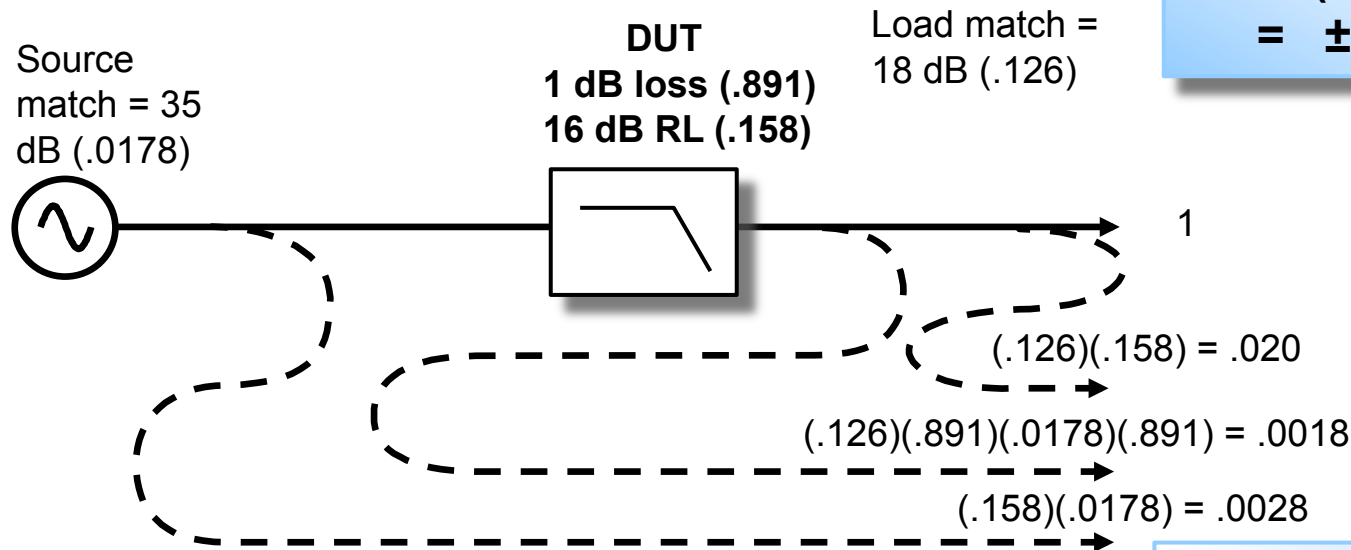
Effective source match = 35 dB!

Calibration Uncertainty

$$= (1 \pm \rho_S \rho_L)$$

$$= (1 \pm (.0178)(.126))$$

$$= \pm .02 \text{ dB}$$



Measurement uncertainty

$$= 1 \pm (.020 + .0018 + .0028)$$

$$= 1 \pm .0246$$

$$= + 0.211 \text{ dB}$$

$$- 0.216 \text{ dB}$$

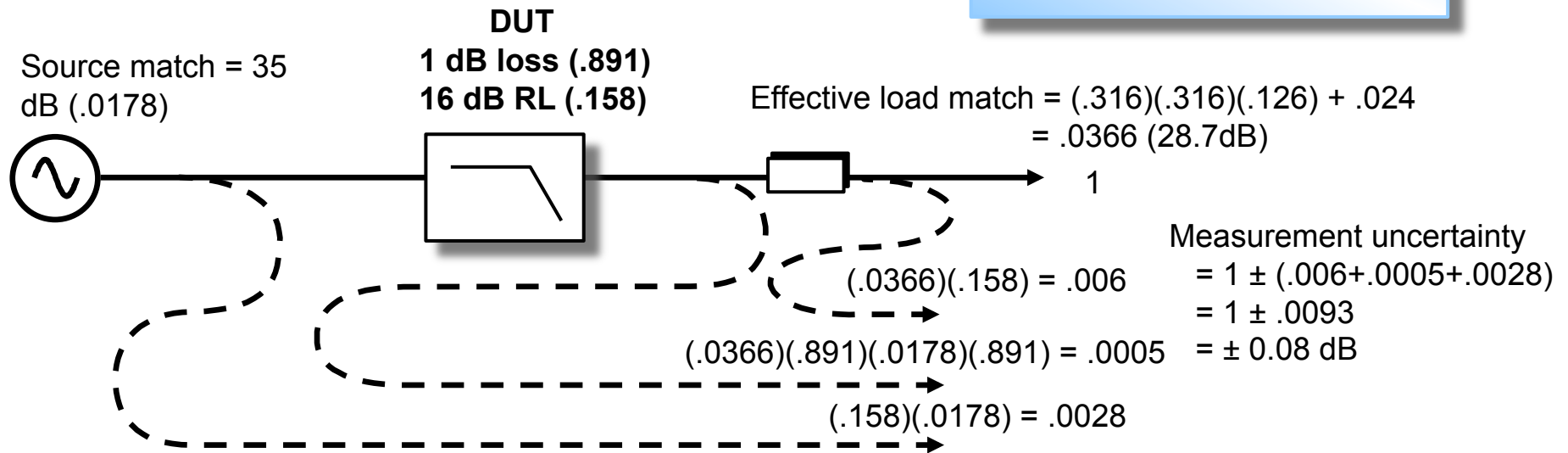
Total measurement uncertainty:

$$0.22 + .02 = \pm 0.24 \text{ dB}$$

Using the *Enhanced Response* Calibration Plus an Attenuator

10 dB attenuator (.316)
 SWR = 1.05 (.024 linear or 32.4 dB)
 Analyzer load match = 18 dB (.126)

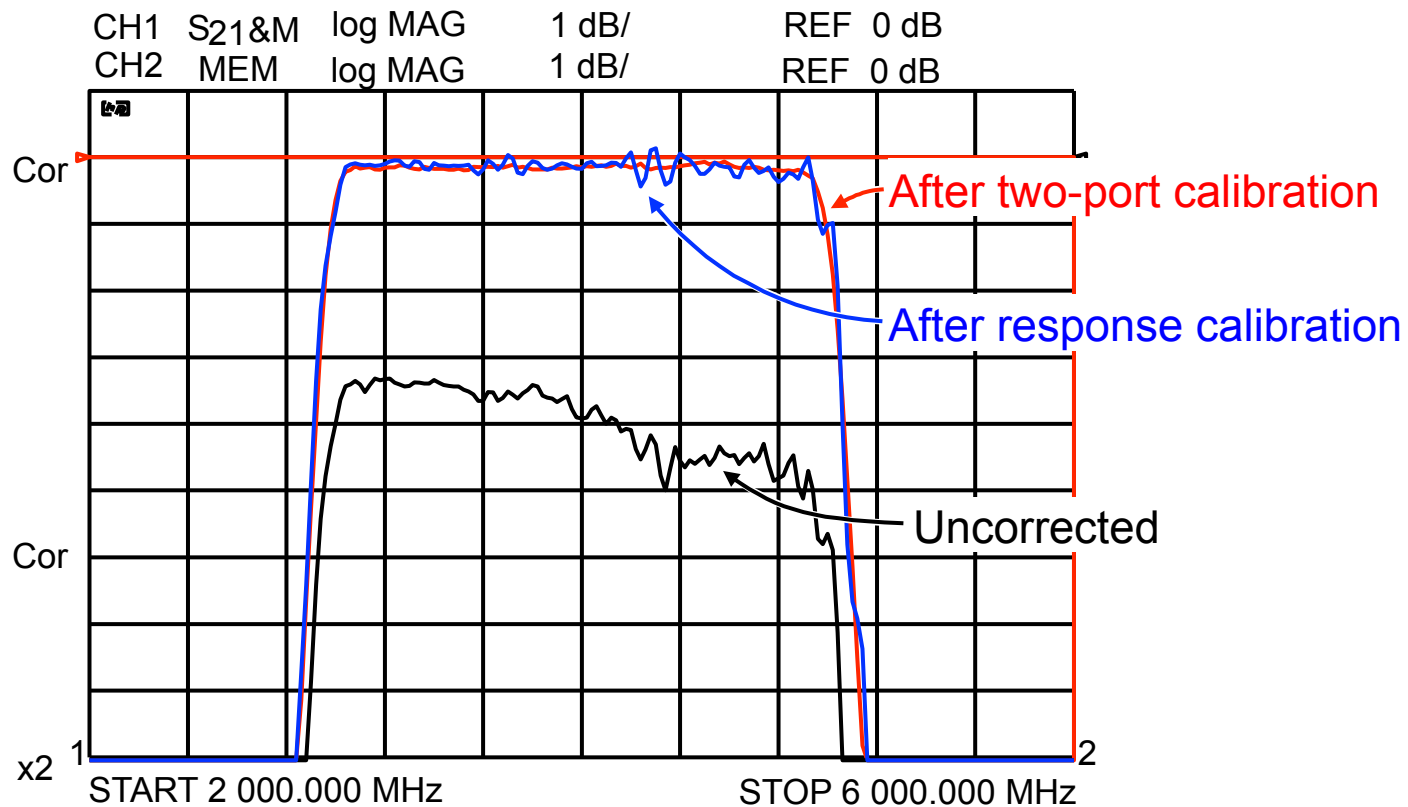
Calibration Uncertainty
 $= (1 \pm \rho_S \rho_L)$
 $= (1 \pm (.0178)(.0366))$
 $= \pm .01 \text{ dB}$



Total measurement uncertainty:
 $0.01 + .08 = \pm 0.09 \text{ dB}$

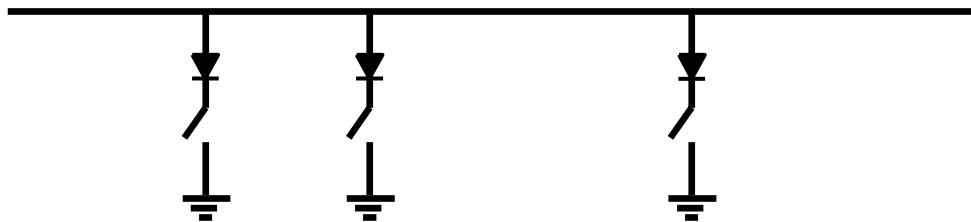
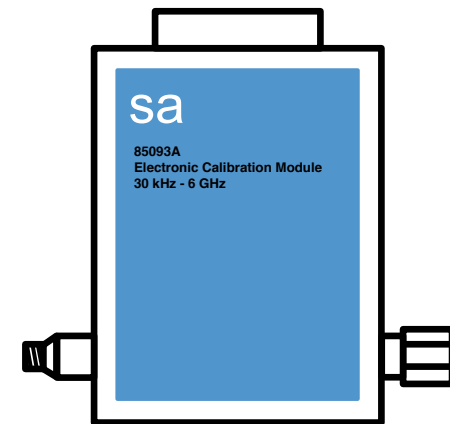
Response versus Two-Port Calibration

Measuring filter insertion loss



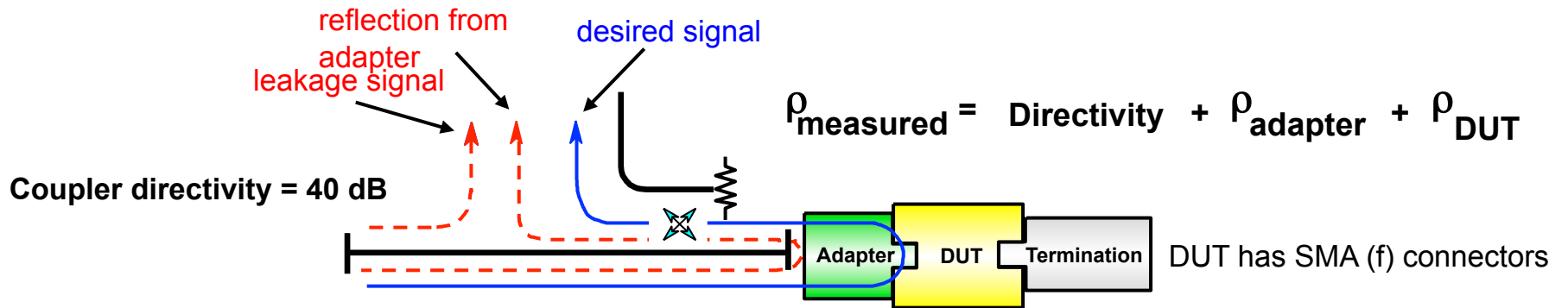
ECal: Electronic Calibration (85060/90 series)

- Variety of modules cover 30 kHz to 26.5 GHz
- Six connector types available (50 Ω and 75 Ω)
- Single-connection
 - reduces calibration time
 - makes calibrations easy to perform
 - minimizes wear on cables and standards
 - eliminates operator errors
- Highly repeatable temperature-compensated terminations provide excellent accuracy



Microwave modules use a transmission line shunted by PIN-diode switches in various combinations

Adapter Considerations



APC-7 calibration done here

Worst-case System Directivity

Adapting from APC-7 to SMA (m)

28 dB		APC-7 to SMA (m) SWR:1.06
17 dB		APC-7 to N (f) + N (m) to SMA (m) SWR:1.05 SWR:1.25
14 dB		APC-7 to N (m) + N (f) to SMA (f) + SMA (m) to (m) SWR:1.05 SWR:1.25 SWR:1.15



Calibrating Non-Insertable Devices

When doing a through cal, normally test ports mate directly

- cables can be connected directly without an adapter
- result is a zero-length through

What is an insertable device?

- has same type of connector, but different sex on each port
- has same type of sexless connector on each port (e.g. APC-7)



What is a non-insertable device?

- one that cannot be inserted in place of a zero-length through
- has same connectors on each port (type and sex)
- has different type of connector on each port (e.g., waveguide on one port, coaxial on the other)

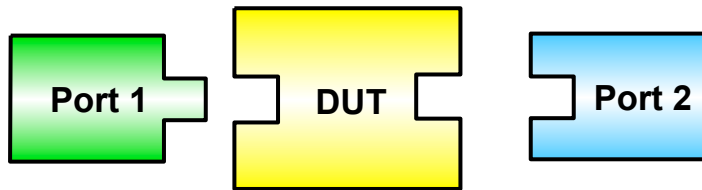


What calibration choices do I have for non-insertable devices?

- use an *uncharacterized* through adapter
- use a *characterized* through adapter (modify cal-kit definition)
- swap equal adapters
- adapter removal



Swap Equal Adapters Method



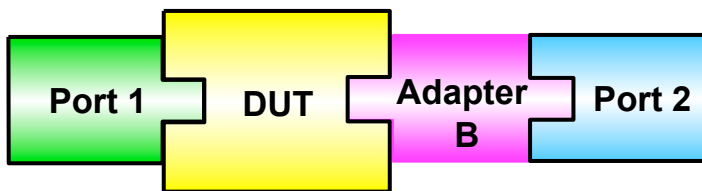
Accuracy depends on how well the adapters are matched - loss, electrical length, match and impedance should all be equal



1. Transmission cal using adapter A.



2. Reflection cal using adapter B.

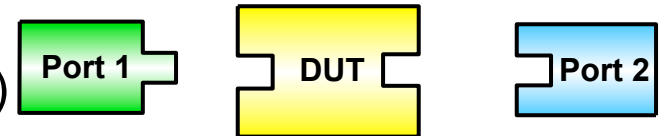


3. Measure DUT using adapter B.

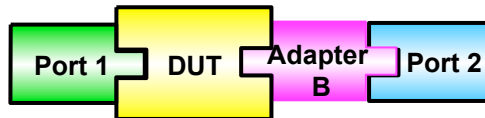


Adapter Removal Calibration

- Calibration is very accurate and traceable
- In firmware of 8753, 8720 and 8510 series
- Also accomplished with ECal modules (85060/90)
- Uses adapter with same connectors as DUT
- Must specify electrical length of adapter to within 1/4 wavelength of highest frequency (to avoid phase ambiguity)



[CAL] [MORE] [MODIFY CAL SET]
[ADAPTER REMOVAL]



1. Perform 2-port cal with adapter on port 2. Save in cal set 1.
2. Perform 2-port cal with adapter on port 1. Save in cal set 2.
3. Use ADAPTER REMOVAL to generate new cal set.
4. Measure DUT without cal adapter.



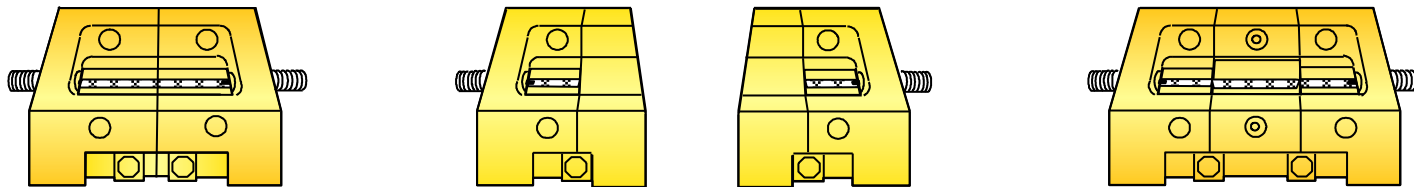
Thru-Reflect-Line (TRL) Calibration

We know about Short-Open-Load-Thru (SOLT) calibration...

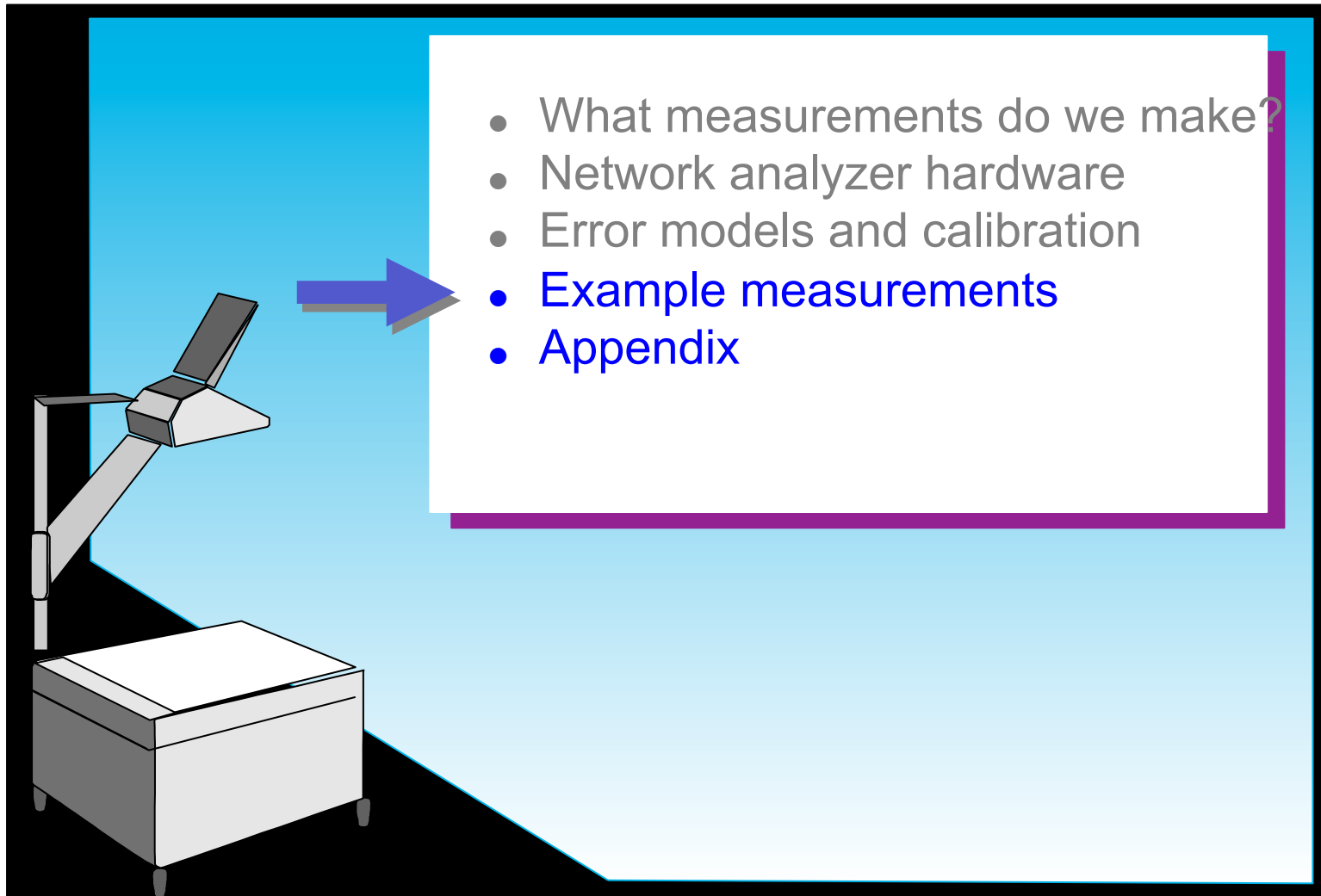
What is TRL?

- A two-port calibration technique
- Good for noncoaxial environments (waveguide, fixtures, wafer probing)
- Uses the same 12-term error model as the more common SOLT cal
- Uses practical calibration standards that are easily fabricated and characterized
- Two variations: TRL (requires 4 receivers) and TRL* (only three receivers needed)
- Other variations: Line-Reflect-Match (LRM), Thru-Reflect-Match (TRM), plus many others

*TRL was developed for
non-coaxial microwave
measurements*



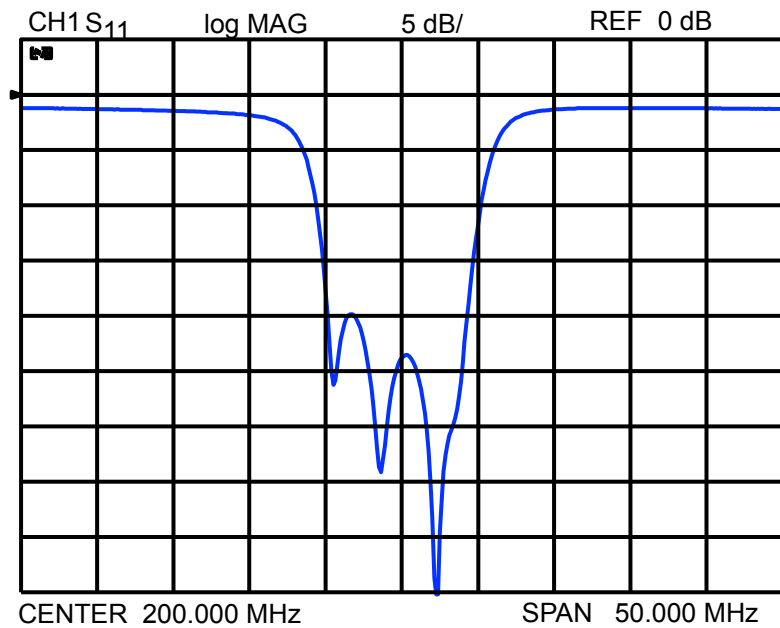
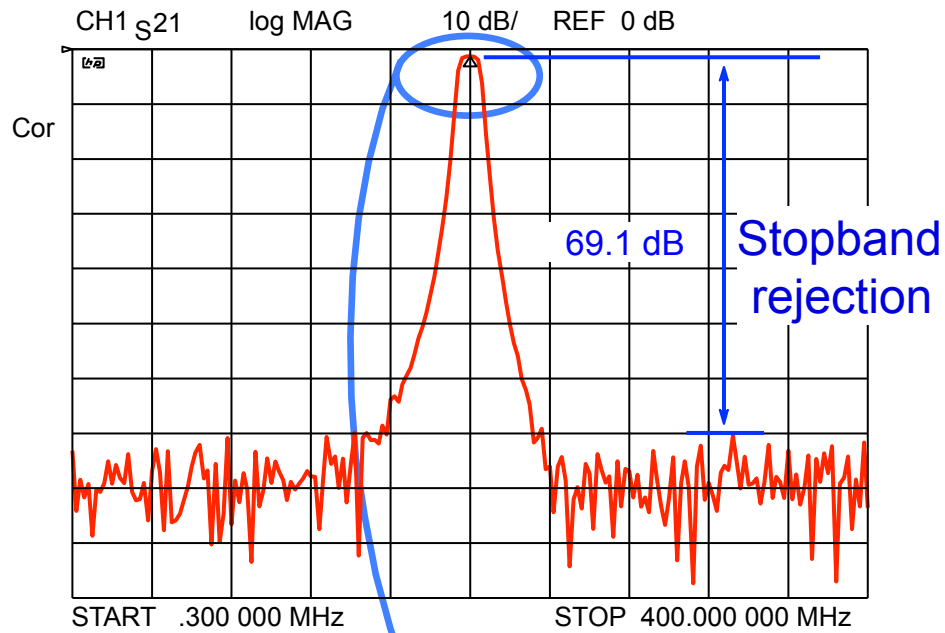
Agenda



- What measurements do we make?
- Network analyzer hardware
- Error models and calibration
- **Example measurements**
- **Appendix**

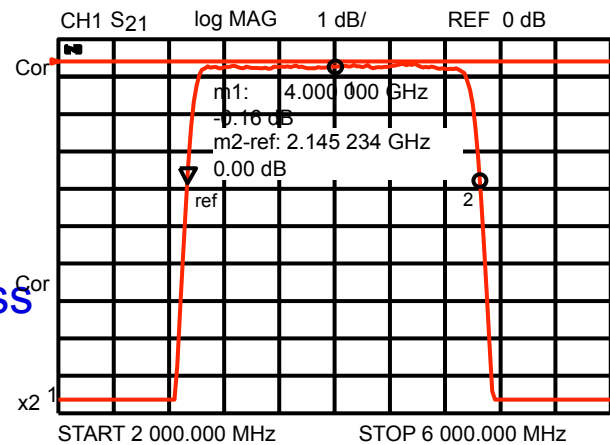


Frequency Sweep - Filter Test

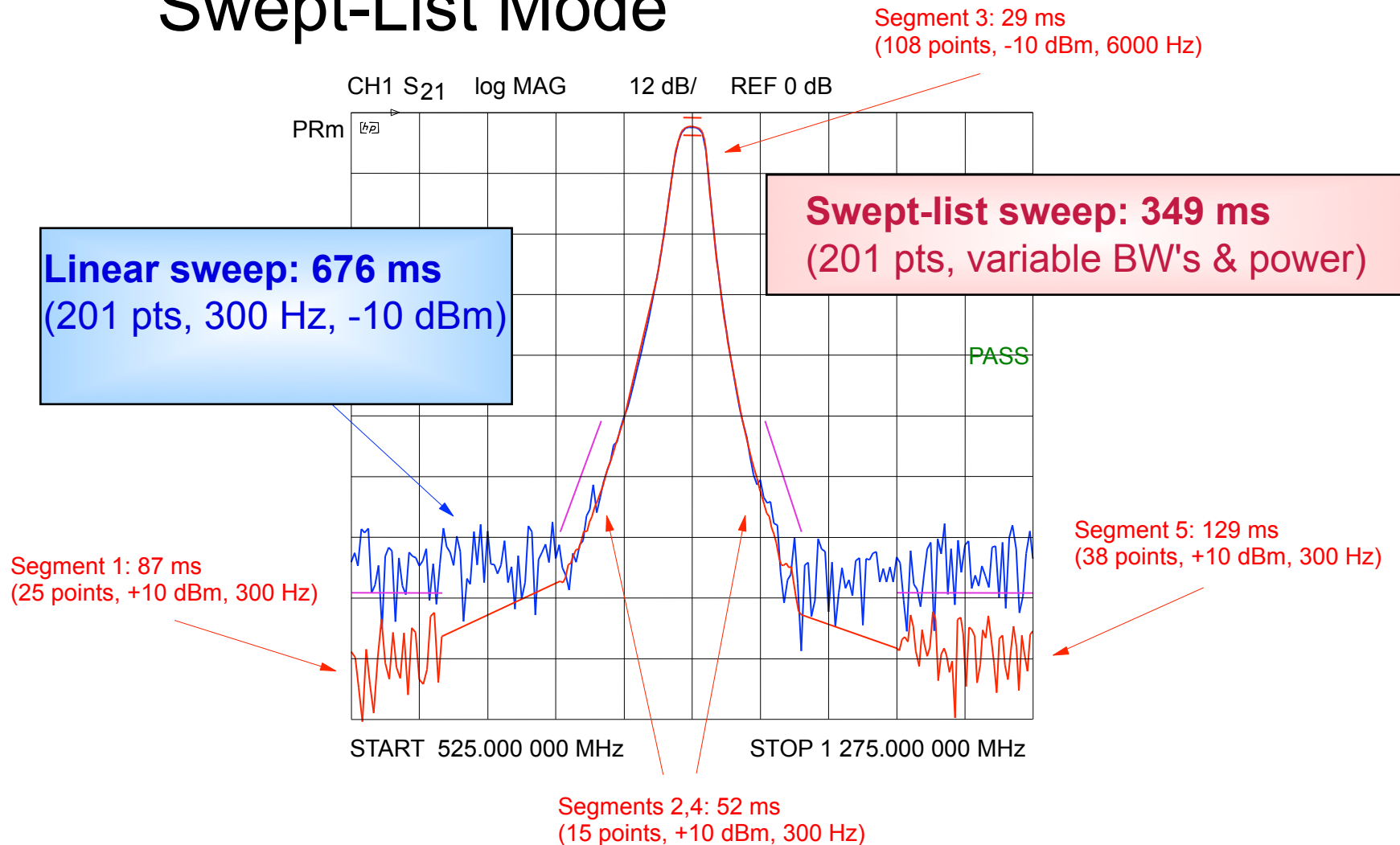


Return loss

Insertion loss



Optimize Filter Measurements with Swept-List Mode



Transfer function Schottky Signals Narrow Band

File number = 5

Core 2-4 GHz Vert. NB H=2705

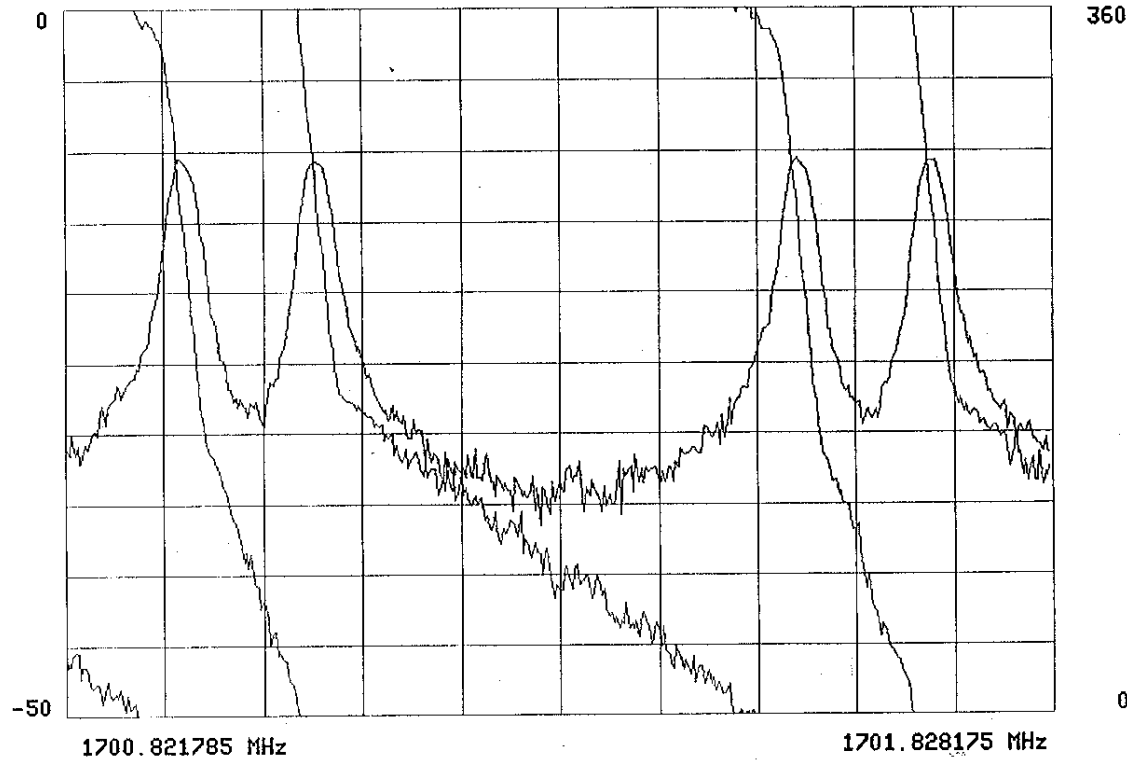
07/01/97 2149

Console Location 43,
Network Analyzer Measurement

27-OCT-1998 10:42

14:56

Current= 10.74 ma DT= 0 ps Atten 3
Amp (dB) Type=1 Amp Phase Phase (deg)



Transfer function Schottky Signals Wide Band

File number = 2
Core 2-4 GHz Vert. WB ATTEN = 3

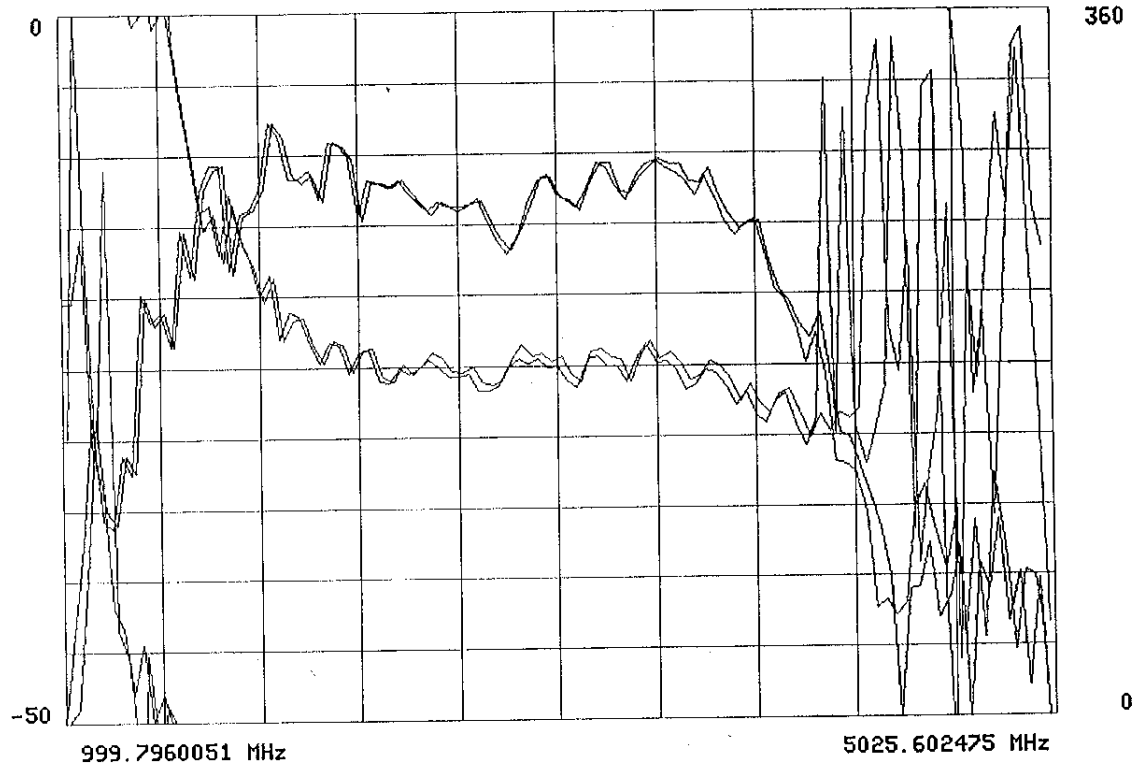
07/01/97 2117

Console Location 43,
Network Analyzer Measurement

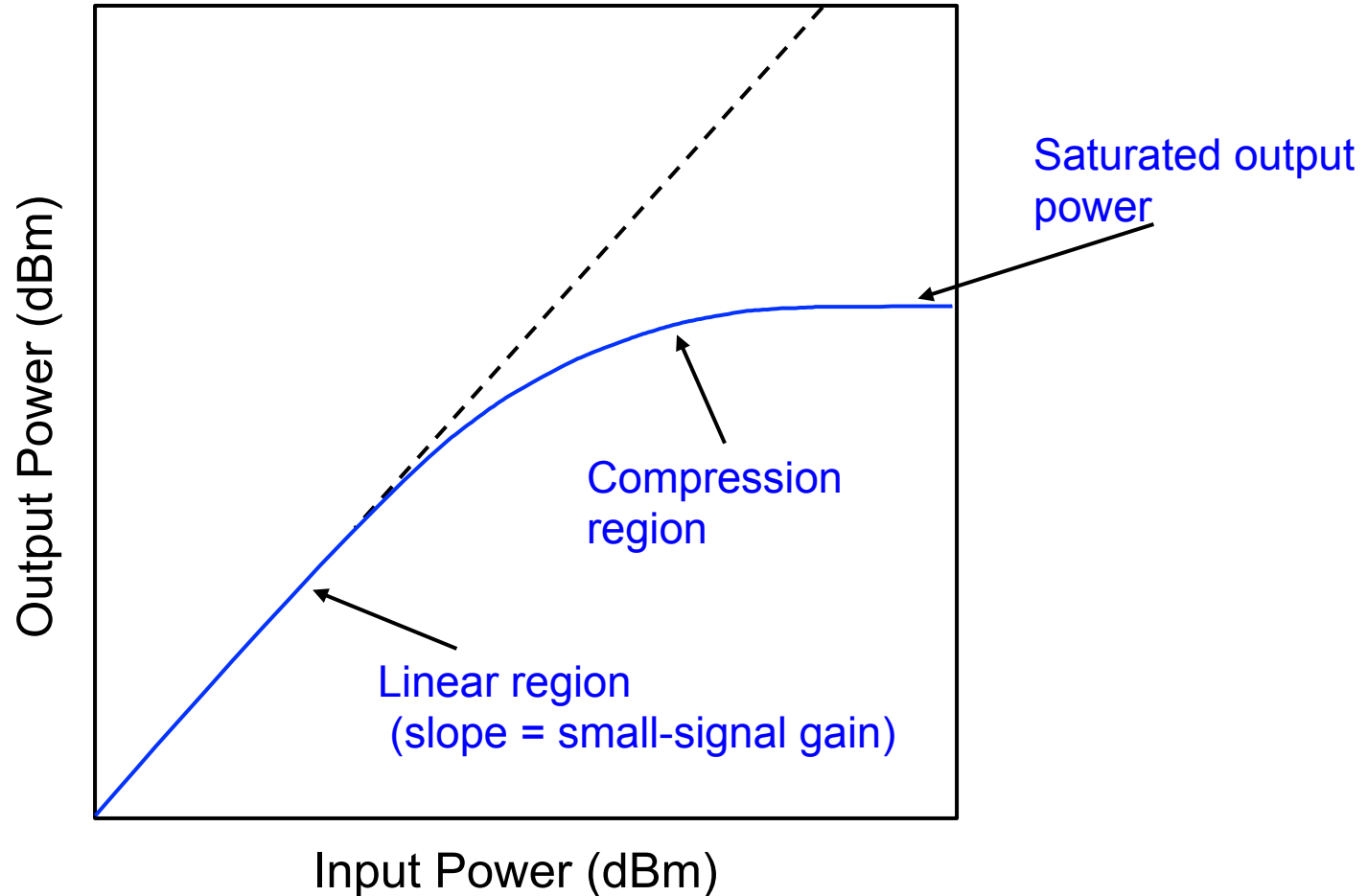
27-OCT-1998 10:42

14:47

Current= 10.75 ma DT= 0 ps Atten 3
Amp (dB) Type=5 Amp LSB Phase LSB Amp USB Phase USB Phase (deg)

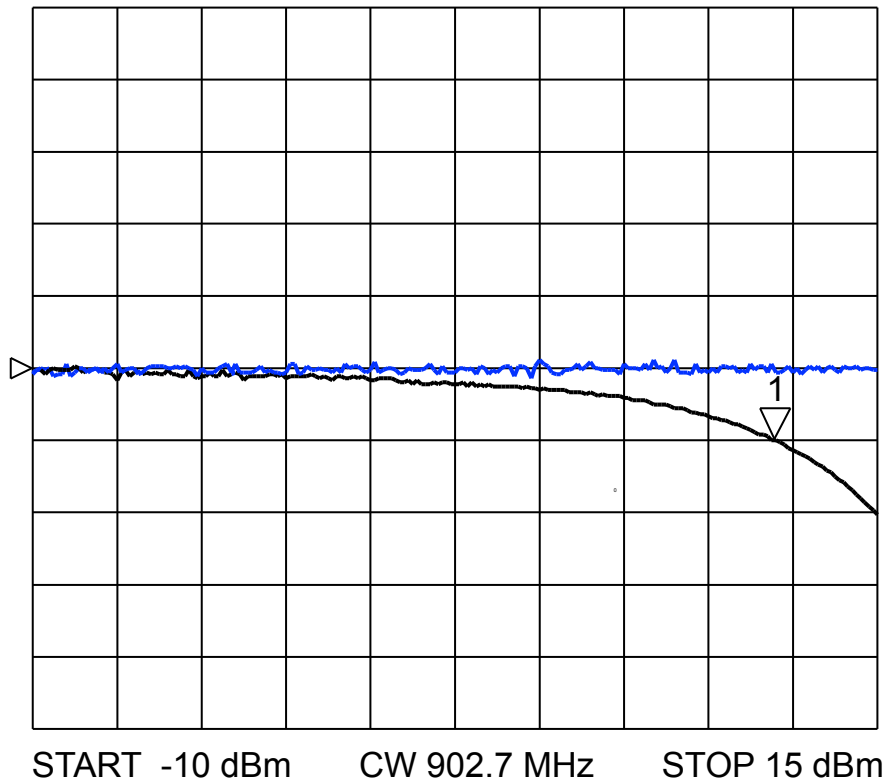


Power Sweeps - Compression



Power Sweep - Gain Compression

CH1 S21 1log MAG 1 dB/ REF 32 dB 30.991 dB
12.3 dBm

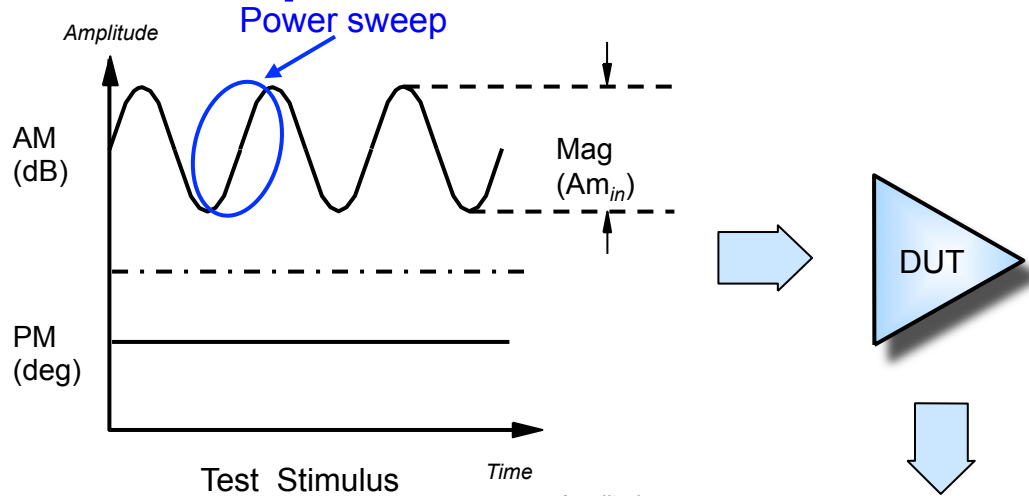


**1 dB
compression:**
input power
resulting in 1 dB
drop in gain



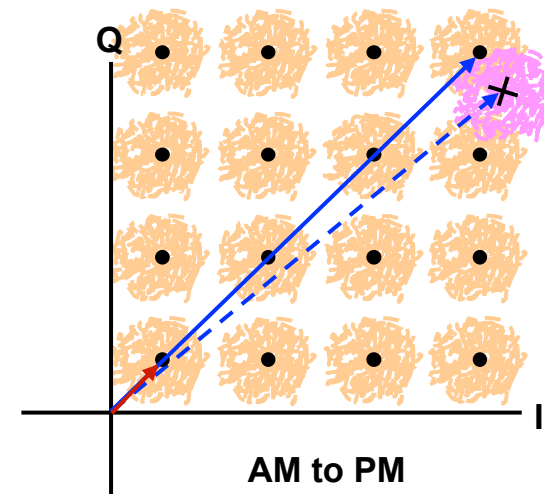
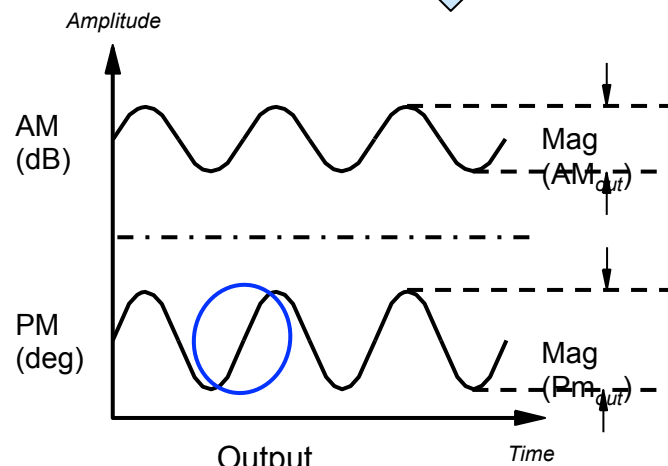
AM to PM Conversion

Measure of phase deviation caused by amplitude variations



- AM can be undesired: supply ripple, fading, thermal
- AM can be desired: modulation (e.g. QAM)

$$\text{AM - PM Conversion} = \frac{\text{Mag} (P_{m_{out}})}{\text{Mag} (A_{m_{in}})} \text{ (deg/dB)}$$

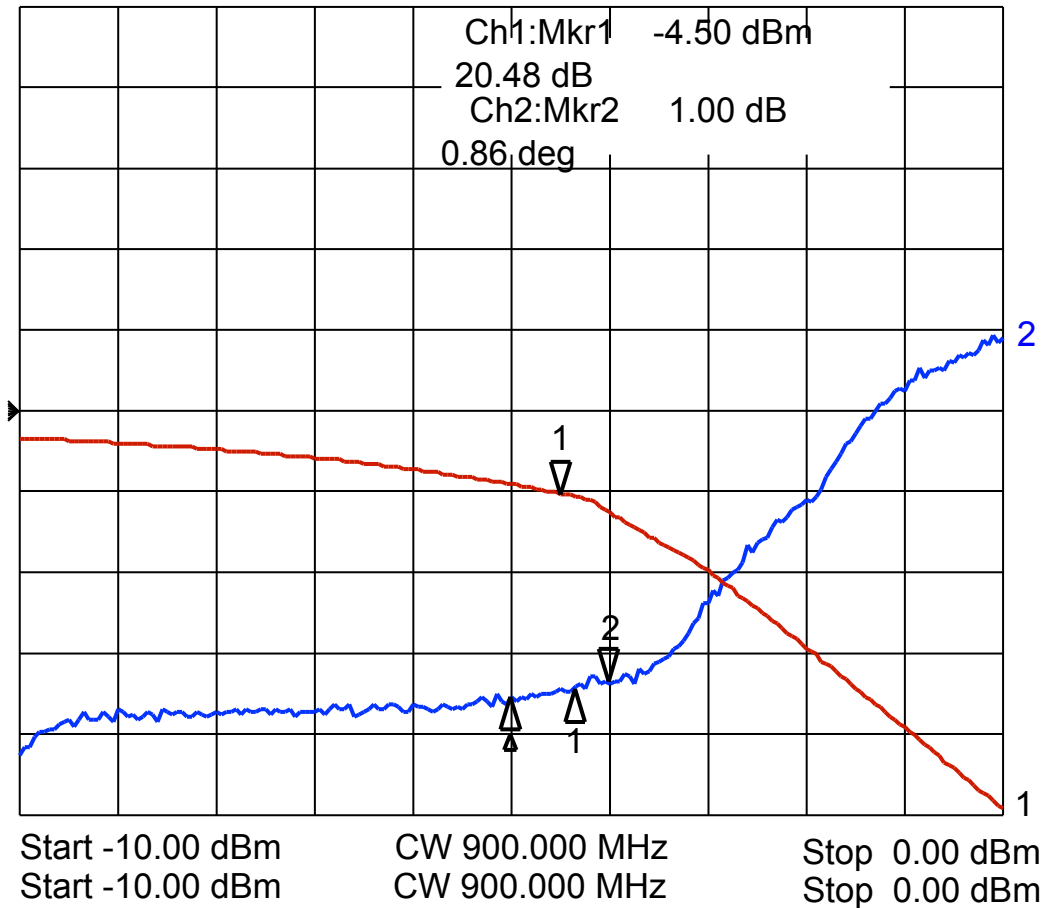


AM to PM conversion can cause bit errors

Copyright 2000

Measuring AM to PM Conversion

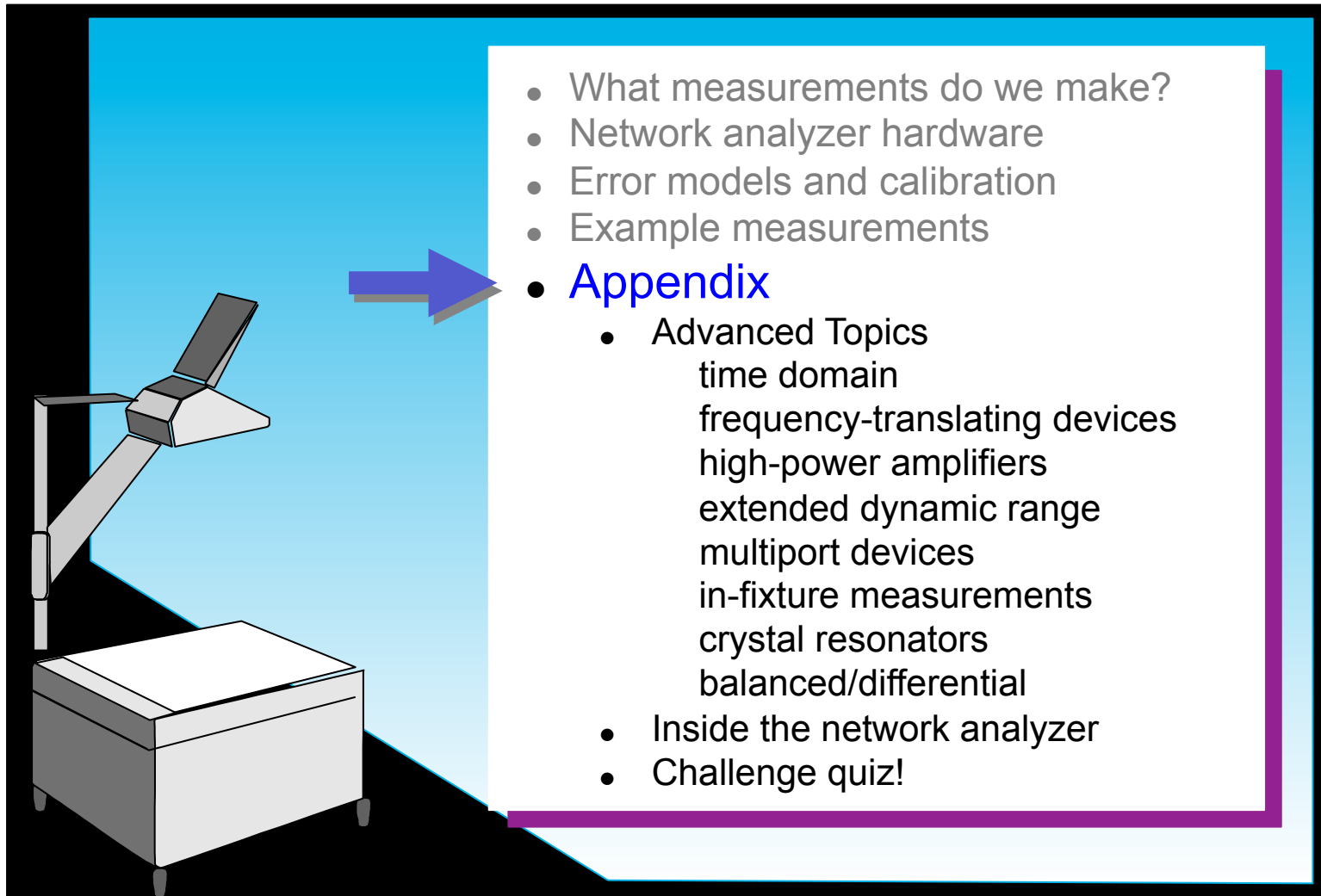
▷ 1:Transmission Log Mag 1.0 dB/ Ref 21.50 dB
▶ 2:Transmission /M Phase 5.0 deg/ Ref -115.7 deg



- Use transmission setup with a power sweep
- Display phase of S21
- AM - PM = 0.86 deg/dB



Agenda

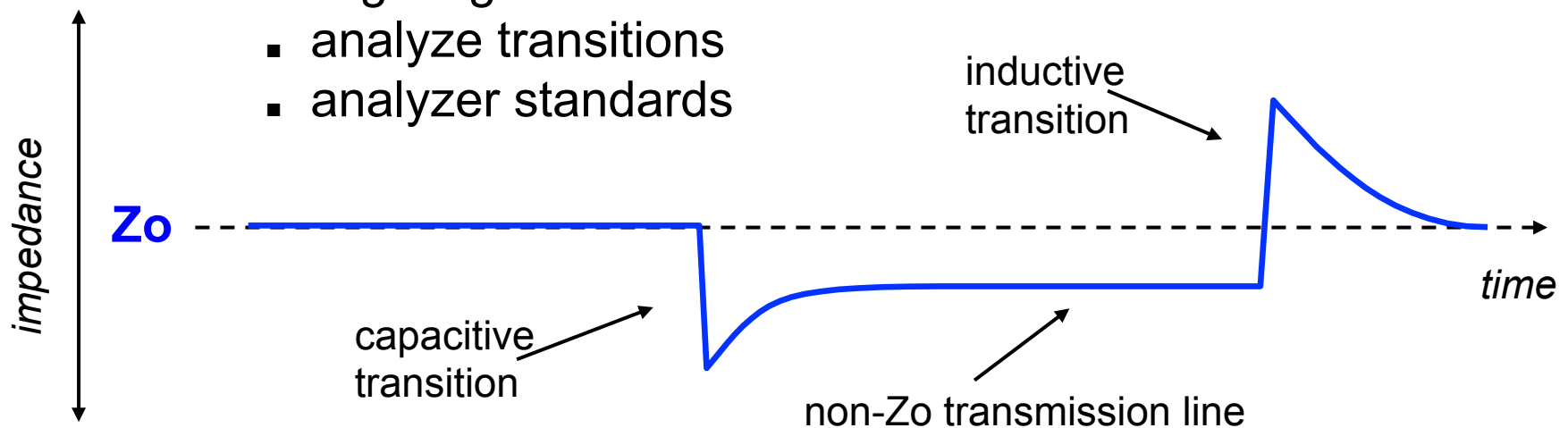


- What measurements do we make?
- Network analyzer hardware
- Error models and calibration
- Example measurements
- **Appendix**
 - Advanced Topics
 - time domain
 - frequency-translating devices
 - high-power amplifiers
 - extended dynamic range
 - multiport devices
 - in-fixture measurements
 - crystal resonators
 - balanced/differential
 - Inside the network analyzer
 - Challenge quiz!



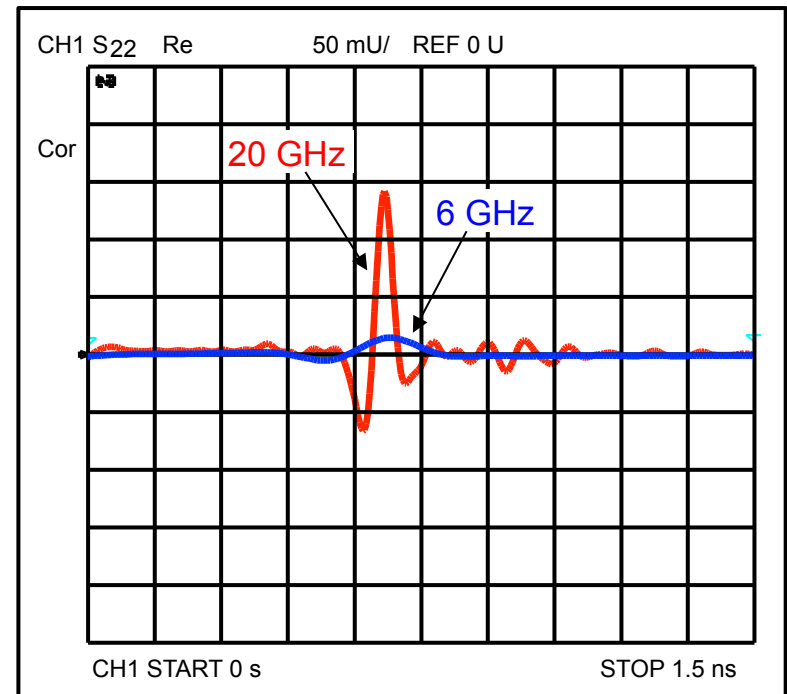
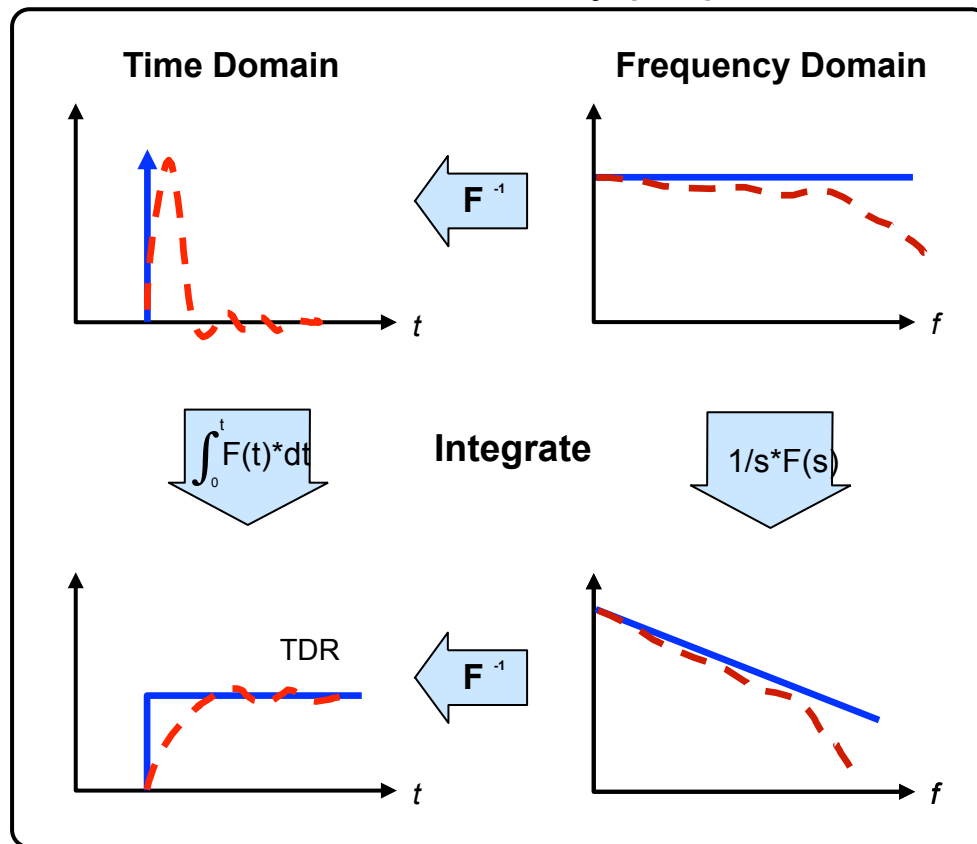
Time-Domain Reflectometry (TDR)

- What is TDR?
 - time-domain reflectometry
 - analyze impedance versus time
 - distinguish between inductive and capacitive transitions
- With gating:
 - analyze transitions
 - analyzer standards



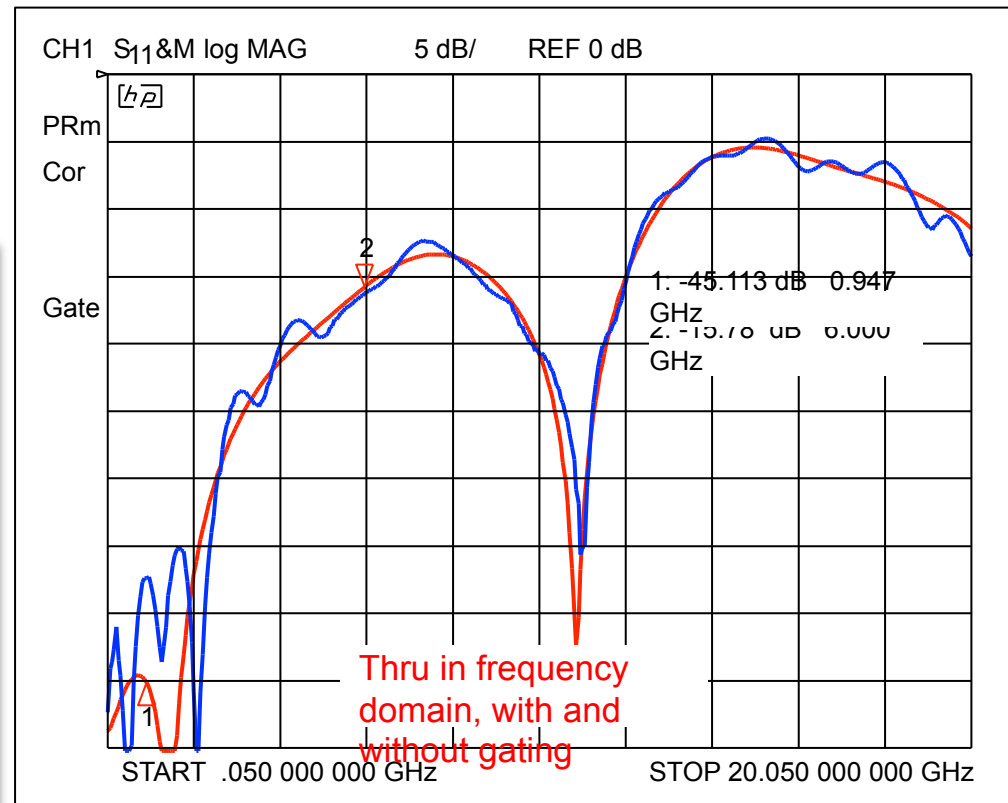
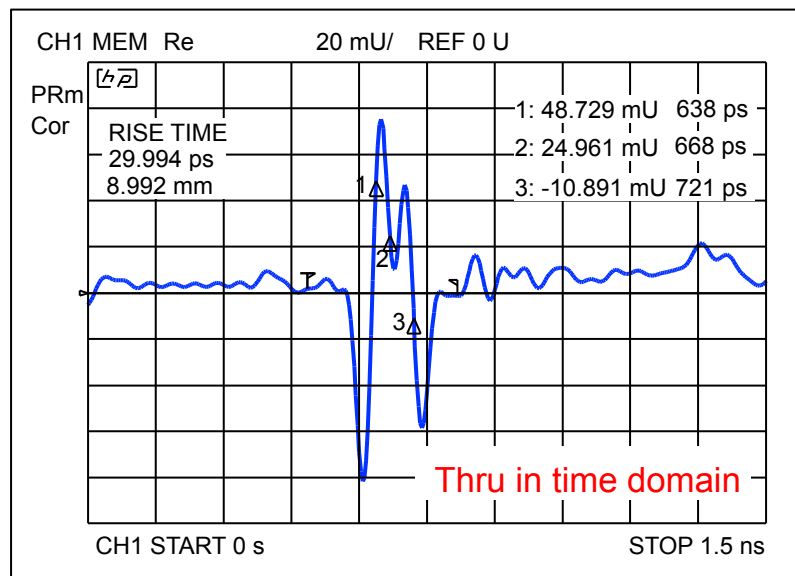
TDR Basics Using a Network Analyzer

- start with broadband frequency sweep (often requires microwave VNA)
- use inverse-Fourier transform to compute time-domain
- resolution inversely proportionate to frequency span



Time-Domain Gating

- TDR and gating can **remove** undesired reflections (a form of error **correction**)
- Only useful for **broadband** devices (a load or thru for example)
- Define **gate** to only include DUT
- Use two-port calibration



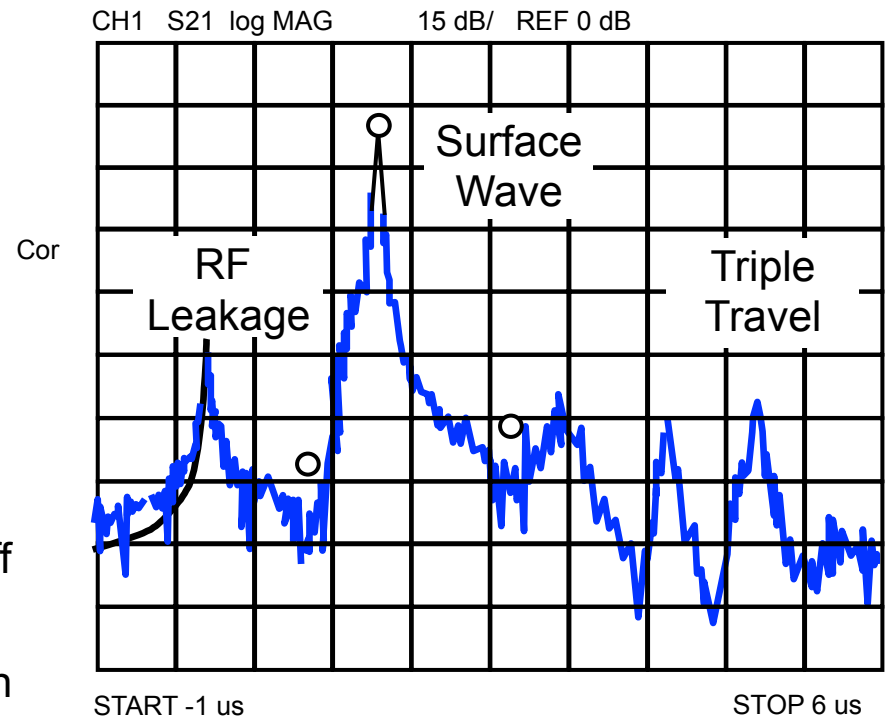
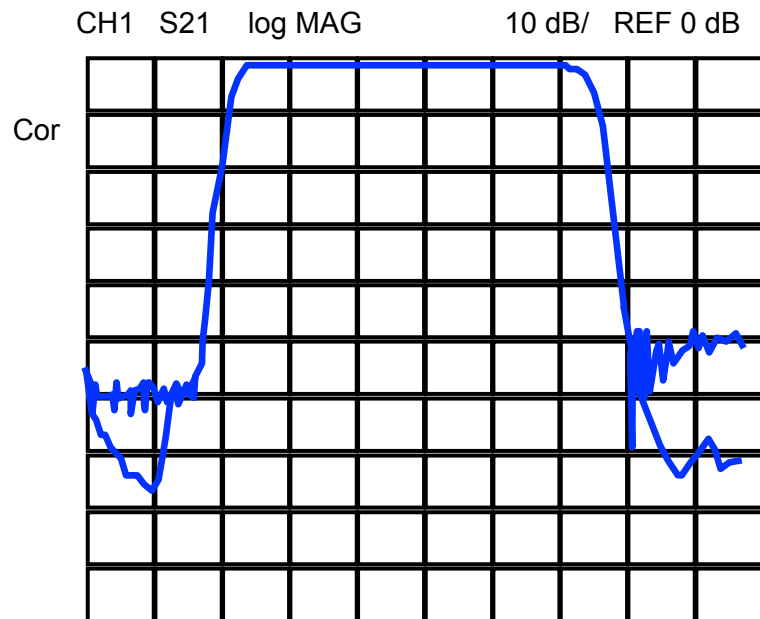
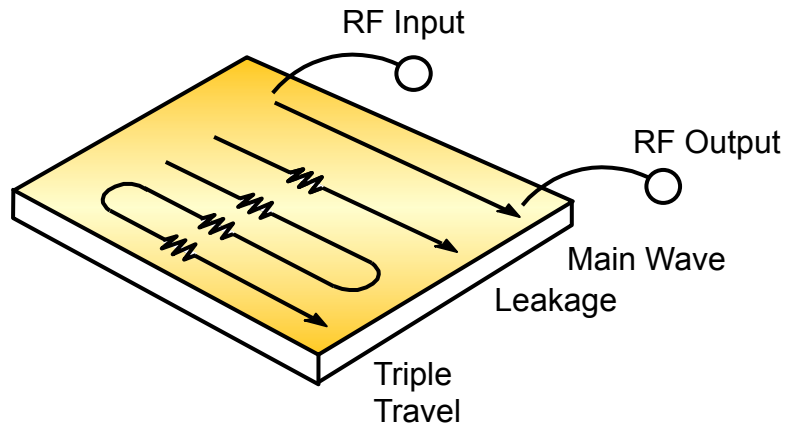
Ten Steps for Performing TDR

1. Set up desired frequency range (need wide span for good spatial resolution)
2. Under SYSTEM, transform menu, press "set freq low pass"
3. Perform one- or two-port calibration
4. Select S11 measurement *
5. Turn on transform (low pass step) *
6. Set format to real *
7. Adjust transform window to trade off rise time with ringing and overshoot *
8. Adjust start and stop times if desired
9. For gating:
 - set start and stop frequencies for gate
 - turn gating on *
 - adjust gate shape to trade off resolution with ripple *
10. To display gated response in frequency domain
 - turn transform off (leave gating on) *
 - change format to log-magnitude *

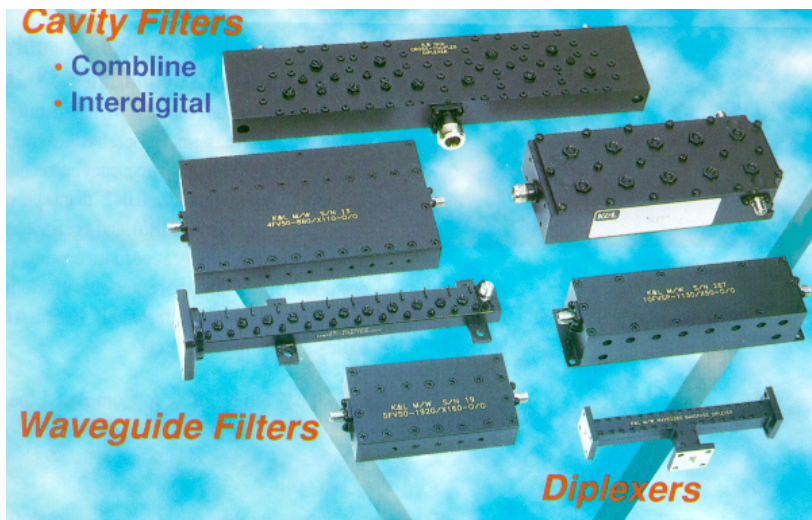
* *If using two channels (even if coupled), these parameters must be set independently for second channel*



Time-Domain Transmission



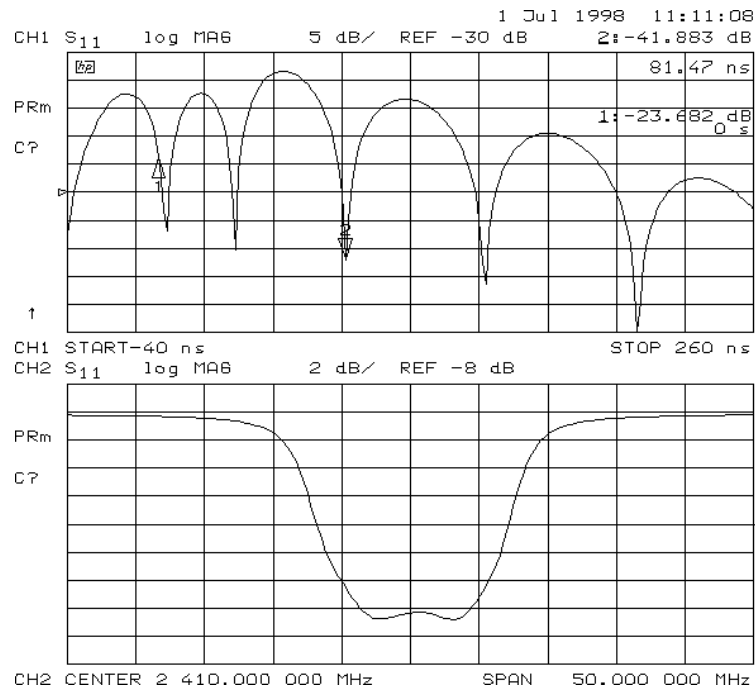
Time-Domain Filter Tuning



- Deterministic method used for tuning cavity-resonator filters
- Traditional frequency-domain tuning is very difficult:
 - lots of training needed
 - may take 20 to 90 minutes to tune a single filter
- Need VNA with fast sweep speeds and fast time-domain processing



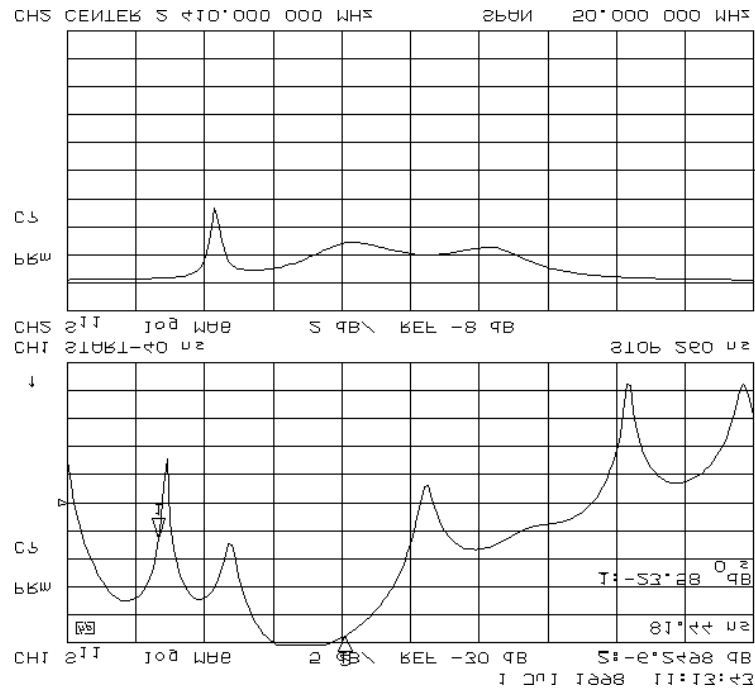
Filter Reflection in Time Domain



- Set analyzer's center frequency = center frequency of the filter
- Measure S_{11} or S_{22} in the time domain
- Nulls in the time-domain response correspond to individual resonators in filter



Tuning Resonator #3

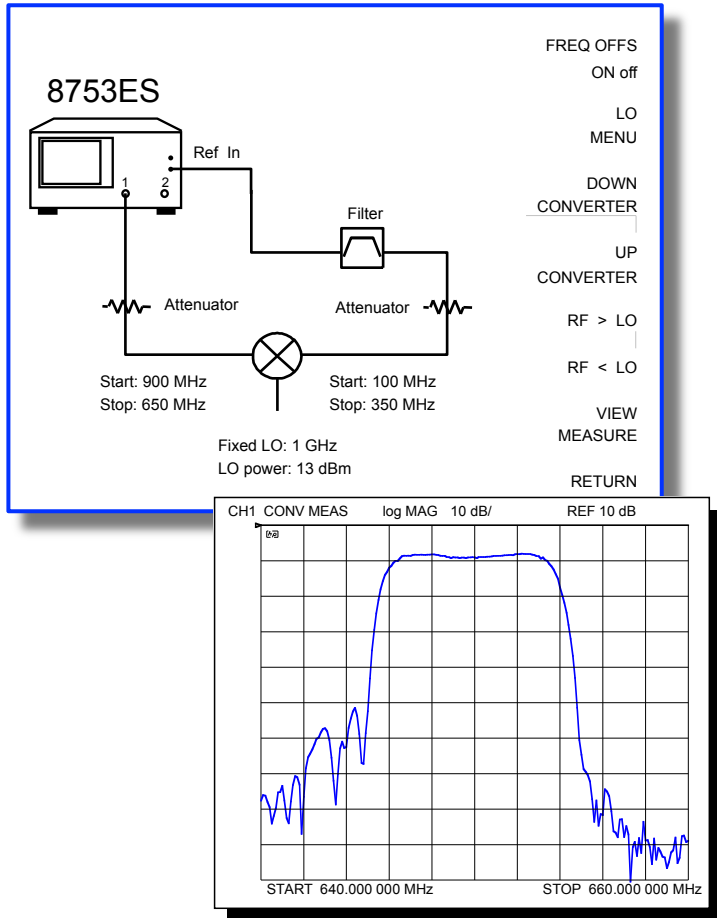


- Easier to identify mistuned resonator in time-domain: null #3 is missing
- Hard to tell which resonator is mistuned from frequency-domain response
- Adjust resonators by minimizing null
- Adjust coupling apertures using the peaks in-between the dips

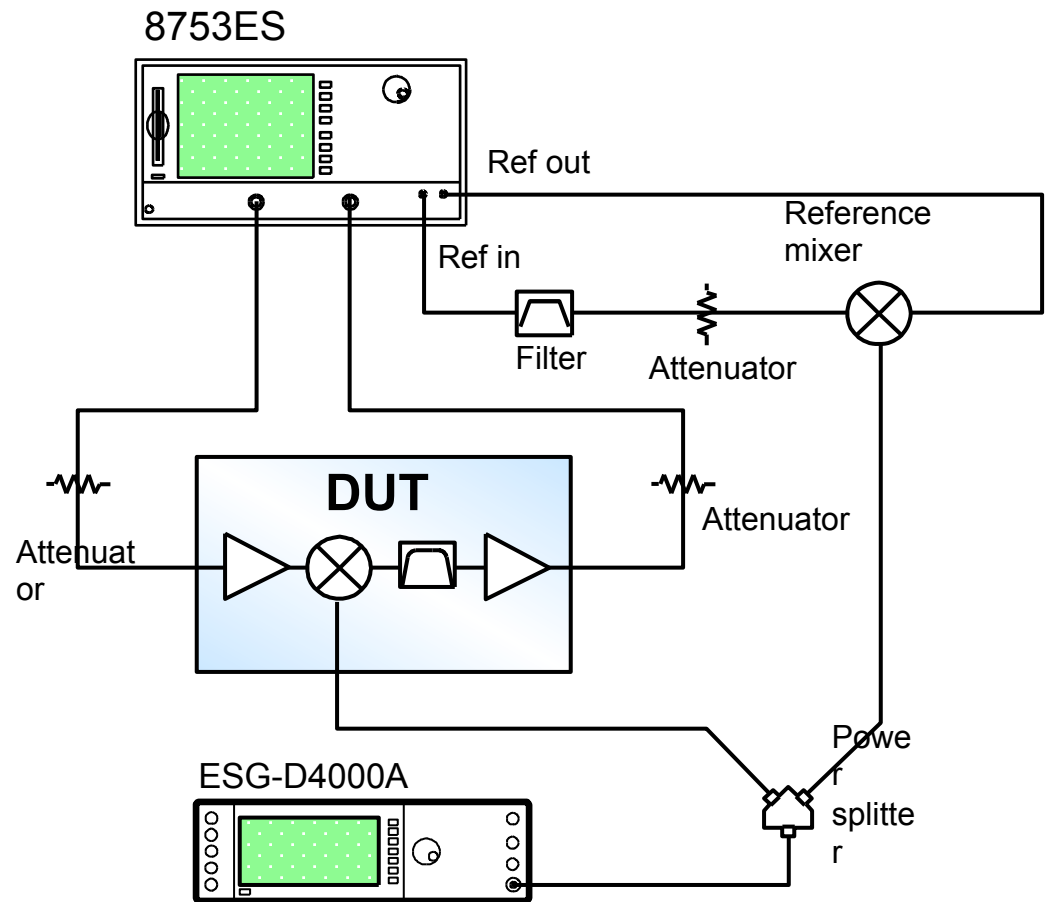


Frequency-Translating Devices

Medium-dynamic range measurements (35 dB)



High-dynamic range measurements (100 dB)

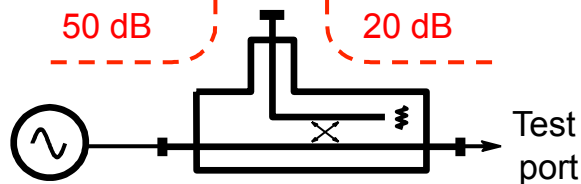


Directional Coupler *Directivity*

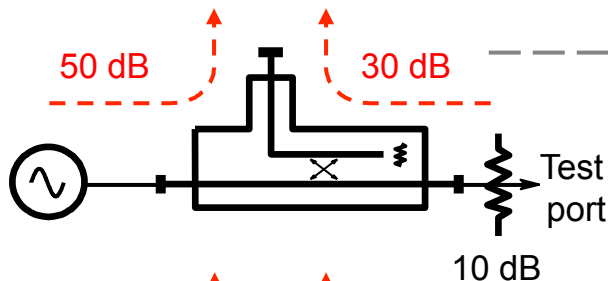
$$\text{Directivity} = \frac{\text{Coupling Factor}_{(\text{fwd})} \times \text{LOSS}_{(\text{through arm})}}{\text{Isolation}_{(\text{rev})}}$$

$$\text{Directivity (dB)} = \text{Isolation (dB)} - \text{Coupling Factor (dB)} - \text{Loss (dB)}$$

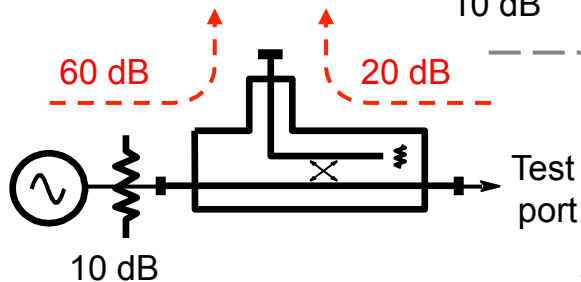
Examples:



$$\text{Directivity} = 50 \text{ dB} - 20 \text{ dB} = 30 \text{ dB}$$



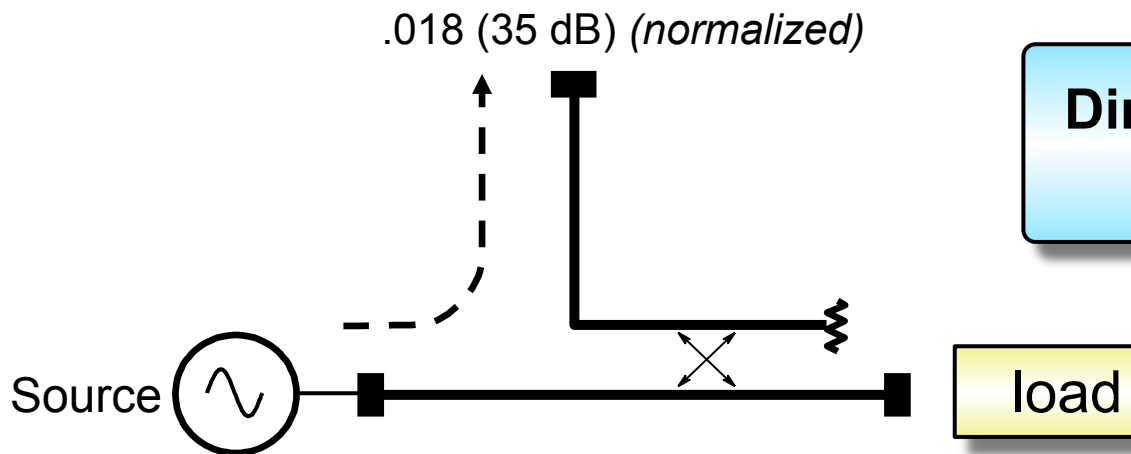
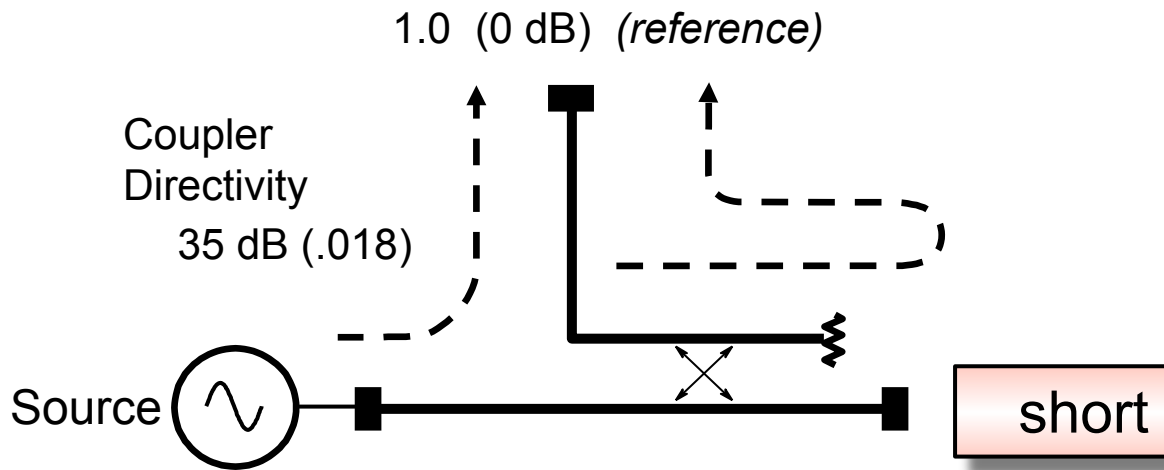
$$\text{Directivity} = 50 \text{ dB} - 30 \text{ dB} - 10 \text{ dB} = 10 \text{ dB}$$



$$\text{Directivity} = 60 \text{ dB} - 20 \text{ dB} - 10 \text{ dB} = 30 \text{ dB}$$



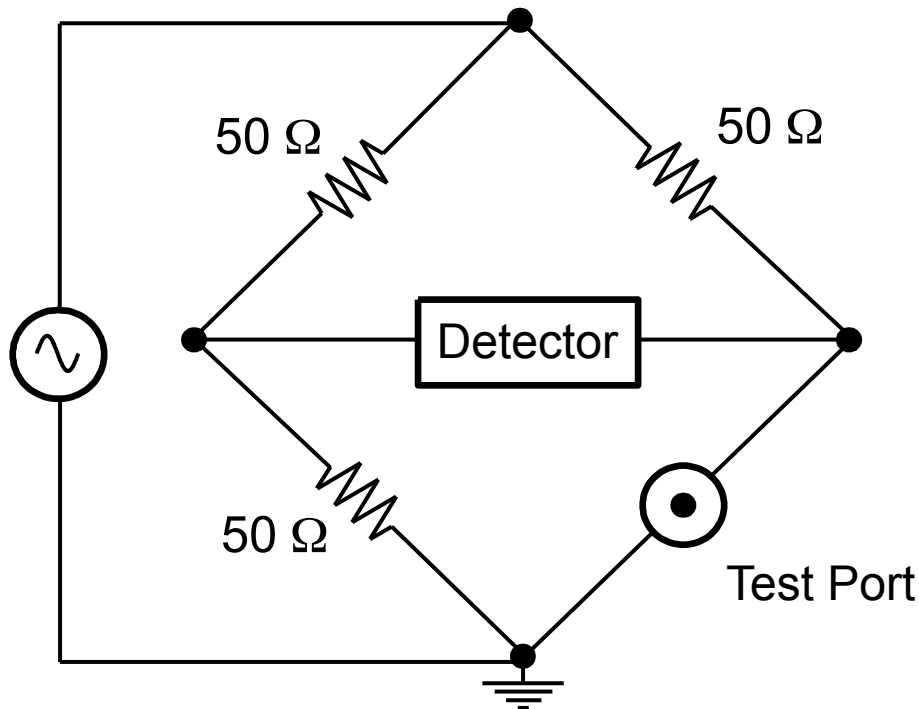
One Method of Measuring Coupler Directivity



$$\text{Directivity} = 35 \text{ dB} - 0 \text{ dB} = 35 \text{ dB}$$

Assume perfect load (no reflection)

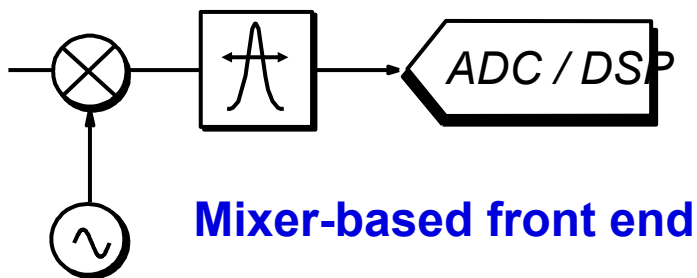
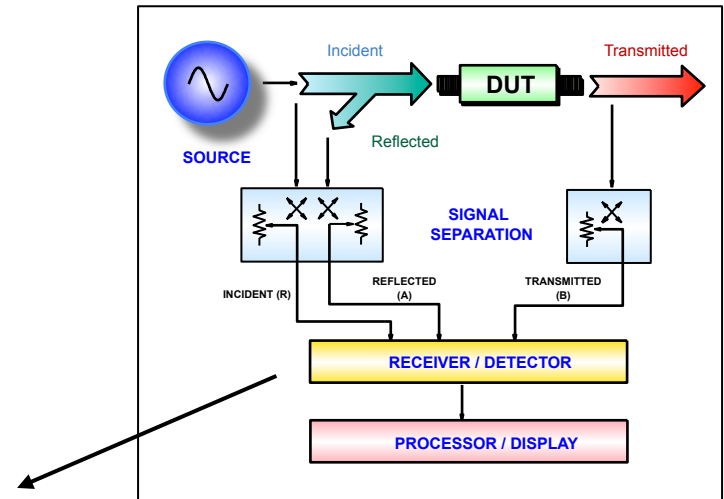
Directional Bridge



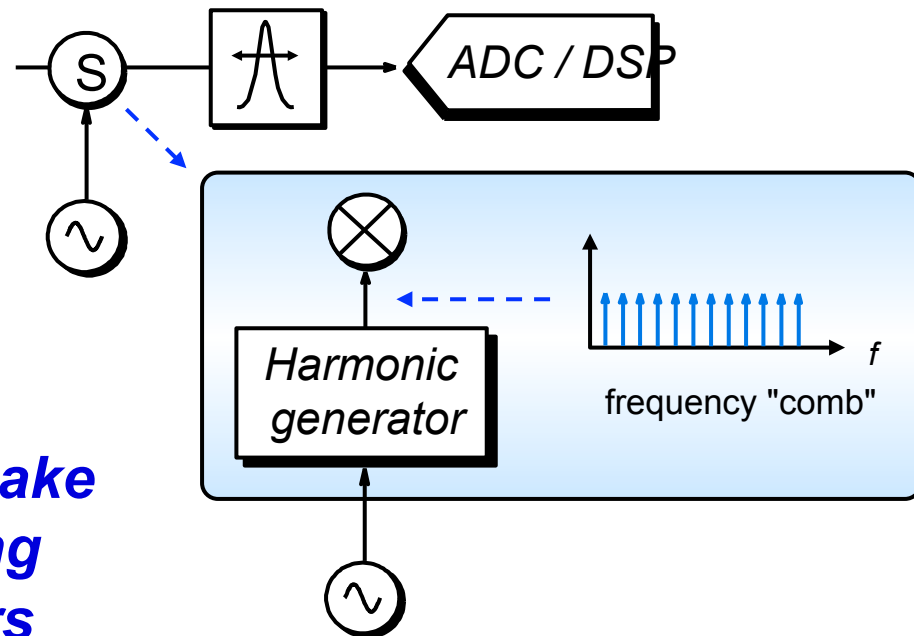
- 50-ohm load at test port balances the bridge -- detector reads zero
- Non-50-ohm load imbalances bridge
- Measuring magnitude and phase of imbalance gives complex impedance
- "Directivity" is difference between maximum and minimum balance



NA Hardware: Front Ends, Mixers Versus Samplers

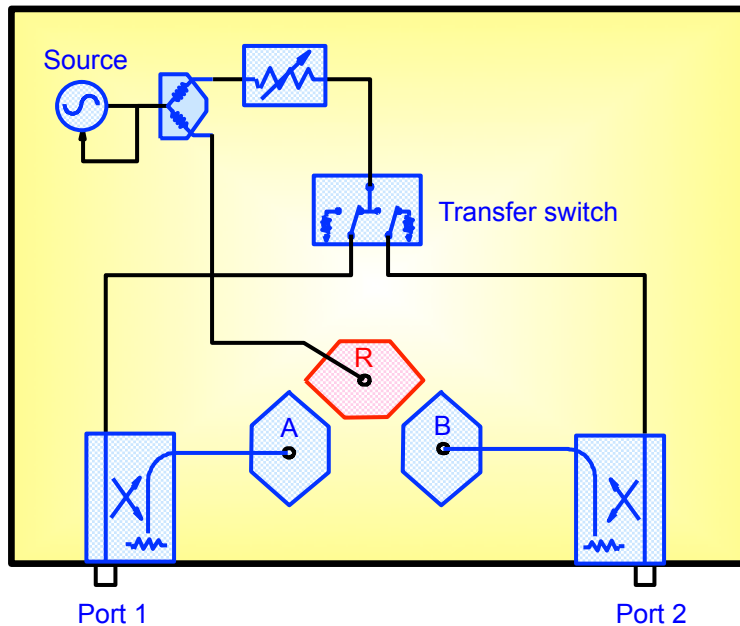


Sampler-based front end



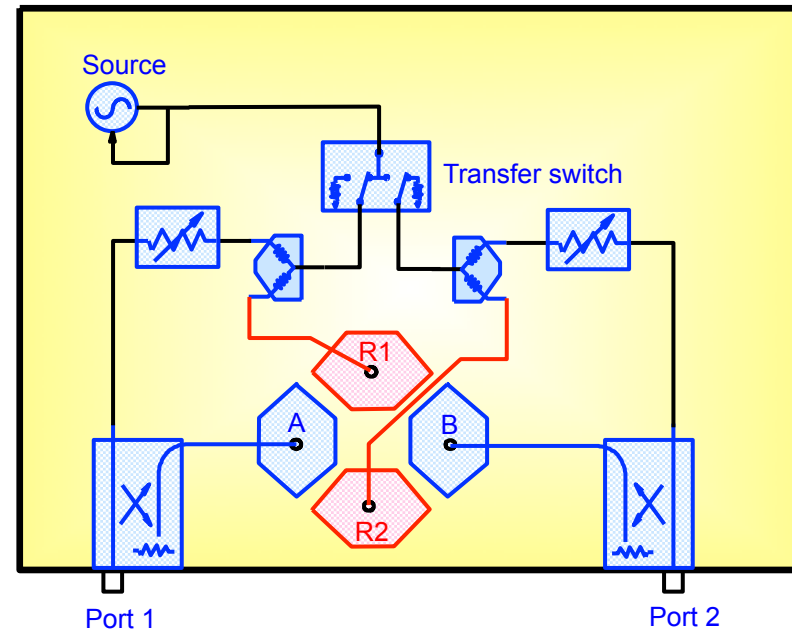
It is cheaper and easier to make broadband front ends using samplers instead of mixers

Three Versus Four-Receiver Analyzers



3 receivers

- more economical
- TRL*, LRM* calcs only
- includes:
 - 8753ES
 - 8720ES (standard)

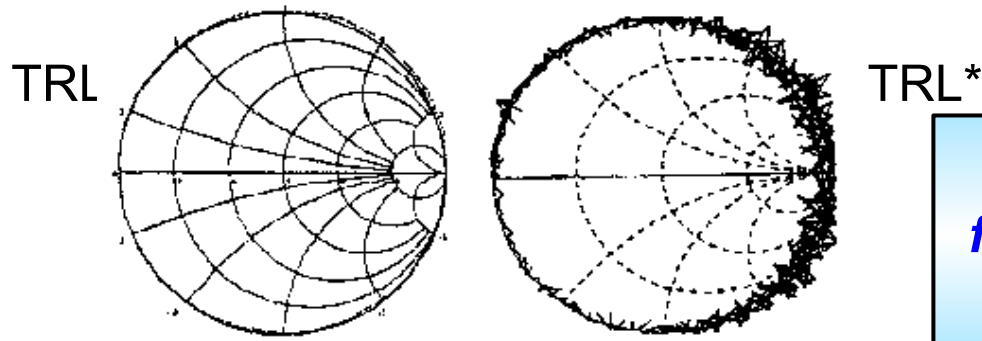


4 receivers

- more expensive
- true TRL, LRM calcs
- includes:
 - 8720ES (option 400)
 - 8510C



Why Are Four Receivers Better Than Three?



8720ES Option 400 adds fourth sampler, allowing full TRL calibration

- **TRL***
 - assumes the **source and load match** of a test port are **equal** (port symmetry between forward and reverse measurements)
 - this is only a fair assumption for three-receiver network analyzers
- **TRL**
 - four receivers are necessary to make the required measurements
 - TRL and TRL* use identical calibration standards
- **In noncoaxial applications**, TRL achieves **better source and load match correction** than TRL*
- **What about coaxial applications?**
 - **SOLT is usually the preferred calibration method**
 - coaxial TRL can be more accurate than SOLT, but not commonly used



Challenge Quiz

1. Can filters cause distortion in communications systems?

- A. Yes, due to impairment of phase and magnitude response
- B. Yes, due to nonlinear components such as ferrite inductors
- C. No, only active devices can cause distortion
- D. No, filters only cause linear phase shifts
- E. Both A and B above

2. Which statement about transmission lines is false?

- A. Useful for efficient transmission of RF power
- B. Requires termination in characteristic impedance for low VSWR
- C. Envelope voltage of RF signal is independent of position along line
- D. Used when wavelength of signal is small compared to length of line
- E. Can be realized in a variety of forms such as coaxial, waveguide, microstrip

3. Which statement about narrowband detection is false?

- A. Is generally the cheapest way to detect microwave signals
- B. Provides much greater dynamic range than diode detection
- C. Uses variable-bandwidth IF filters to set analyzer noise floor
- D. Provides rejection of harmonic and spurious signals
- E. Uses mixers or samplers as downconverters



Challenge Quiz (continued)

- 4. Maximum dynamic range with narrowband detection is defined as:**
- A. Maximum receiver input power minus the stopband of the device under test
 - B. Maximum receiver input power minus the receiver's noise floor
 - C. Detector 1-dB-compression point minus the harmonic level of the source
 - D. Receiver damage level plus the maximum source output power
 - E. Maximum source output power minus the receiver's noise floor
- 5. With a T/R analyzer, the following error terms can be corrected:**
- A. Source match, load match, transmission tracking
 - B. Load match, reflection tracking, transmission tracking
 - C. Source match, reflection tracking, transmission tracking
 - D. Directivity, source match, load match
 - E. Directivity, reflection tracking, load match
- 6. Calibration(s) can remove which of the following types of measurement error?**
- A. Systematic and drift
 - B. Systematic and random
 - C. Random and drift
 - D. Repeatability and systematic
 - E. Repeatability and drift



Challenge Quiz (continued)

7. Which statement about TRL calibration is false?

- A. Is a type of two-port error correction
- B. Uses easily fabricated and characterized standards
- C. Most commonly used in noncoaxial environments
- D. Is not available on the 8720ES family of microwave network analyzers
- E. Has a special version for three-sampler network analyzers

8. For which component is it hardest to get accurate transmission and reflection measurements when using a T/R network analyzer?

- A. Amplifiers because output power causes receiver compression
- B. Cables because load match cannot be corrected
- C. Filter stopbands because of lack of dynamic range
- D. Mixers because of lack of broadband detectors
- E. Attenuators because source match cannot be corrected

9. Power sweeps are good for which measurements?

- A. Gain compression
- B. AM to PM conversion
- C. Saturated output power
- D. Power linearity
- E. All of the above



Answers to Challenge Quiz

1. E

2. C

3. A

4. B

5. C

6. A

7. D

8. B

9. E